

Strickley

Center for Research in Electro-Optics and Lasers
University of Central Florida

AFFILIATES' DAY

January 13, 1992

Speakers' Presentations

CREOL
12424 Research Parkway, Suite 400
Orlando, Florida 32826
(407) 658-6800

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PRESENTATION

SPEAKER

Overview of CREOL

M.J. Soileau

Sensor Protection from Pulsed Lasers

E.W. Vanstryland

Characterization of Nonlinear Optical Materials

D.J. Hagan

Development of New Laser and NLO Materials

B. Chai

New Solid State Lasers

M. Bass

Solid State Laser and Laser Spectroscopy

J. Kim

Advanced Solid State Laser Systems, X-ray Optics,
and Electron-Optics Technology

M. Richardson

& W. Silfvast

Applications of CREOL Free-Electron Lasers

L. Elias

Ground-Based Laser Tracking and Imaging of Space
and Airborne Objects

R.L. Phillips

Coherent Array Laser Radar Signal Processing

C.M. Stickley

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G. Borman

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J. Harvey

Multiple Quantum Well/Optoelectronics, New
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A. Miller

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G. Stegeman

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J. Moharam

A New Class of Thin Optical Films

K. Guenther

CREOL

(Center for Research in Electro-Optics and Lasers)

Established 1986

University of Central Florida, Orlando,

Director: M J Soileau

Assistant Director: C M Stickley

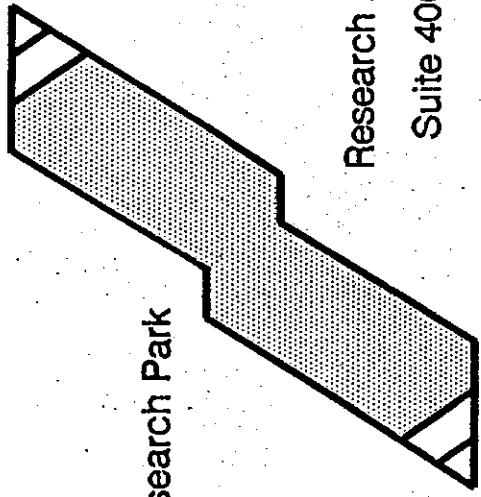
Objective:

- * Establish a Center of Excellence at UCF in optics and laser research and education
- * To assist in the development of Florida's High Tech industries

Description:

CREOL is an interdisciplinary center involving faculty and students from a variety of academic units including Physics, Electrical Engineering, Mechanical Engineering, Mathematics and Computer Science

University of Central Florida Research Park

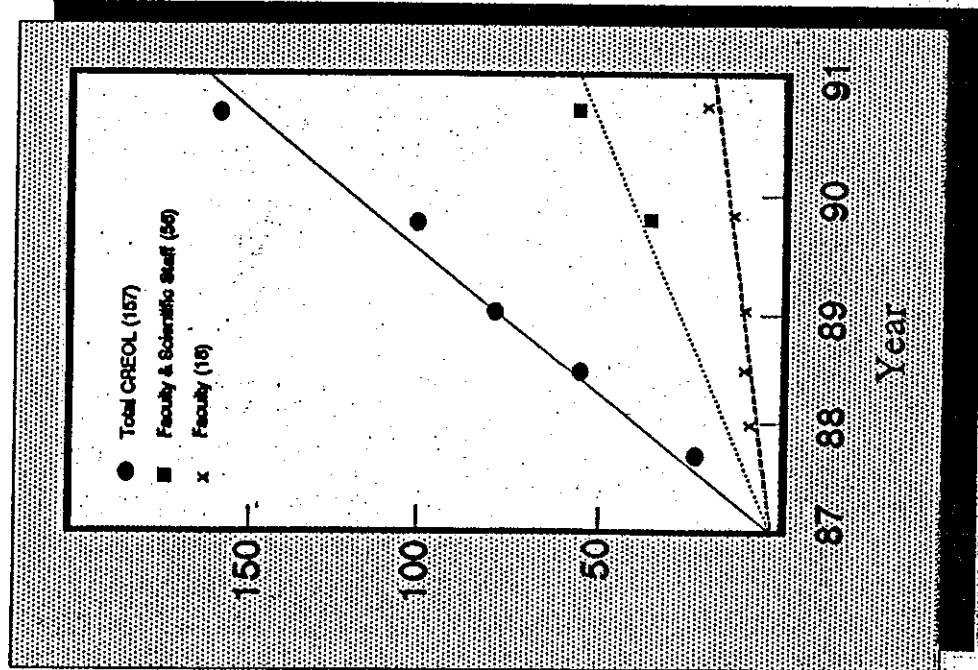
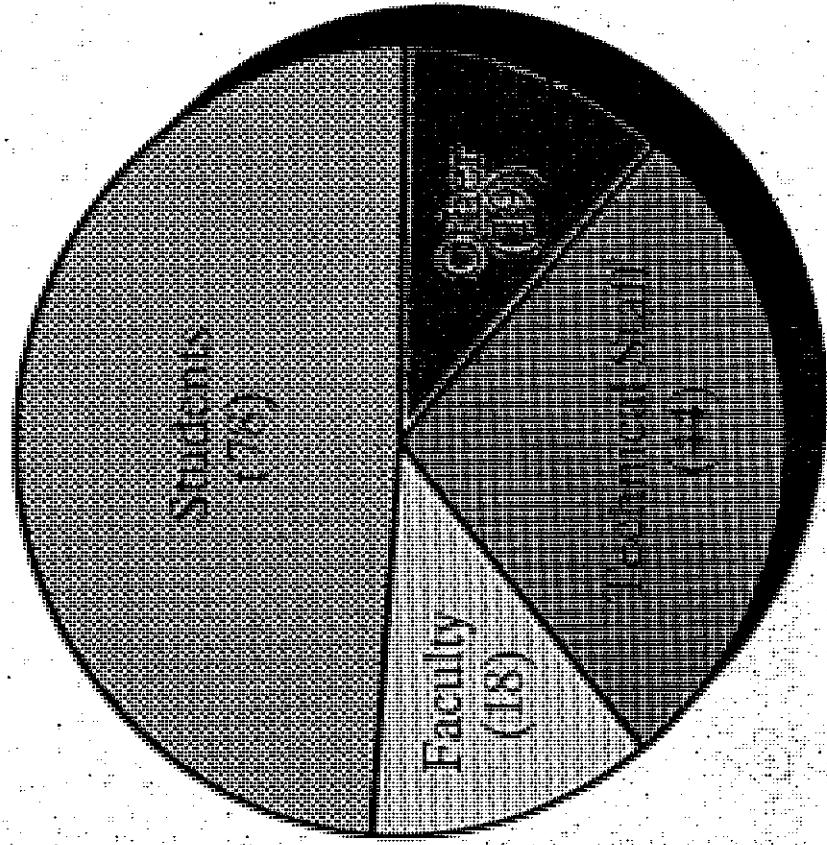


Suite 400

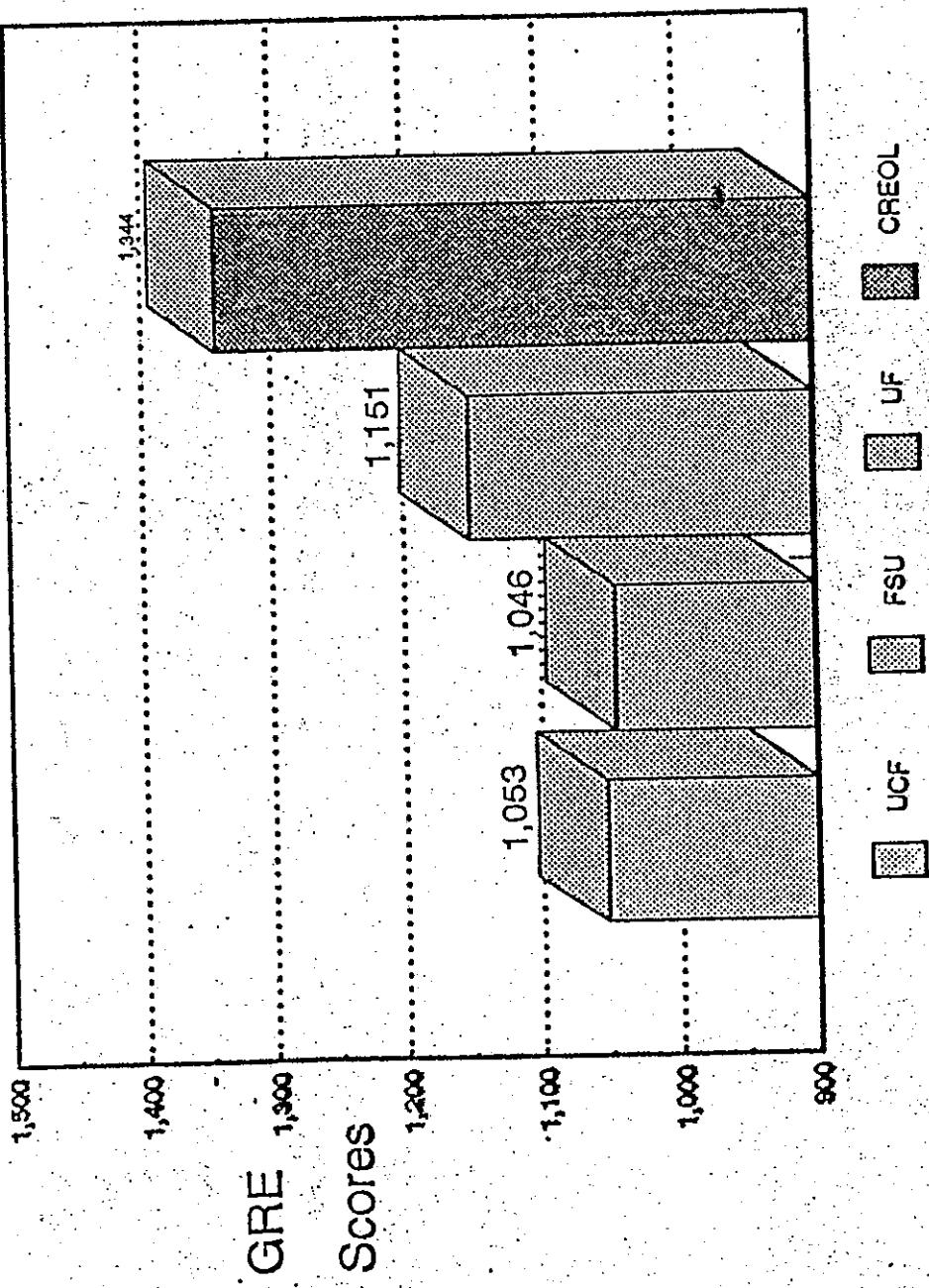
Research Pavilion

CREOL PERSONNEL

Total 157



Student Recruiting



CREOL FACULTY PROFILES

- 50% hold rank of fellow in major national and international professional societies.
- CREOL faculty are on boards of governments of 3 out of 4 major professional societies dealing with lasers and optics.
- 50% have chaired, co-chaired or served on organizing committees of major national and international conferences dealing with this research specialty in the past year.
- Over 150 professional publications and presentations in AY 90/91.
- Conclusion: CREOL faculty are judged by their peers to be among the top people in their research fields.

CREOL Faculty & Research Topics

Quantum Optics	C. Pashov	Microscopic Light Propagation	J. Dowell	Electromagnetic Spectroscopy	E. W. Hagley
Quantum Computing	J. Levy	Nonlinear Optics & Optomechanics	B. Chitambar	Digital	M. Soltani
Diffractive Optics	M. J. Moaveni	Laser Induced Diffraction & Interference	L. Leifer	Optical Coherence	G. Sagnac
Photocell Optics	J. G. Gribble	Surface State Spectroscopy	M. Hines	Quantum Well Optoelectronics	A. Molokeev
Linear Propagation	R. Phillips	Plasma Physics & Vortex Electrastatics	J. Korty	Surface	M. Rethink
Quantum Optics	K. Chentsov	Strongly Nonlinear & Hysteresis Systems	M. Steiner		

OPTICS COURSES



EEL-4440 Optical Engineering	PHY-4424 Optics
EEL-5441 Introduction to Wave Optics	PHY-5446 Laser Principles
EEL-5446 Optical Systems Design	PHY-5431 Optical Properties of Materials
EEL-5450C Thin Film Optics	PHY-5938 Introduction to Crystal Growth
EEL-5451L Electro-Optics Laboratory	PHY-6434 Nonlinear Optics
EEL-5563 Fiber Optics Communication	PHY-6448 Laser Systems
EEL-6443 Electro-optics	PHY-6424 Optical Properties of Solids
EEL-6457 Advanced Topics in Electro-Optics	PHY-6204 Atomic Spectroscopy
EEL-6560 Laser Engineering	PHY-6400 Physics of Free Electrons
EEL-6561 Fourier Optics	PHY-6410 Modern X-Ray Science
EEL-6562 Diode Pumped Lasers	PHY-6447 Laser Physics
EEL-6564 Optical Communication Theory	
EEL-6565 Infrared Technology	

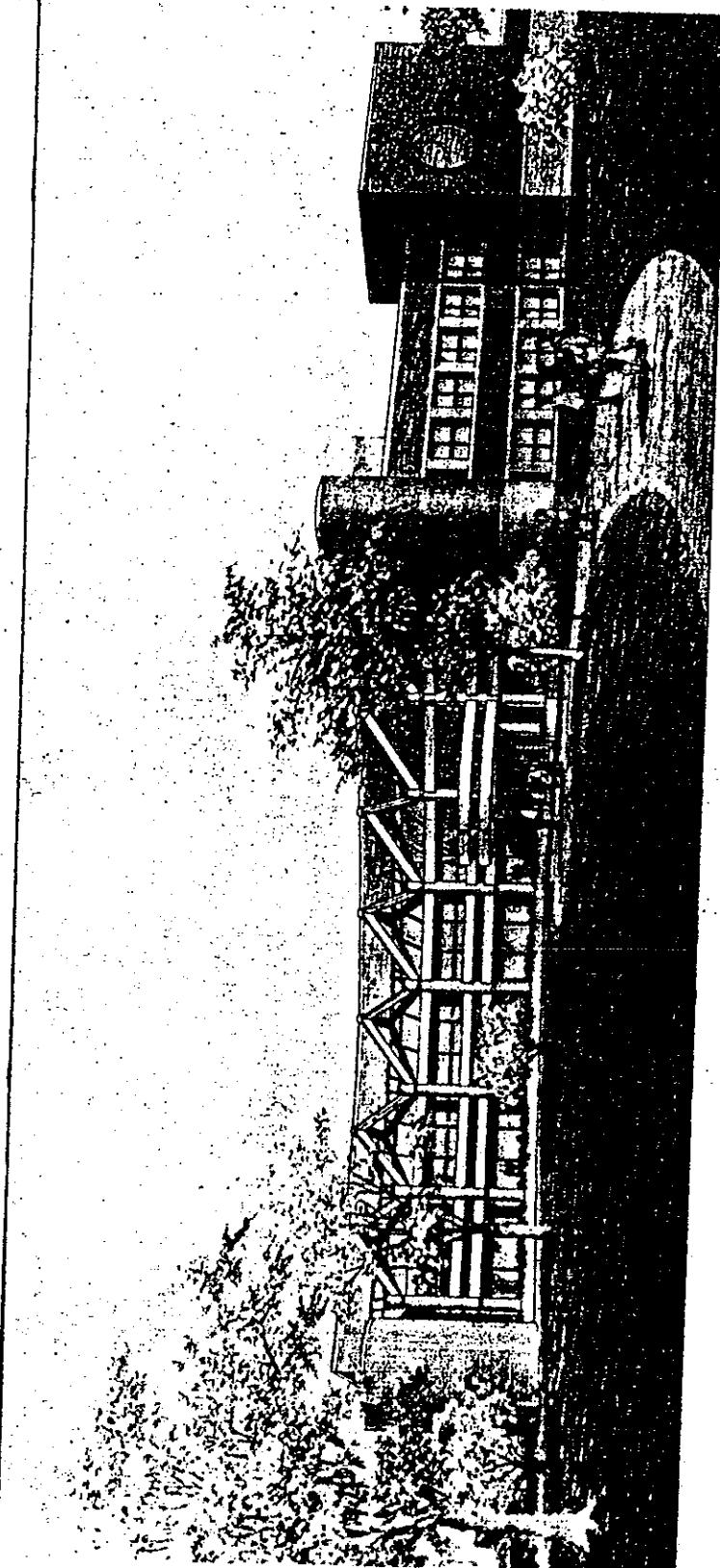
CREOL LABORATORIES

Present

- 51 Laboratories
- \$8M+ State-of-the-Art Capital Equipment
- 33,000 sq ft Office and Labs (Research Pavilion)
- 14,000 sq ft Offices & Labs (Site #2, Research Park)
- 2,000 sq ft Labs on Campus

Future

- 70,000 sq ft CREOL Building Planned
- Groundbreaking Sept 2013



CREOL Industrial Affiliates Program

Membership Requirements

Sustaining Member:

Participate in Eminent Scholar Program

Senior Member:

Annual Donation of \$10,000

Member:

1. Gross sales greater than \$10,000,000: \$5,000 annual donation
2. Gross sales greater than \$1,000,000: \$2,500 annual donation
3. Gross sales less than \$1,000,000: \$1,000 annual donation

Membership in this special category is restricted to small business as defined by the U.S. Government





CREOL

CREOL Industrial Affiliates Program

Membership Benefits*

- Establishes a formal relationship between the company and CREOL
- The *Highlights* newsletter of the Center for Research in Electro-Optics and Lasers
- Copies of any unrestricted publications, upon request arising from research carried out by the Center
- The CREOL Director's reports on the status of ongoing research, prospective programs and other activities
- A directory of the graduate students involved in CREOL-related programs
- Participation in the Annual Corporate Affiliates Meeting
- Influence direction of CREOL research
- Senior members are given a seat of the CREOL Industrial Advisory Board

*The honest truth is that CREOL is the primary beneficiary of this program because it supplies us with our only source of unrestricted funds.

CREOL

(Center for Research in Electro-Optics and Lasers)

Established 1986

University of Central Florida, Orlando,

Director: M J Soileau

Assistant Director: C M Stickley

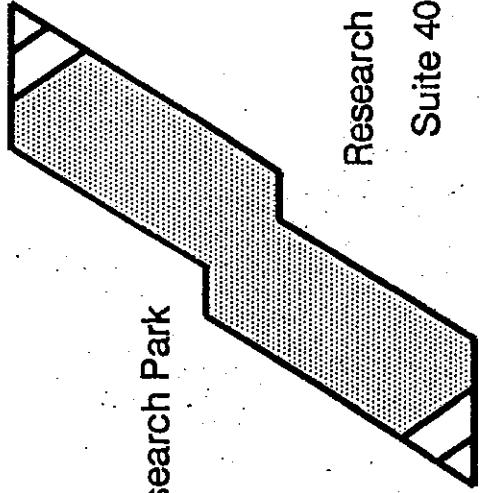
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University of Central Florida Research Park



Research Pavilion

Suite 400

SENSOR PROTECTION

Faculty:

**E.W. Van Stryland
M.J. Soileau
D.J. Hagan
A. Miller**

PhD Scientists:

**D. Hutchings
M. Sheik-Bahae
A.A. Said**

Students:

**Tai Wei, Richard DeSalvo, Jiangwei Wang, Zho Wang, T.
Xia and Mike Hasselbeck**

**Two of the PI's (MJS and EVS) hold security clearances.
This helps in communicating research results to company
scientists working with classified military systems (eg.
Martin Marietta).**

Funding Received:

<u>US CNVEO/DARPA (1988-92)</u>	\$1,200,000
"Passive Spatial Beam Control" with M.J. Soileau	
This was a direct match to the FHTIC funding.	
<u>SBIR Funded with Schwartz E-O (we split award)</u>	\$49,992
<u>Battelle Columbus Laboratories (1987-88)</u>	\$25,000
"Measurement of Nonlinear Optical Properties of Materials", with M.J. Soileau and D.J. Hagan	
<u>General Dynamics (1987-88)</u>	\$44,731
"Laser Damage and Limiting", with M.J. Soileau	
<u>McDonnell Douglas (1988-89)</u>	\$19,594
"Pulse Laser Test", with M.J. Soileau	
<u>Jet Propulsion Laboratory (1988-89)</u>	\$50,000
"Cascaded Optical Limiter" with M.J. Soileau and D.J. Hagan	
<u>Army Research Office (1990)</u>	\$75,000
"Optical Limiting" with D.J. Hagan and M.J. Soileau	
<u>McDonnell Douglas (1990)</u>	\$22,293
"Limiting Test" with M.J. Soileau	
<u>National Science Foundation (1987-90)</u>	\$248,000
"Engineering of Two-Photon Nonlinearities in Bulk and Artificially Structured Semiconductors" with M.J. Soileau, and D.J. Hagan	
<u>Battelle Columbus Laboratories (1992)</u>	\$75,000
<u>National Science Foundation (1992-95)</u>	\$252,000
"Dispersion of Optical Nonlinearities in Solids" with M.J. Soileau, D.J. Hagan and M. Sheik-Bahae	
<u>Florida High Technology and Industrial Council (1991)</u> . .	\$21,161
"Passive Optical Switching" with D.J. Hagan and M.J. Soileau	

DISSERTATIONS

The research funded by the Florida High Technology and industrial Council the past year has resulted in the completion of the following doctoral dissertations.

- 1 Edesly Canto-Said, "Picosecond Degenerate Four-Wave-Mixing in Semiconductors", 1989.**
- 2 Yuen Yuan Wu, "Semiconductor Nonlinearities for Passive Spatial Beam Control", 1990.**
- 3 Kamjou Mansour, "Characterization of Optical Nonlinearities in Carbon Black Suspensions in Liquids", 1990.**
- 4 Ali A. Said, "Development and Application of a Nonlinear Optical Characterization Technique", 1991.**

**Masters Thesis: Jayant Malhotra, "Laser Induced Darkening in Semiconductor Doped Glasses", Univ. of Central Florida, 1988.
Funded by the Florida High Technolgy and Industry Council**

APPROACH

1. develop techniques and facilities for the nonlinear optical characterization of materials
2. work with the materials people to optimize the nonlinear optical properties based on the results of our studies
3. implement these materials in the design and construction of optical limiting devices for sensor protection.

This last step is to be accomplished in collaboration with industry and government laboratories (eg. Martin Marietta, Shwartz E-O, JPL, CNVEO).

We organized three topical meetings of the SPIE held in Orlando entitled "Materials for Optical Switches, Isolators, and Limiters". This conference brought to Florida the primary researchers from around the U.S. working in this field. We presented several talks each year.

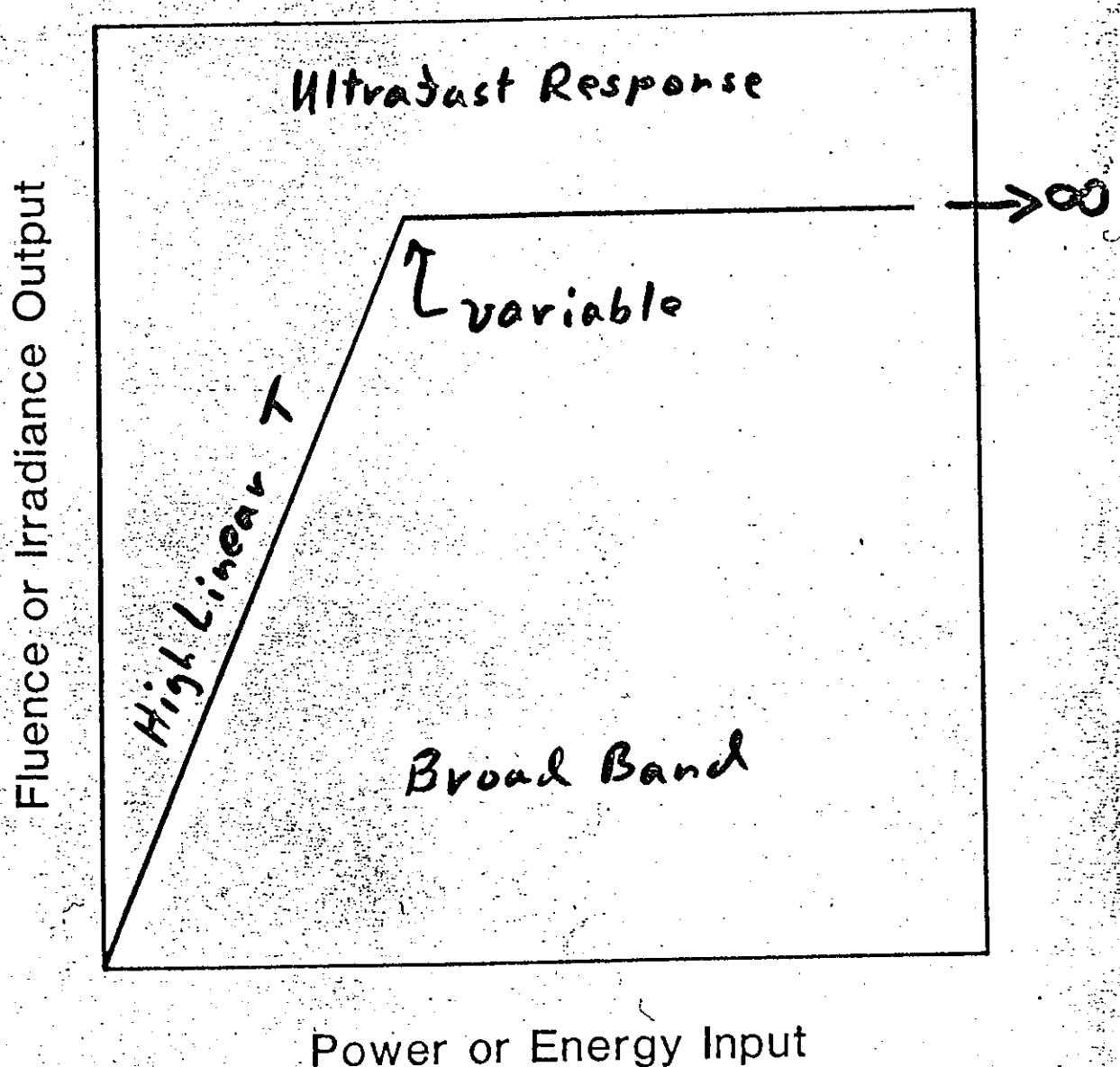
History

- o original OPL patent M.J. Soileau 1978
- o screening test for OPL 1980
- o semiconductor limiter (2PA) 1985
- o Patent; "OPL Based on Two-Photon Absorption" 1988
- o designed and built MONOPOL 1988
 - self-protecting semiconductor limiter
 - 10 nJ (300 W) limiting for psec 0.53 μ m pulses
 - 1 μ J (80 W) limiting with nsec 0.53 μ m pulses
- o developed Z-scan 1988
- o limiting in carbon suspensions 1989
- o developed psec DFWM (1 and 0.5 μ m) 1989
- o developed method to model thick limiters 1989
 - can optimize focusing geometry 1990
- o related n_2 to β the 2PA coefficient via nonlinear Kramers-Kronig 1990

COLLABORATIONS:

- o with RSRE Malvern, England
 - modified liquids, $V_x O_y$, liquid crystals
- o with Jet Propulsion Lab on organics
- o with Westinghouse on TAS at 10 μm (Singh)
 - also AgGaSe from Stanford (R. Route)
 - also AgGaS from Martin Marietta
- o with DuPont on n_2 of KTP (Vanherzeele)
- o with McDonnell Douglas for screening materials
- o with Battelle Columbus for screening materials
- o with LLNL (R. Adair, L. Chase)
 - n_2 of a series of materials at several λ
they have interest in n_2 at 355 and 266 nm
- o with Bruce Chai (CREOL)
 - n_2 of LiCaAlF (of interest to LLNL)
- o with Wright Patt. (C. Lee, Spire)
 - n_2 of organic thin films (in plastic host)
- o with University of Florida (Joe Simmons)
 - DFWM, n_2 , Darkening of semiconductor doped glass
- o with Kent State Liquid Crystal Institute on organics
- o with U. of Iowa (A.L. Smirl) semiconductor doping
- o with Oklahoma State Univ. (R.C. Powell)
- o with CNVEO for;
 - help in setting up in-house experiments

Ideal Optical Limiter Response



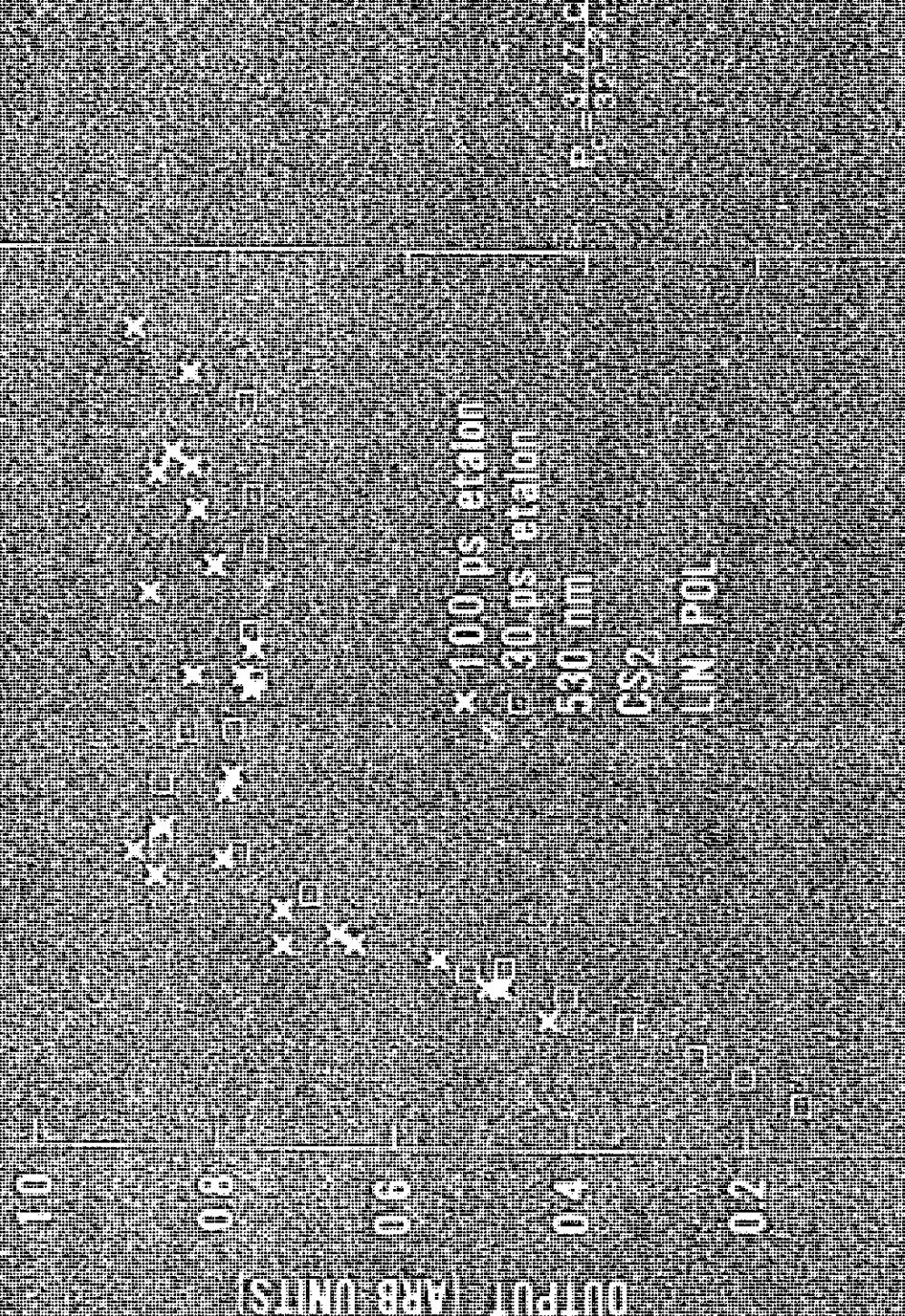
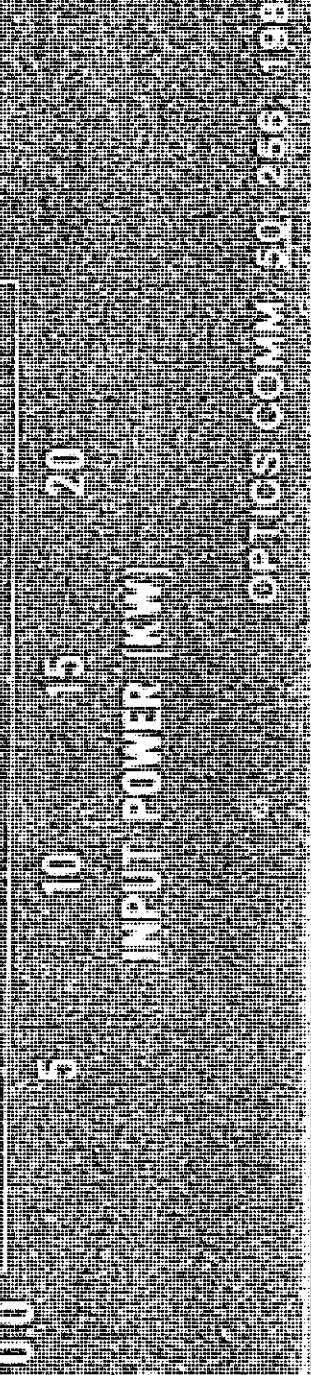
45°

\leftrightarrow
variable

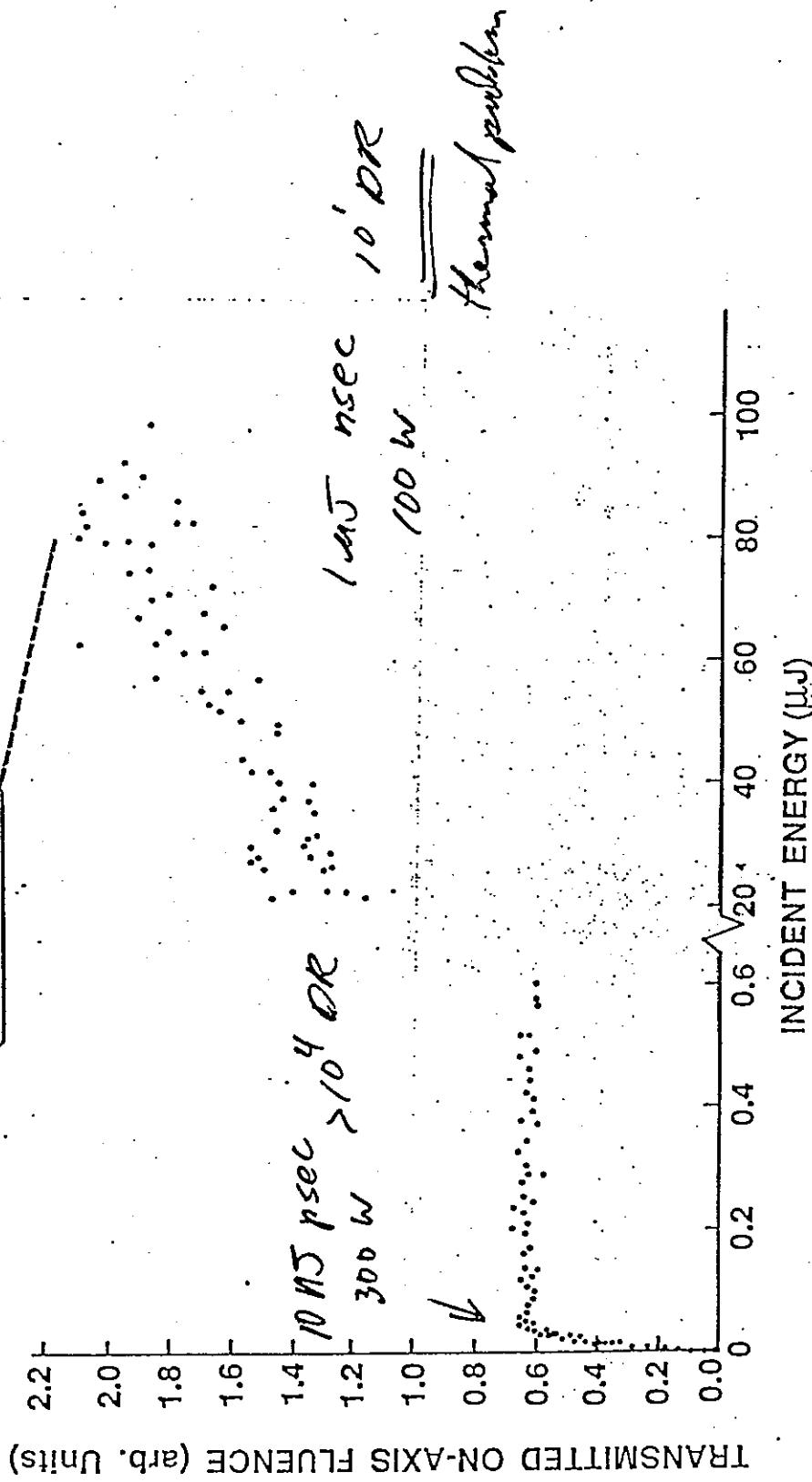
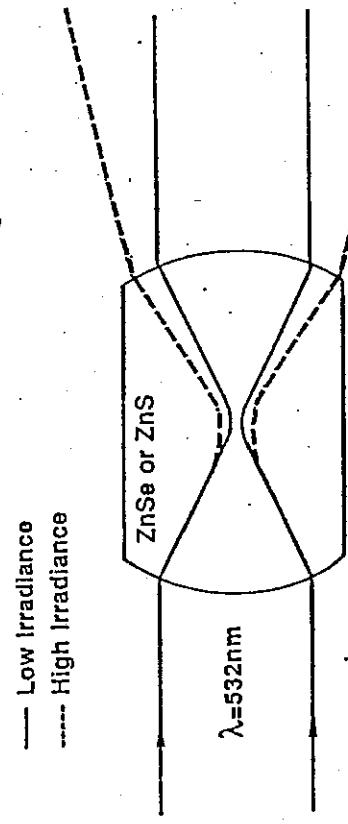
fast rise

In the case of Kerr liquids such as CS_2 , you can get exactly the shape desired and have high linear transmission. Also the screening test can be used to calculate the critical power and obtain an

You can get a very large dynamic range with CS_2 , since liquids self-heal, and you can vary the cutoff power- but only to higher values. You do this by diluting it. That's the *only* thing wrong



Semiconductor Lasers



Combining with other materials
(Joint with JPL)

grad. student

Nonlinear Scattering in a Carbon Black Suspension

$\lambda = 532 \text{ nm}$

$t_p = 14 \text{ nsec}$

Low Intensity



(a)

Front of the Cell ←

1 CM

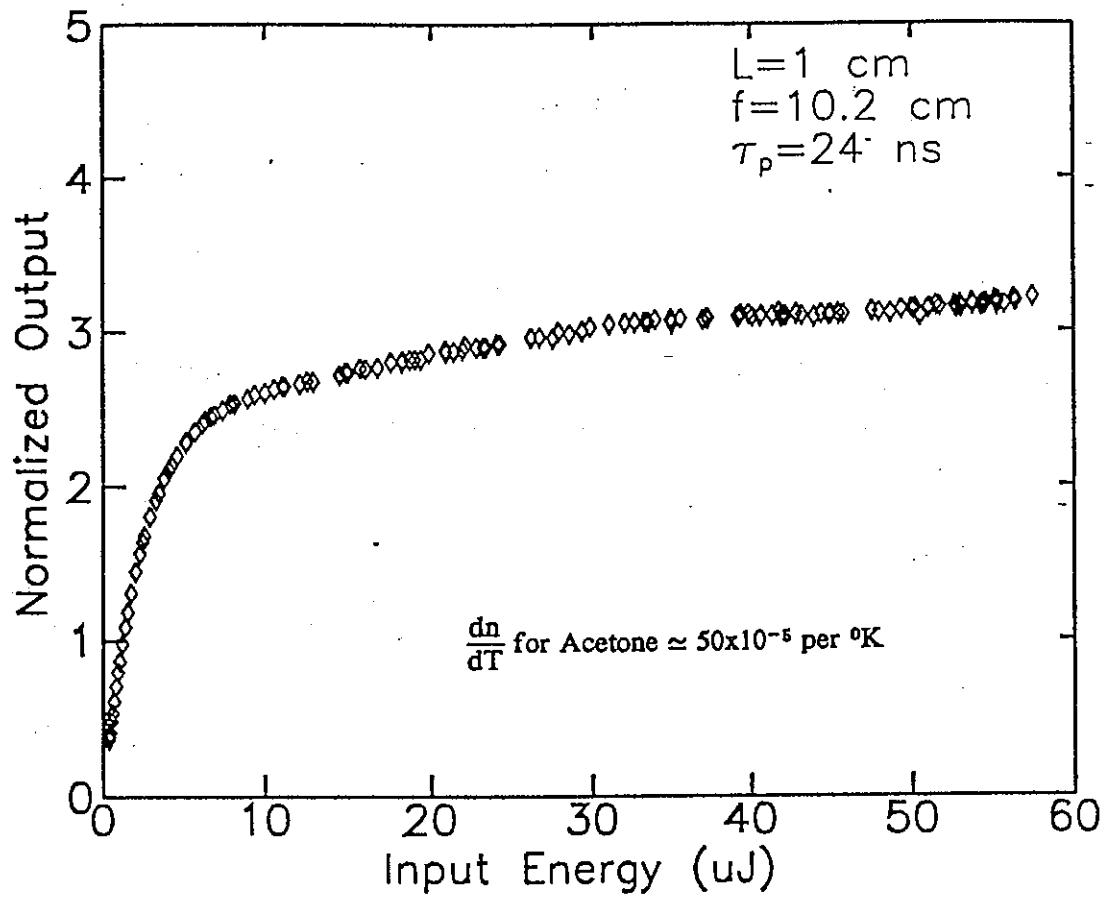
→ Back of the Cell

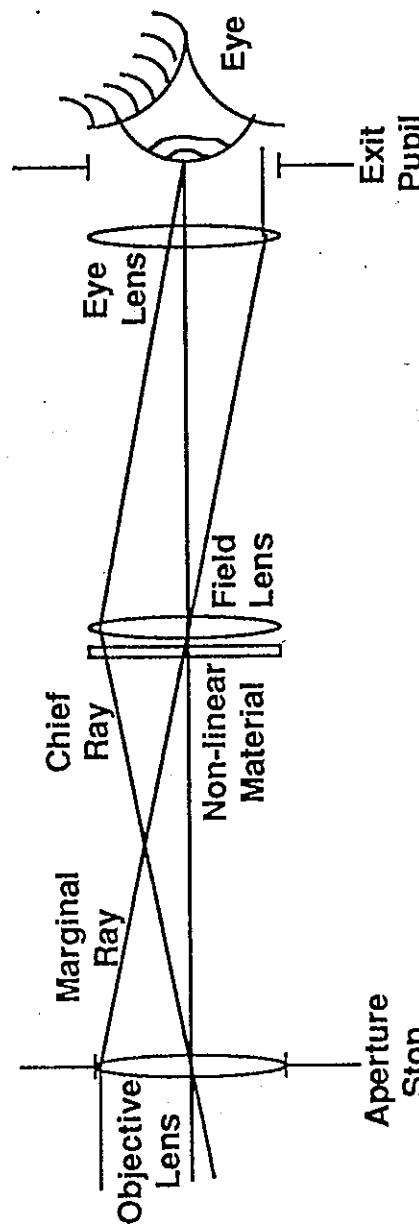
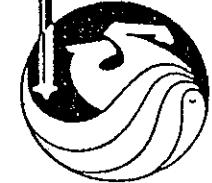
High Intensity



(b)

LIMITING BY THERMAL EXPANSION FOR NSEC PULSES





o for a 2 inch input lens and a 1/4 inch iris opening, the energy in the limiting medium is ≈ 70 times the energy entering the eye in the linear regime.

- An F/4 Objective with Identical Eye Lens constitutes Afocal System

- Non-linear Material is positioned at Prime focus of Objective Lens

- Stop at Objective Lens is reimaged by Field Lens to produce Exit Pupil at Eye

- Spherical Aberration designed in to dominate Coma and Astigmatism
(controls image size and makes it uniform over 30° field)

- Erecting Prism (not shown) to be between Field Lens and Eye Lens

Announcement and Call for Papers

Nonlinear and Electro-Optic Materials for Optical Switching

Part of SPIE's International Symposium
and Exhibition on Optical Engineering and Photonics

19-24 April 1992
Marriott's Orlando World Center Resort and Convention Center
Orlando, Florida USA

Conference Chair: M. J. Soltész, Consultant, St. Central Florida
Chair: L.C. Davis, The Pennsylvania State Univ., Edward J.
Lippert, U.S. Army Ctr. for Night Vision and Electro-Optics, Eric W.
Kornblit, CRC/AT&T, of Central Florida

This conference will concentrate on the physical and related areas
that are relevant to optical switching. Of particular interest are papers
dealing with materials and physical mechanisms that are relevant to
the applications of optical switches that can be
used to fabricate optical switches or other systems. Topics include:

OE/AEROSPACE
ORLANDO, FLA.

- liquid crystal optical modulators
- liquid crystals
- nonlinear properties of organic
- solid-state materials
- photorefractive materials
- nonlinear absorption, refraction, and scattering
- beam steering

Abstract Due Date: 23 September 1991*
Manuscript Due Date: 23 March 1992

SPIE—The International Society for Optical Engineering

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CHARACTERIZATION OF NONLINEAR OPTICAL MATERIALS

Personnel

Faculty:

D. J. Hagan

E.W. Van Stryland

M.J. Solleau

M. Sheik-Bahae

Postdoctoral:

D.C. Hutchings (Theory)

A.A. Said

Students:

P. Buck, T. Xia, J. Wang, Z. Wang

R. DeSalvo, M. Hasselbeck, T.H. Wei

Nonlinear Refraction and Absorption:

$$n = n_0 + n_2 |E|^2 + n_4 |E|^4$$

+ - - -

$$\alpha = \alpha_0 + \beta I + \dots$$

more generally:

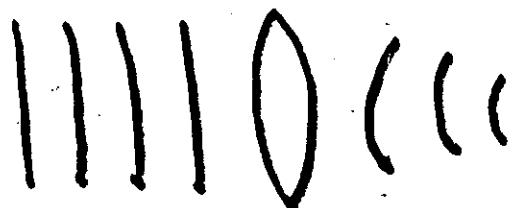
$$n \rightarrow n(I)$$

$$\alpha \rightarrow \alpha(I)$$

- Strong light propagating in a medium can alter its optical properties.

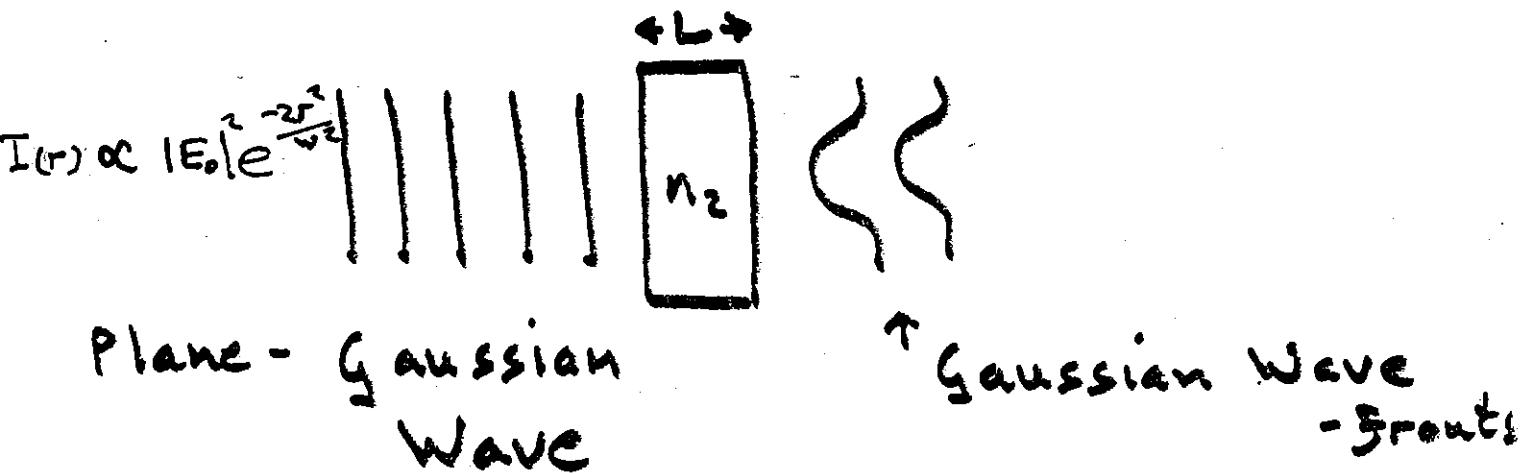
Self-Focussing: ($n_2 > 0$)

1, Regular lens



plane wave spherical wave - $e^{-ikr^2/2\lambda}$

2, Nonlinear Medium ; $n = n_0 + n_2 |E|^2$

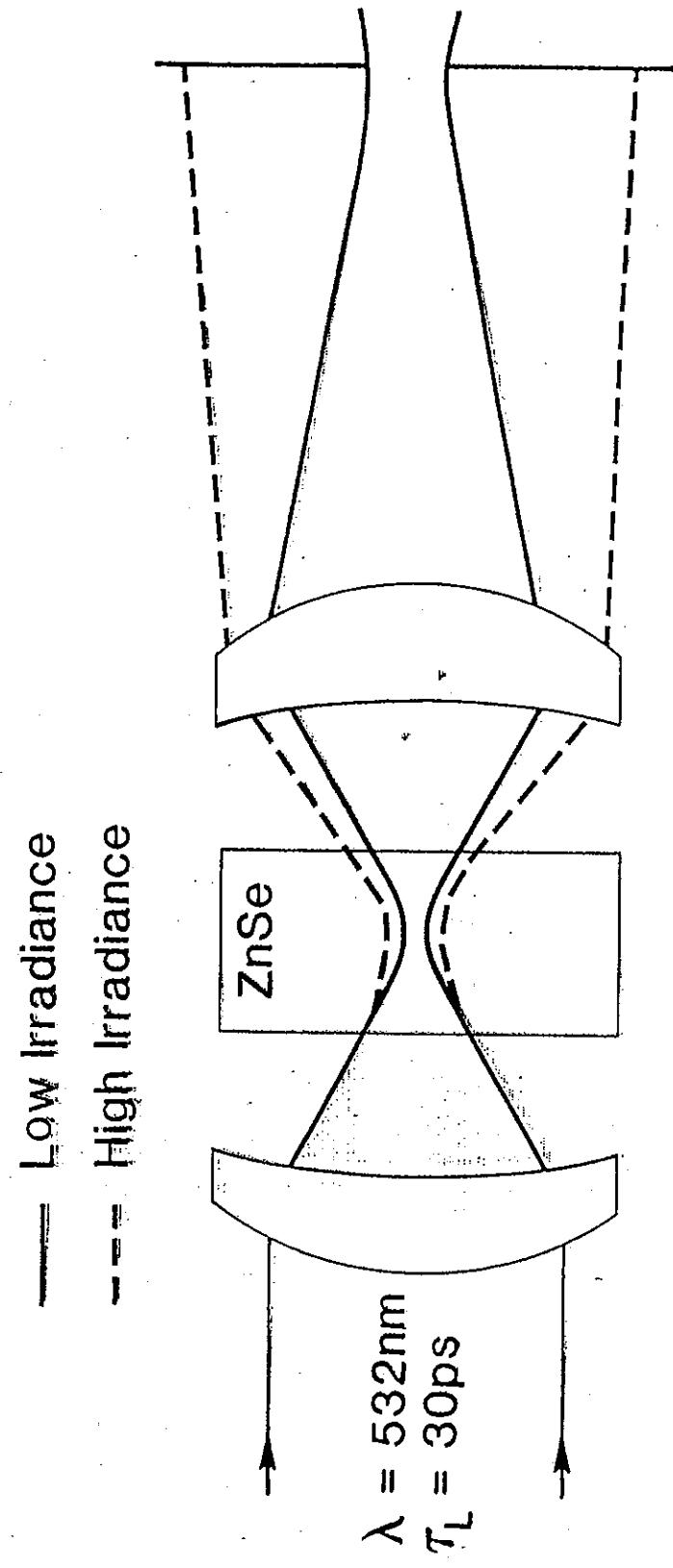


Plane - Gaussian Wave

Gaussian Wave - Front

- effective focal length

$$f_{\text{eff}} \doteq \frac{w^2}{n_2 |E|^2 L}$$



Measurement Techniques

Nonlinear Transmission

Optical Limiting

Beam Distortion

Excite-Probe

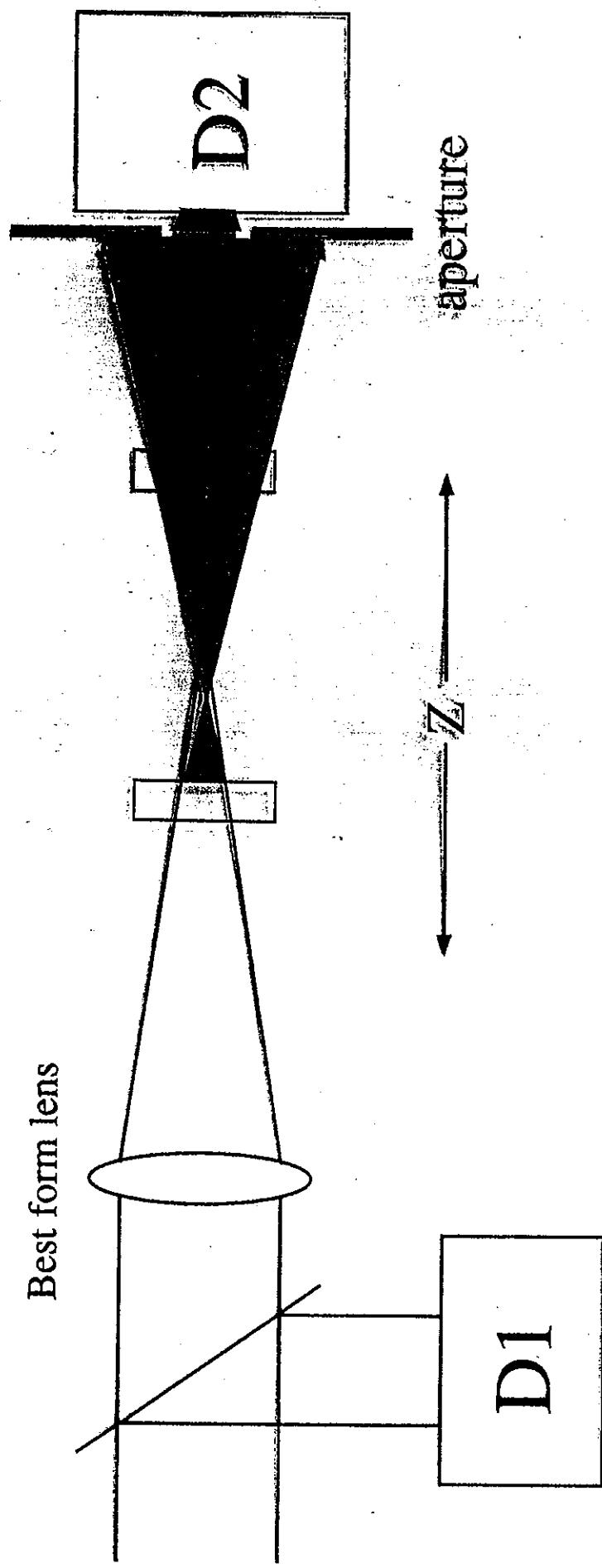
Degenerate Four-Wave Mixing

Z-Scan*

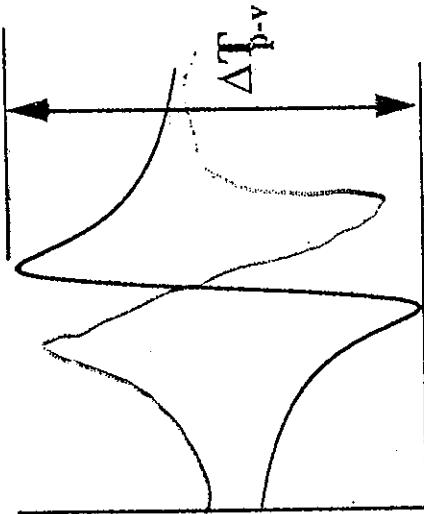
Excite-Probe Z-Scan*

(* Developed at CREOL)

Z-Scan Set-up



Z-Scan



Normalized Transmittance

$$\Delta T_{p-v} = p |\Delta \Phi_{NL}| \quad \text{where } p = 0.36 \text{ for a 40\% aperture}$$

The NL phase shift is defined as:

$$\Delta \Phi_{NL} = k n_2 I L$$

k is the wave vector

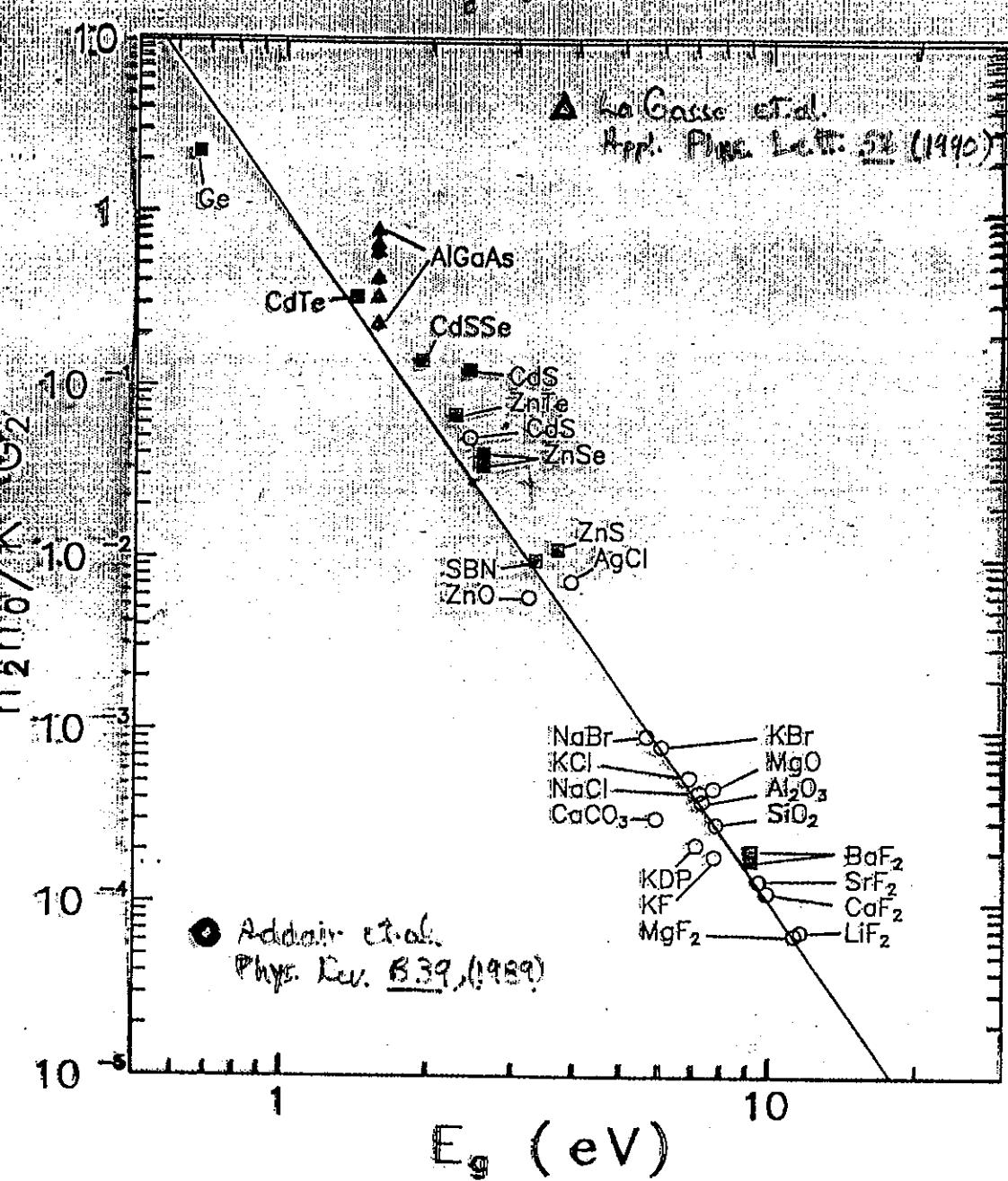
I is the peak irradiance

L is the sample length

n_2 is the nonlinear refractive index

BAND-GAP SCALING OF n_2

$$n_2 = \frac{K'}{E_g^{\alpha} n_e} \cdot G(\tau \omega / E_g)$$



LABS & FACILITIES

10-Hz Picosecond Nd:YAG lab

- Excite-Probe Z-scan & DFWM

10-Hz Picosecond Nd:YAG / Dye laser lab

- Z-Scans in IR, Visible & UV.

Picosecond / Nanosecond CO₂ lab

- Characterization in the mid-IR
(9-11 micron band)

Single mode Nanosecond Nd:Yag lab

- Streak camera / vidicon for
study of nsec limiting.
- nsec Z-Scans in IR and Visible

Picosecond Cr:LiSrAlF₆ laser lab

- Tuneable 50 psec 850 nm
laser with 100 microjoule output.

*** Femtosecond Ti:Sapphire / Cr:LiSrAlF**

- regenerative amplifier system
- 200 fsec, millijoule energy pulses
- fsec broadband continuum source

Picosecond Nd:YLF laser

- Electro-Optic Sampling

Development of New Lasers and NLO Materials

Bruce H.T. Chai

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(Center for Research in Electro-Optics and Lasers)
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Orlando, Florida 32826

Tel: (407) 658 - 6847
Fax: (407) 658 - 6880

January 13, 1992

*** This work is supported by DARPA, FHTIC**

§ Introduction:

⇒ Objectives:

- ◊ Establish a state-of-art crystal growth center in a university environment for
 - » Research
 - » Education
- ◊ Developing high optical quality crystals
 - » Solid state laser hosts
 - » Nonlinear optical devices
 - » Substrates
- ◊ Supply materials internally and externally for R & D
- ◊ Technology transfer
 - » from abroad to CREOL
 - » from CREOL to industry and government laboratories

§ Crystal Growth Facilities at CREOL:

- ◊ The Crystal Growth Laboratory is established under AMMP (the Advanced Microelectronics and Materials Program) funded by both DARPA and the State of Florida.
- ◊ Laboratory planning started in March 1989.
- ◊ Installation of power, water and utilities started in July 1989.
- ◊ Testing first crystal puller at the end of September, 1989.
- ◊ Current Facilities:

Five stations fully optional, four to be completed. They include

3 RF heated pullers (two 30KW and one 50KW)
2 resistant heating fluoride pullers
3 TSSG furnaces (flux growth)
1 Cambridge pressurized puller

- ◊ Low temperature solution growth stations
 - ⇒ nonlinear organic compounds.
- ◊ A fiber puller is under construction ⇒ with J. Dixon
- ◊ Optical fabrication laboratory.
- ◊ Most completed bulk crystal growth facility in U.S. universities.

§ Crystal Growth Stations at CREOL:

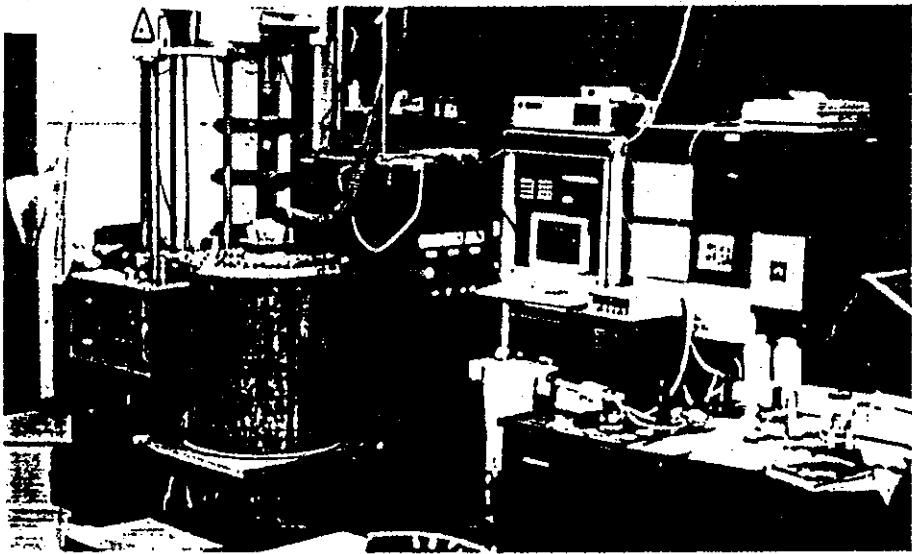


Fig. 2, Induction heated Czochralski station

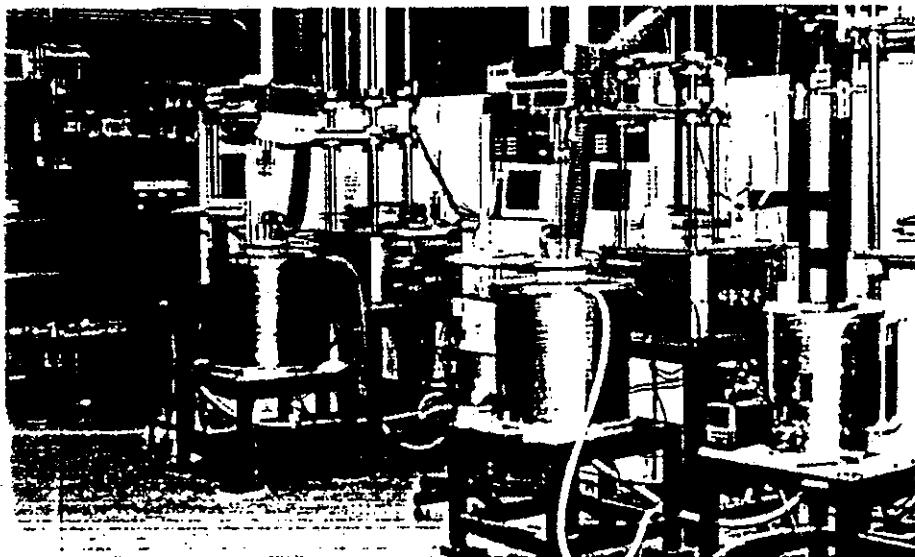


Fig. 3, Resistance heated Czochralski station

§ Czochralski Pulling:

- Pulling crystals directly from melt
- Best developed growth technique because it can produce large, dislocation free crystals in a reasonable time.
- Produces highest optical quality crystal
- Require smooth rotation and pull movement
- Crystal diameter depends on temperature and pull rate.
- Free standing crystal after growth
- Can tolerate to some degree of nonstoichiometry and peritectic melting
- Two types of pullers used
 - (1) RF heated → for oxide crystals,
 - high melting point (up to 2200°C)
 - Iridium metal containers
 - (2) Resistant heated → for fluorides
 - low melting point (up to 1100°C)
 - Platinum metal containers

CRYSTALS PRODUCED AT CREOL



§ Current Research Programs:

(A) New Laser Materials Research

-- Oxides

-- Fluorides

(B) Nonlinear Optical Crystals

-- Borates

-- Niobates

§ Selection of Laser Materials :

- Selection of host crystals
 - transparent
 - robust
 - high thermal conductivity
 - low refractive indices

Cline's rule – High Al and Be for good laser materials

- Selection of dopants
 - rare earth elements – intrinsic transition
 - transitional metals – extrinsic transition
 - codoping – energy transfer
- Matching crystal to dopants
 - ionic size
 - coordination number
 - chemical stability
- Site distortions
 - fluorescence lifetime
 - nonradiative absorption
 - excited state absorption
- Crystal growth
- * Crystal defects
 - scattering, smoke
 - stress
 - inclusions, voids, solid particles, Ir, etc.
 - inhomogeneity

§ Current Laser Materials Research

◊ Oxides:

- Cr⁴⁺ doped laser materials
 - Mg₂SiO₄, YAG, CAS, CGS, CAO, YSO, FAP
 - Cr⁴⁺ doped YSO has been successfully lased
- Rare earth doped laser materials
 - YAG, YAP, YSO, FAP, CaYAlO₄

◊ Fluorides:

- Cr³⁺ doped laser materials
 - LiSAF, LiCAF, LiSCAF, LiSCrF
- Rare earth doped laser materials
 - YLF, KYF, BYF
 - First demonstration of TSSG of KYF

§ Current Nonlinear Optical Materials Research

◊ Borates:

- BTO, SNB, KNB
- KNB – a new potential useful crystal

◊ Niobates:

- LiNbO₃, KLN, SBN
- Rare earth doped NLO materials
 - LiNbO₃, SBN,
 - Self frequency doubling
- Periodical structures for quasi-phase matching
 - LiNbO₃, LiTaO₃, BNN,

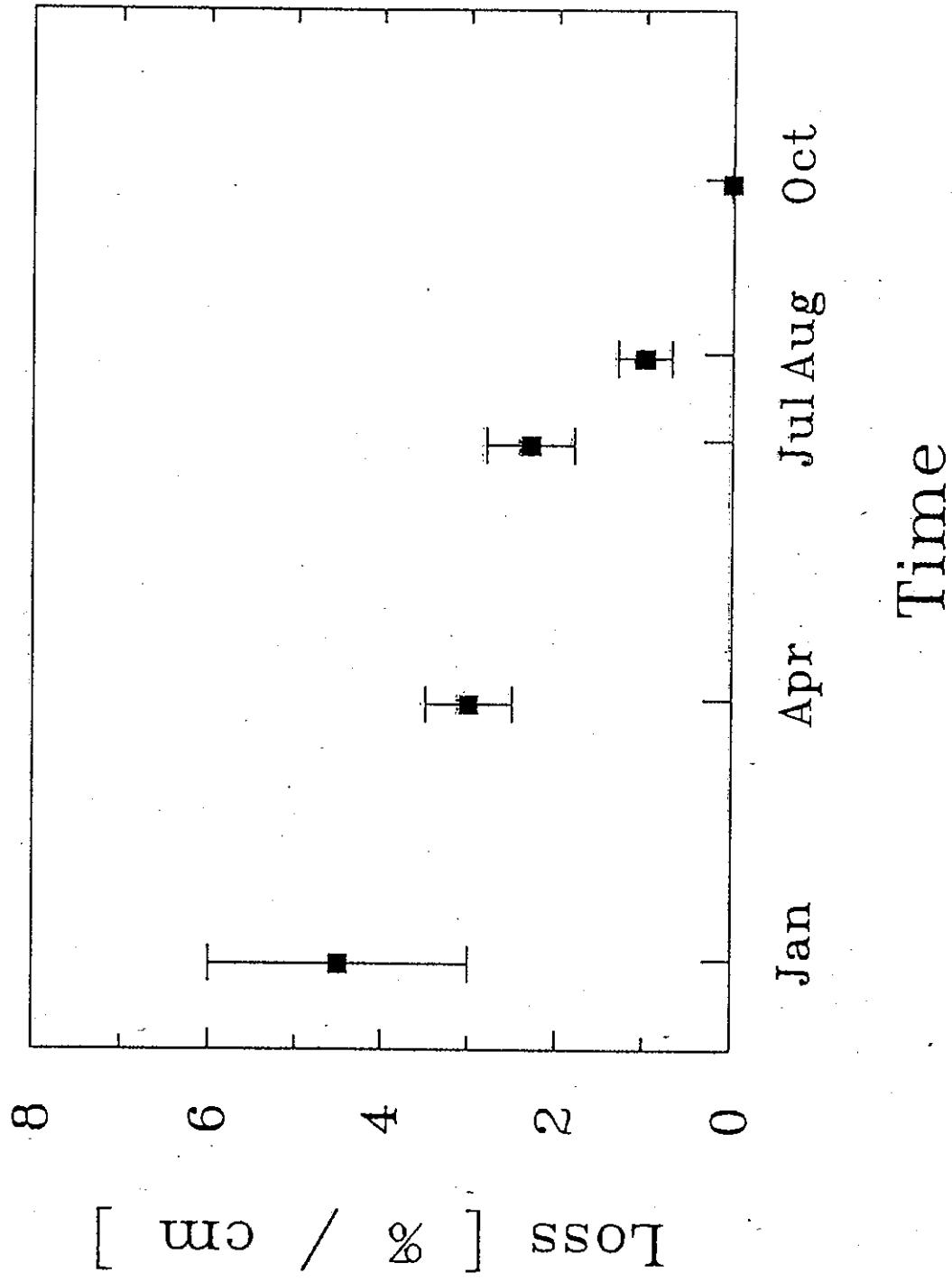
NEW SOLID STATE LASERS

Presented by Dr. Michael Bass

Industrial Affiliates' Day

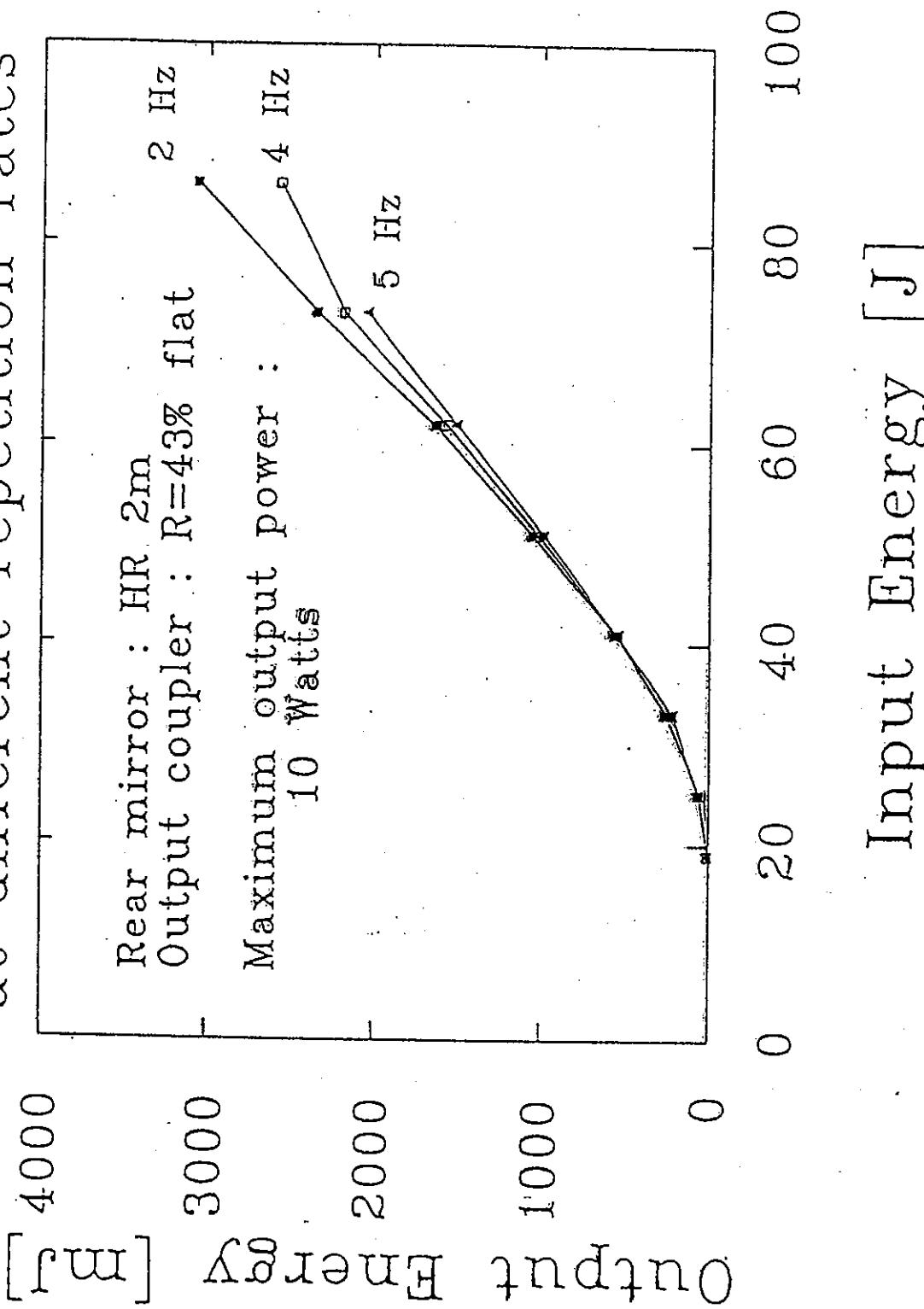
Monday, January 13, 1992

Losses in CrLiSAF

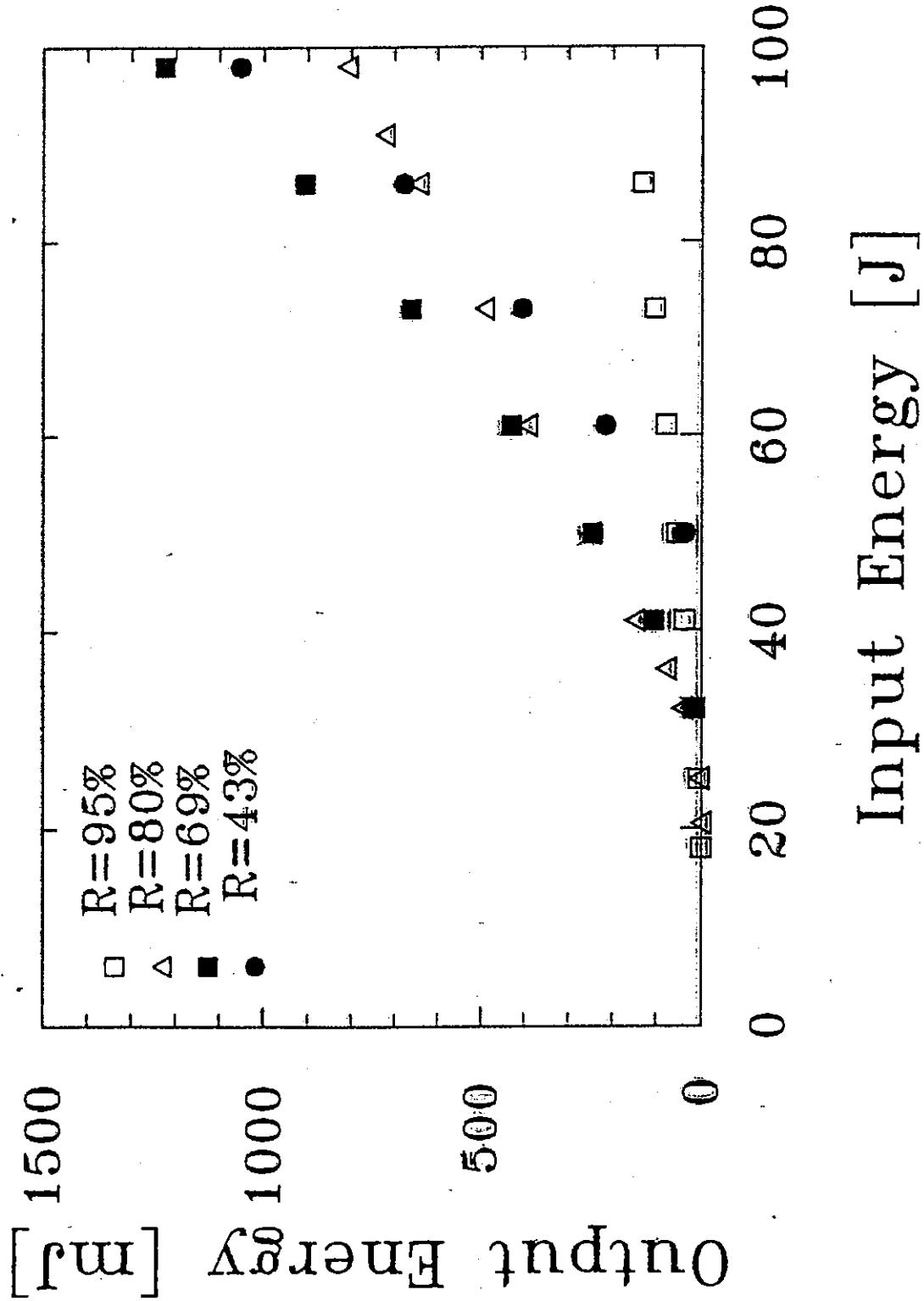




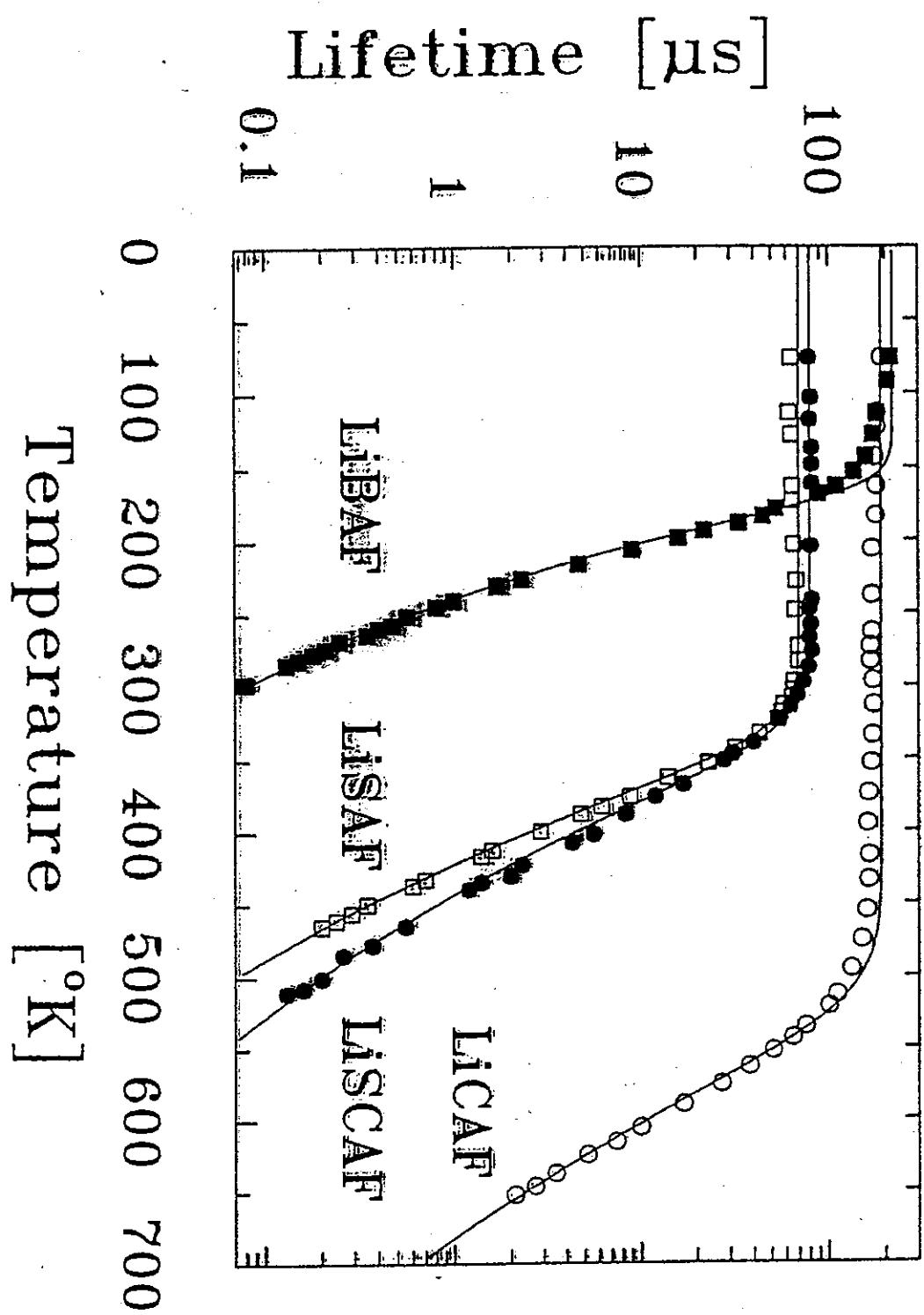
Laser performance of Cr:LiSAF at different repetition rates



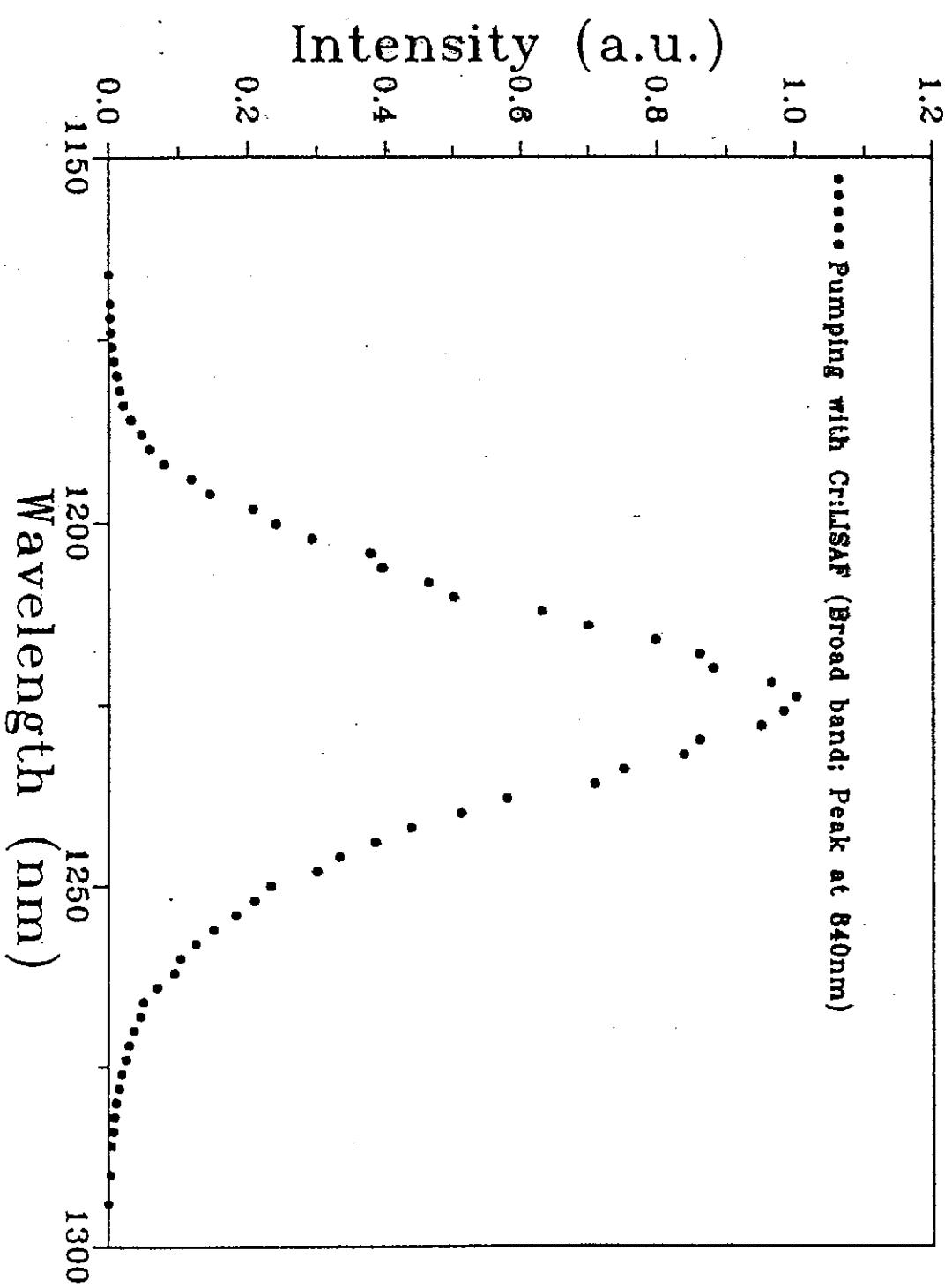
Input output energies for 2%Cr:LiSCAF



Lifetimes of Cr^{3+} in LiBAF, LiCAF and LiSCAF



Free-running Laser Spectrum of Cr:Y₂SiO₅ at 77K



1150 1200 1250 1300

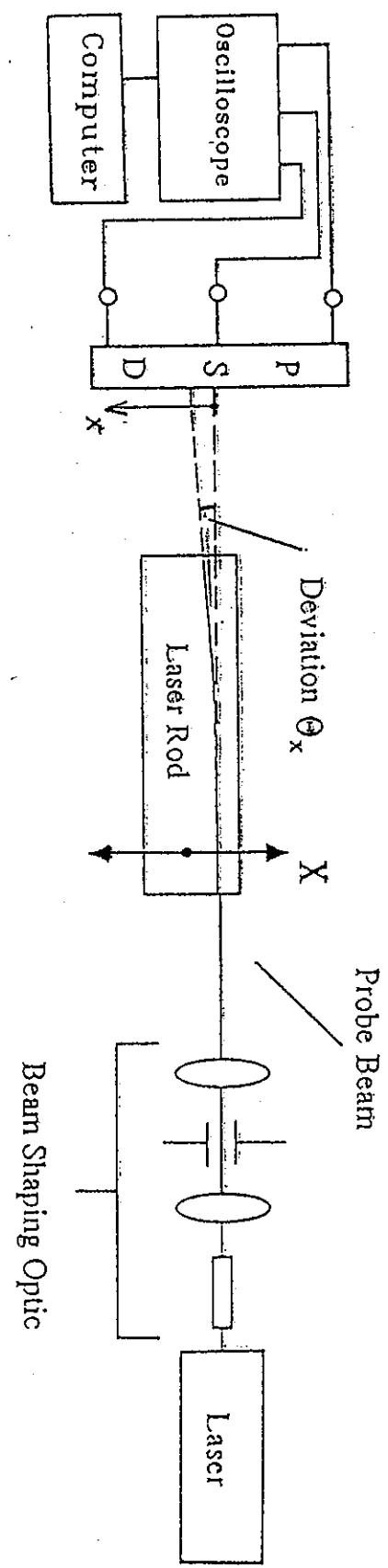
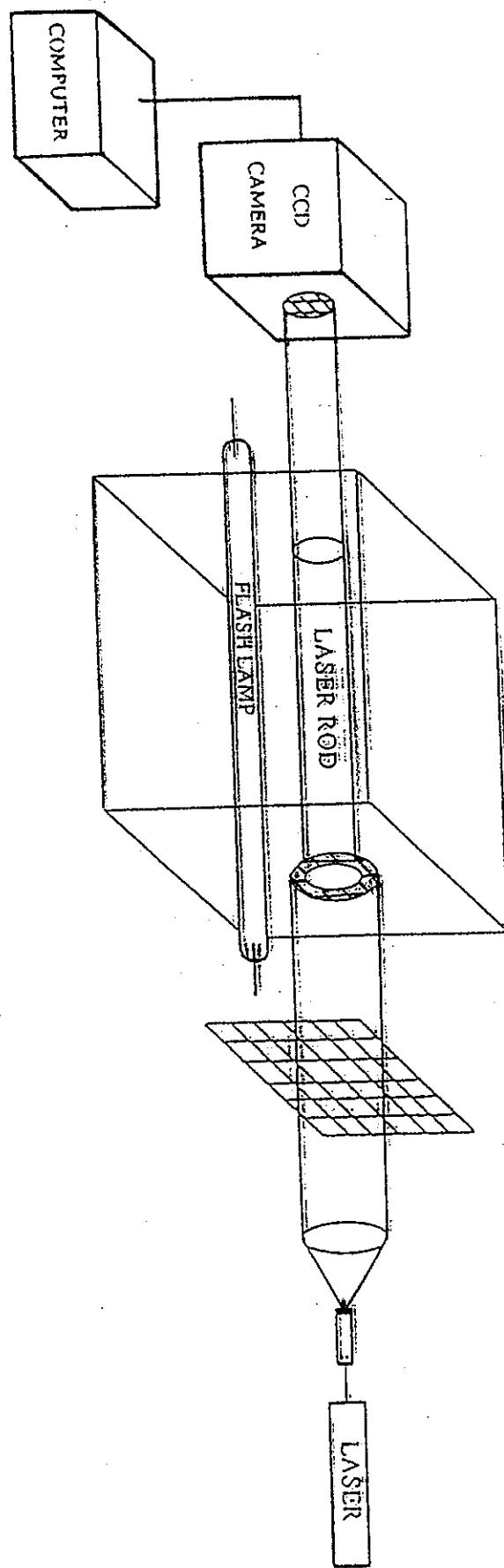
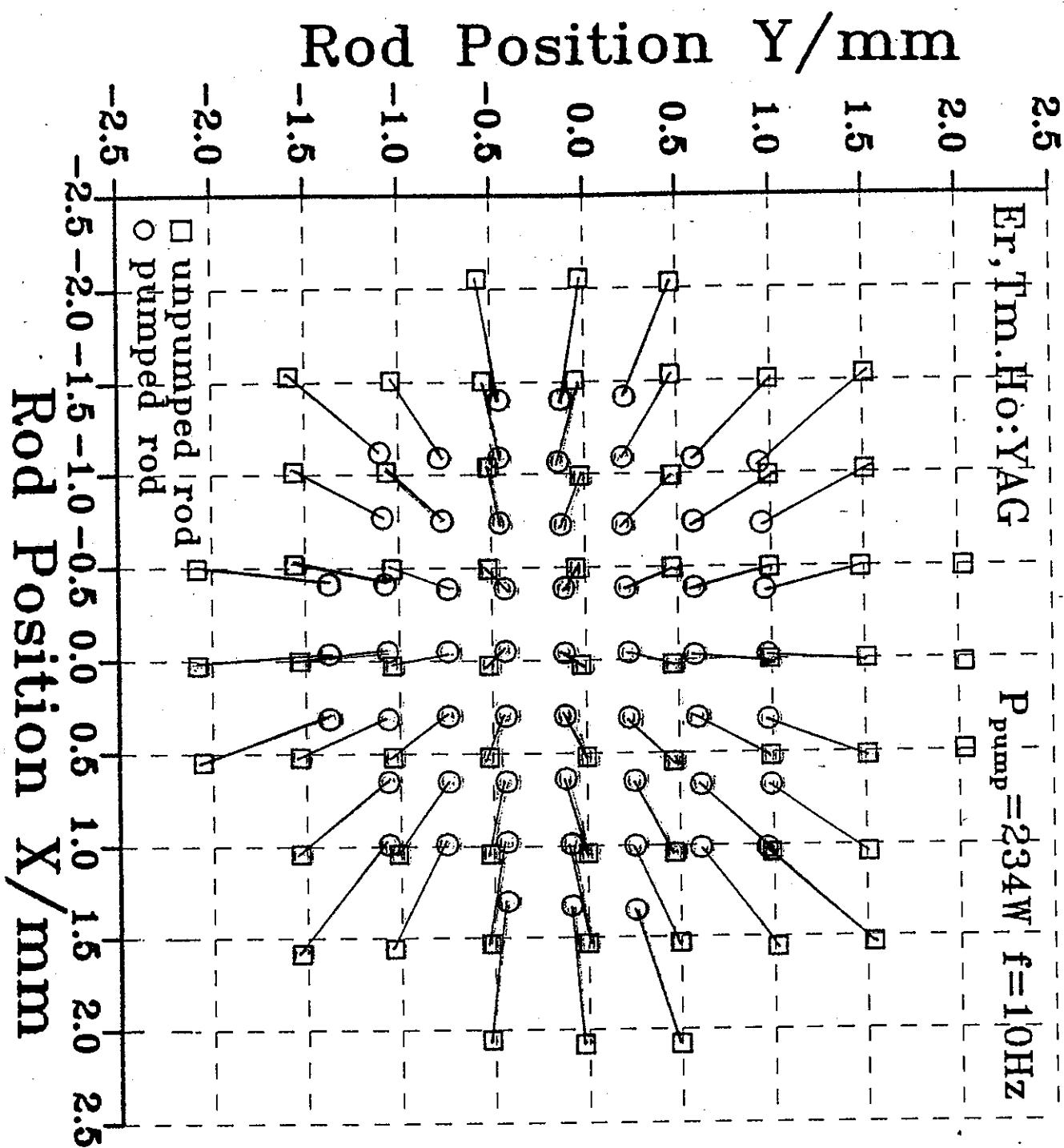


Fig. 1



6



SOLID STATE LASERS AND LASER SPECTROSCOPY

Faculty:

**Jin J. Kim, Professor of Physics and Electrical
Engineering**

**Bruce H.T. Chai, Professor of Physics and Mechanical
Engineering**

Postdoctoral:

Chil-Min Kim

Students:

Jim Scheid

Kijun Park

Ron Raike

Solid State Lasers and Laser Spectroscopy

Jin J. Kim and Bruce H. T. Chai

Center for Research in Electro-Optics and Lasers

University of Central Florida

Orlando, FL 32826

**Study the Physical Properties of Tunable Laser Host Materials
such as Cr³⁺ :LiSAF, LiCAF, LiSCAF, and Pr³⁺:YLF
for Diode Laser Pumping**

**---measurements of thermal expansion coefficients and
the indices of refraction**

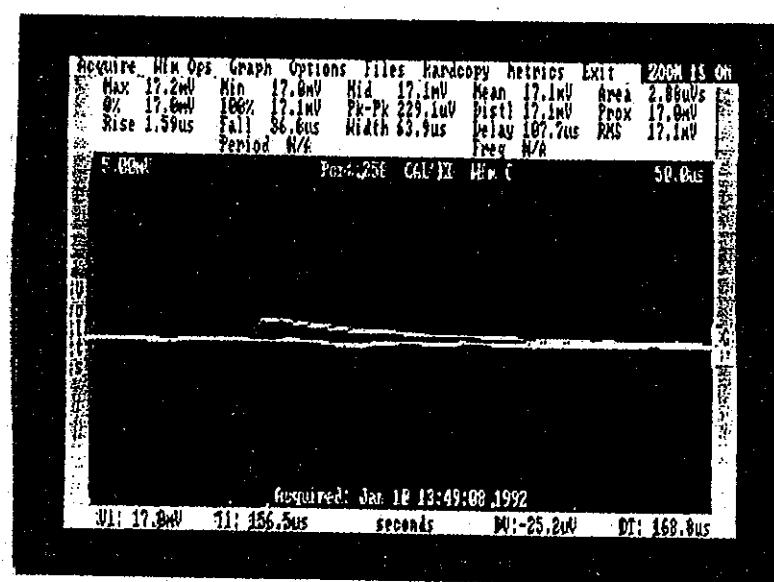
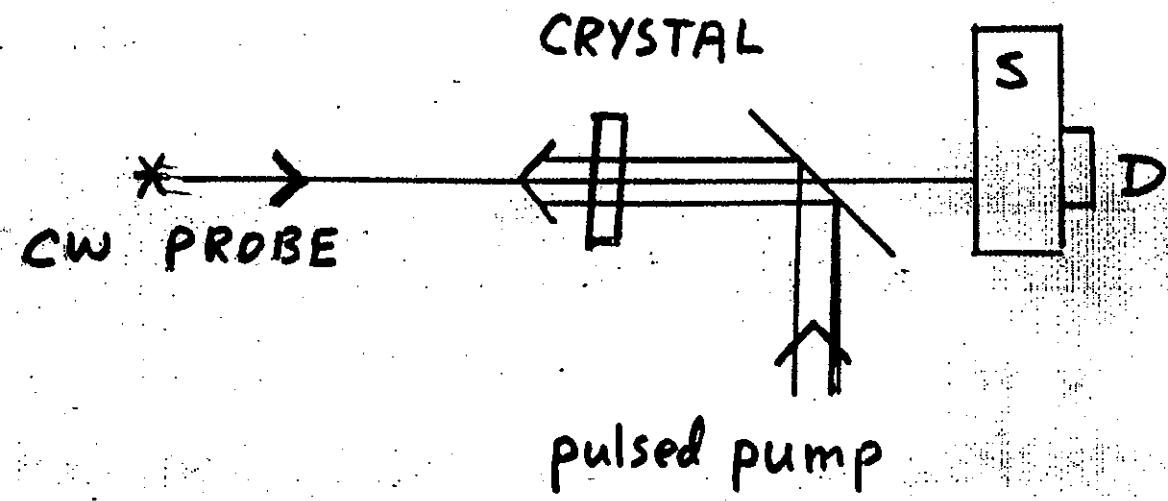
---excited state absorption cross sections

---transition properties

---laser gain

**Conduct Pulsed Dye Laser Pumping Experiments
in Simulation of High Average Power Diode Laser Pumping
of Tunable Solid State Lasers**

Set up CW Diode Laser Pumping of Pr³⁺:YLF Laser



Pump at 640 nm
Signal at 520 nm

Excited State Absorption Measurements

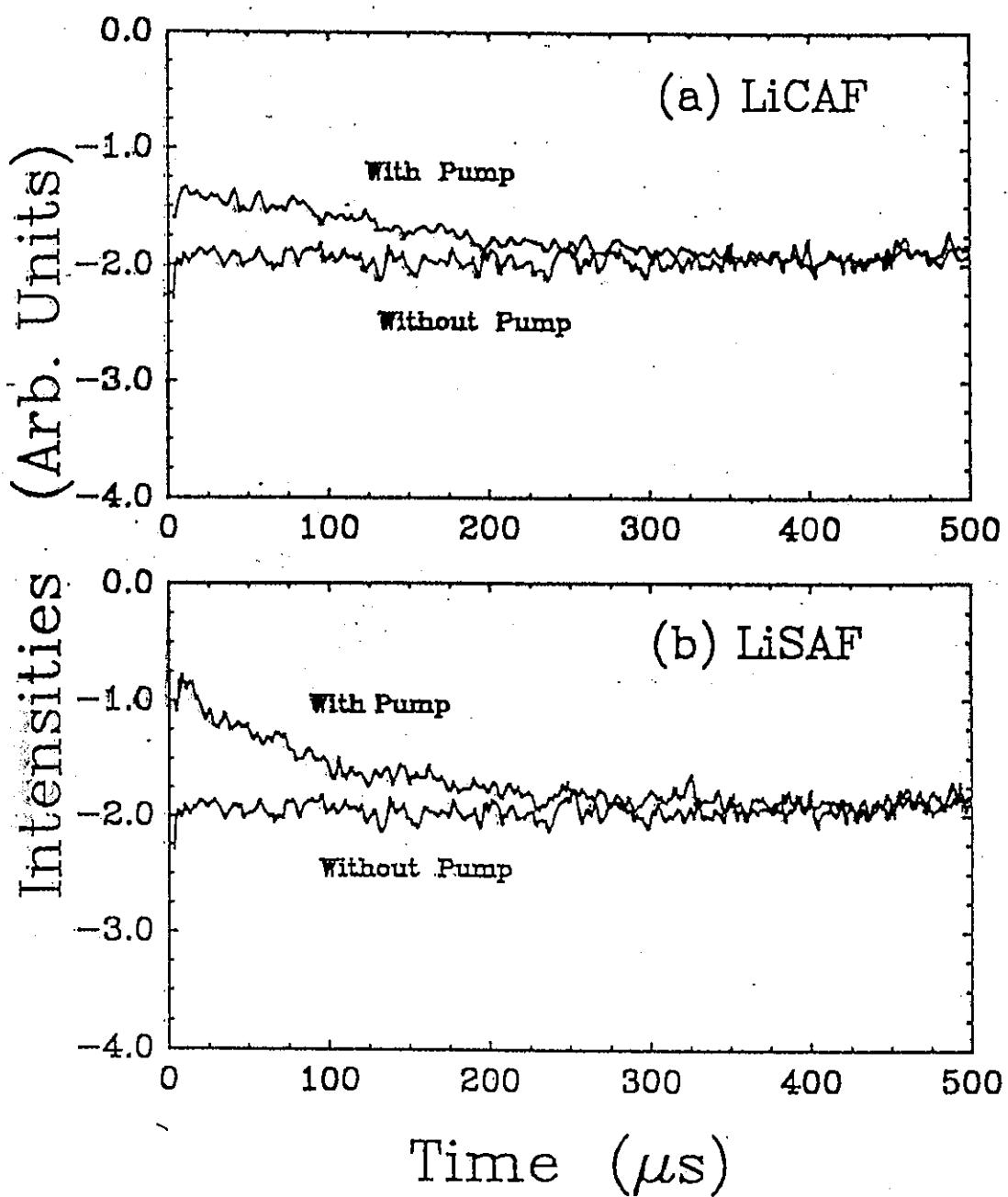


Fig. 3

J. J. Kim, et al.

Cr-doped LiSAF Laser Pumped by a Pulsed Dye Laser

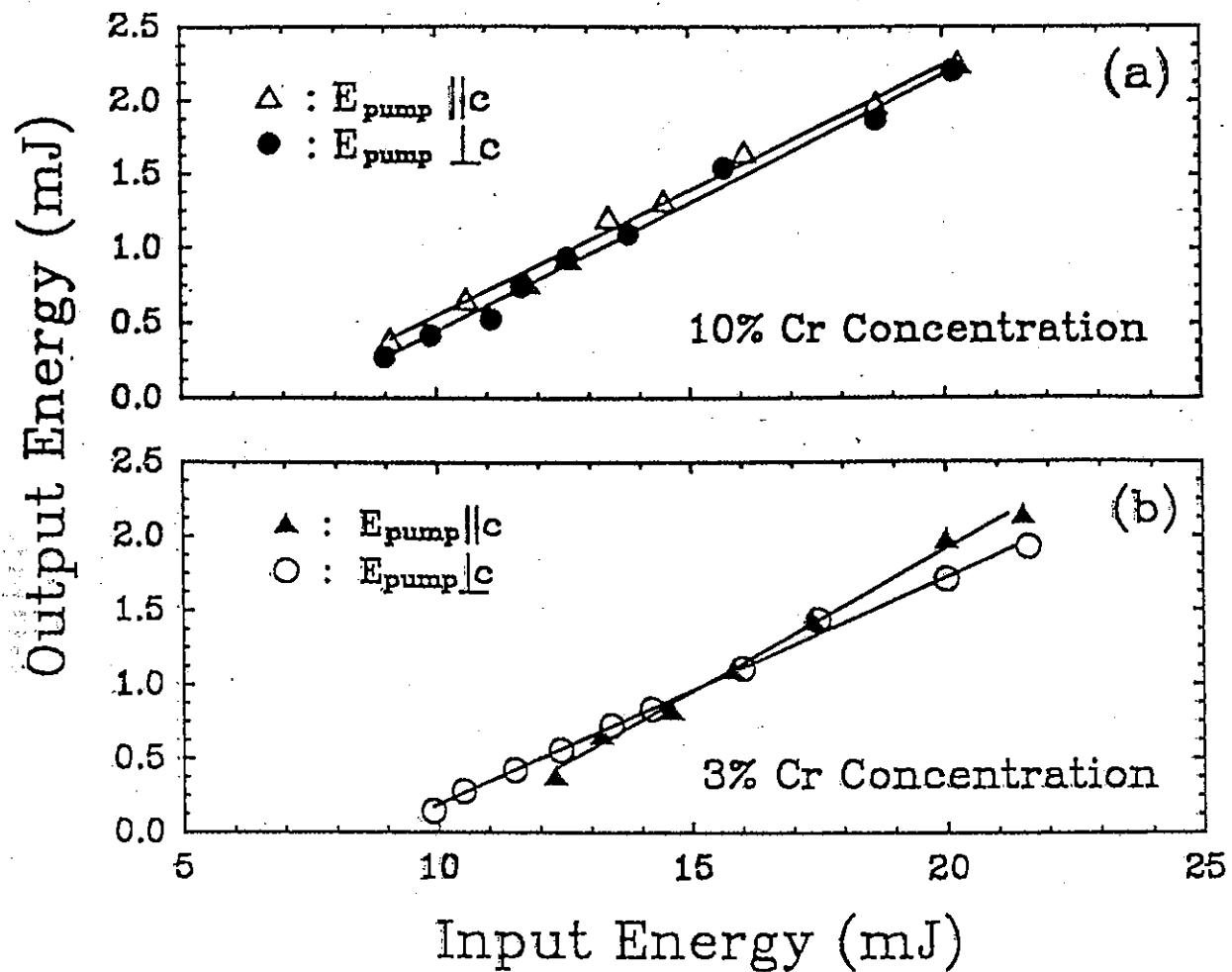


Fig. 1.

Y. T. Kim et al.

Chaos

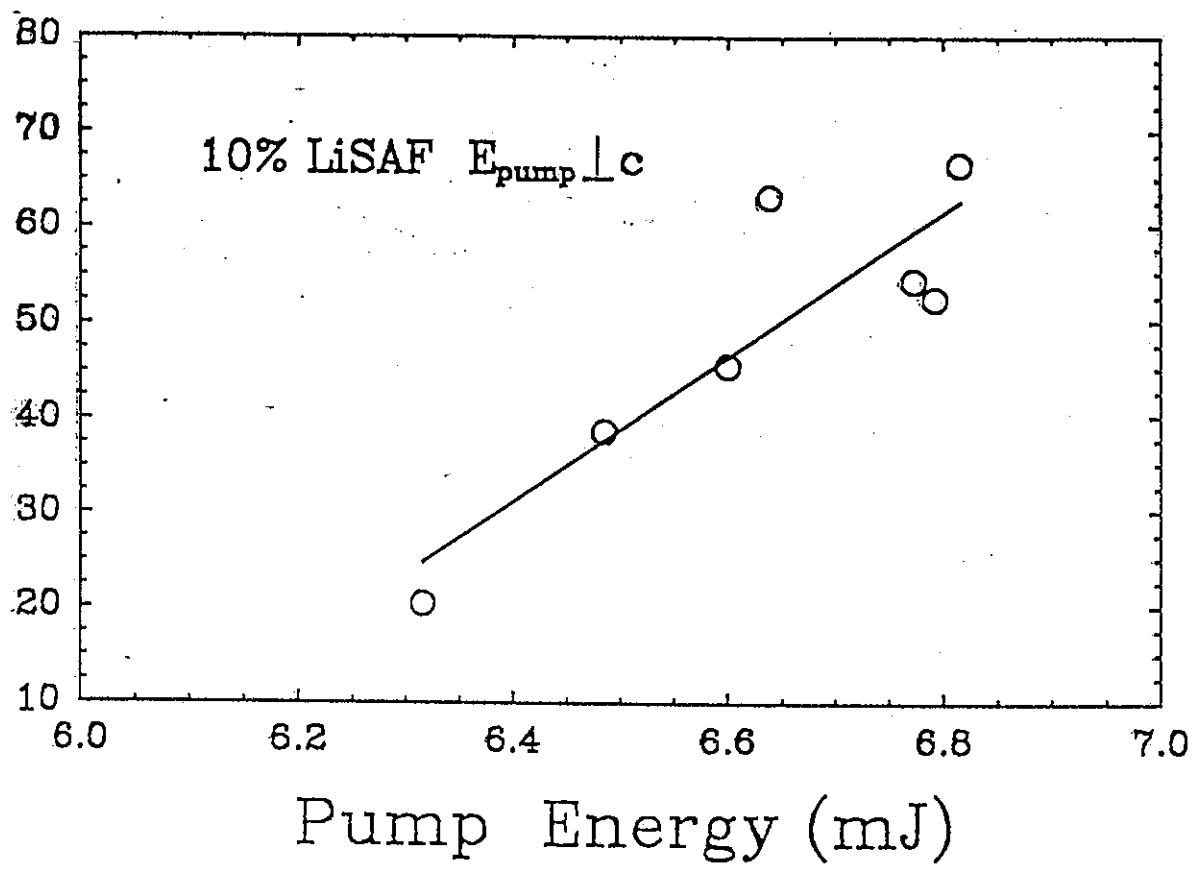


Fig. 2
J. J. Kim, et al
 Cr^{3+} : LiSAF

summary

**We have expertise in spectroscopic studies of materials
and laser research and development**

**We also have expertise in applications of pulsed power
technology to laser research and development**

DIODE-LASER-PUMPED SOLID-STATE LASERS

JEFFREY J. DIXON
DEPARTMENT OF ELECTRICAL ENGINEERING

CARNEGIE-MELLON UNIVERSITY
JANUARY 13, 1992

GROUP PERSONNEL

DR. DIVINDBER SAINI - POSTDOCTORAL FELLOW

DR. PIETER N. KEAN - POSTDOCTORAL FELLOW

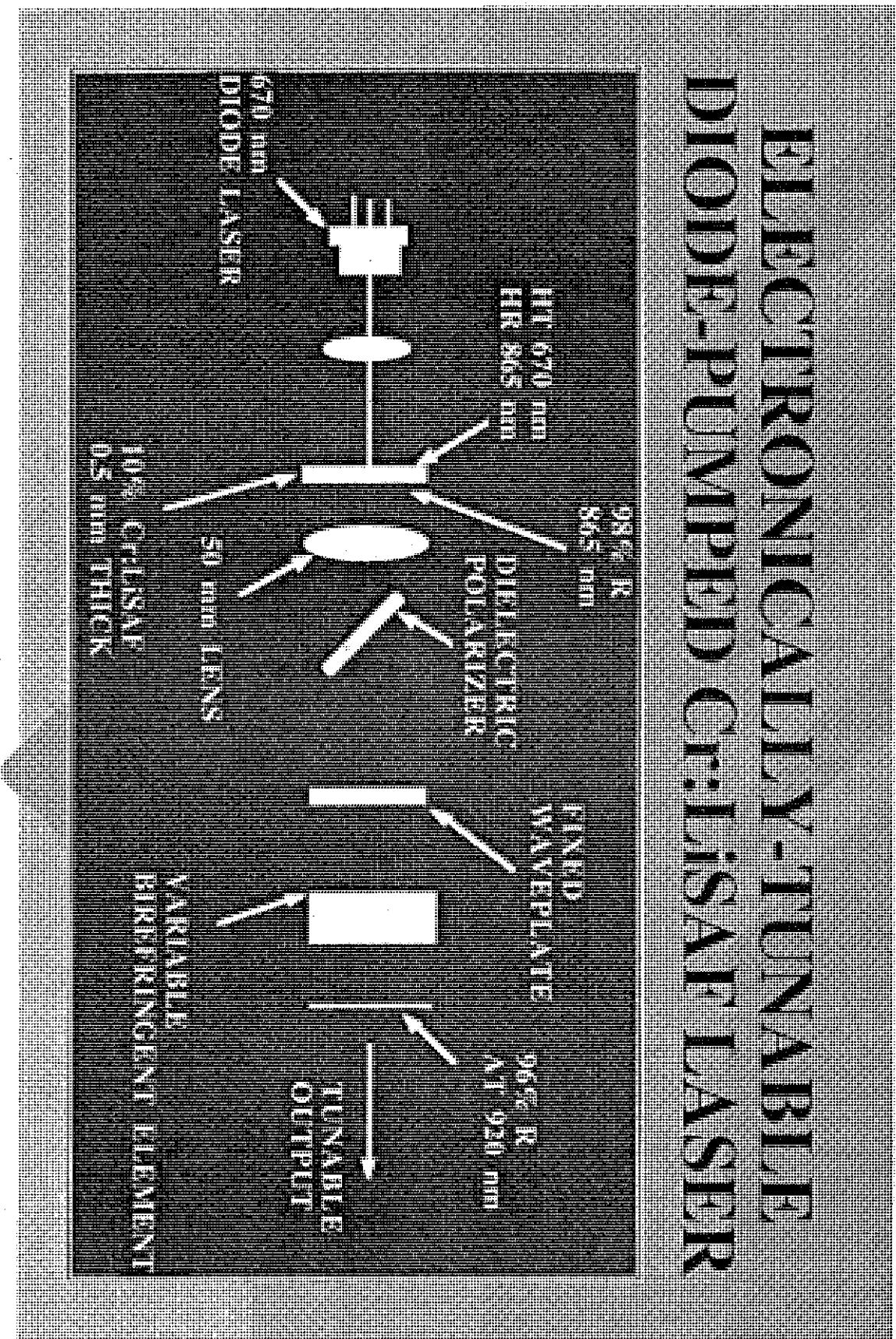
JEFF CUMBERSON - STUDENT

ERIC GRANN - STUDENT

HELEN VOSS - STUDENT

QI ZHANG - STUDENT

ELECTRONICALLY-TUNABLE, DIODE-PUMPED CRYSTAL LASER



PROS AND CONS OF DIODE PUMPING

ADVANTAGES

COMPARISON MODES

- APPLICATION STABILITY
- SPECIFIC, COMPACTNESS
- SPECIFIC, COMPARATIVE
- INERTIAL STABILITY
- LOW VACUUM REQUIREMENTS

DISADVANTAGES

EFFICIENCY VS. COMPLEXITY

COMPARISON MODE

- EFFICIENCY
- SIZE
- SPECIFICITY
- COHERENCE
- LIFETIME
- HIGH COST
- LOW OUTPUT POWER

PRIMARY GROUP OBJECTIVES

- INVESTIGATE NEW INNER MATERIALS
- DEVELOP PUMPING TECHNIQUES
- NEW MODELS
- NOVEL WAYS TO USE 'OLD' MODELS
- DEVELOP TECHNIQUES FOR NONLINEAR FREQUENCY CONVERSION
- INTERNAL KINETIC PROCESSES
- NONLINEAR OPTICAL MATERIALS

GROUPE PERSONNEL

DR. DIVINERSANI - POSTDOCTORAL FELLOW

DR. PETER N. KENN - POSTDOCTORAL FELLOW

JEFF CUTTERERSON - STUDENT

ERIC GRANN - STUDENT

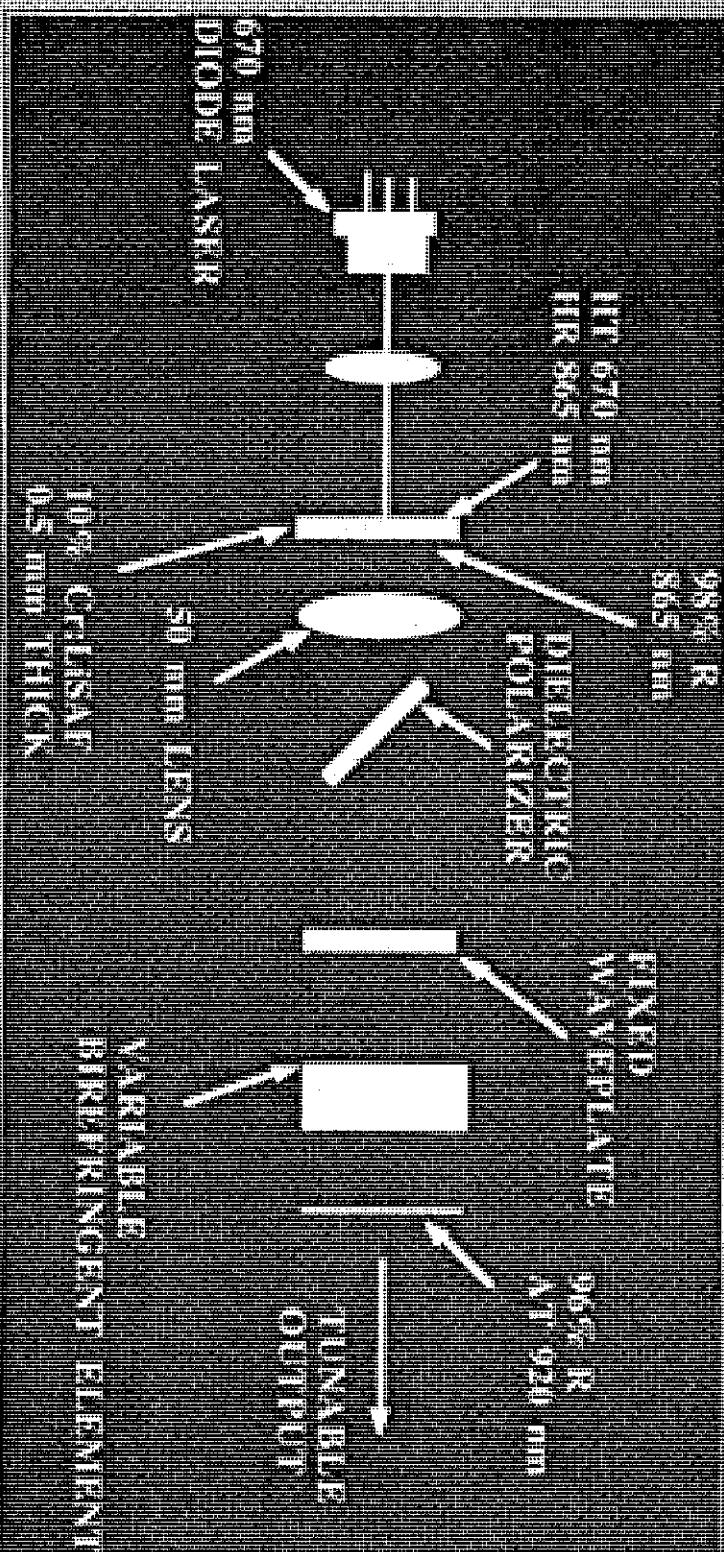
HILKE VÖSS - STUDENT

OLIZHANG - STUDENT

NEW MATERIALS

1. CRYSTAL
2. STOCHIMICRICAL COMPOUNDS
3. SPECTROSCOPY LAB
4. SINGLE-CRYSTAL FIBER PULLER

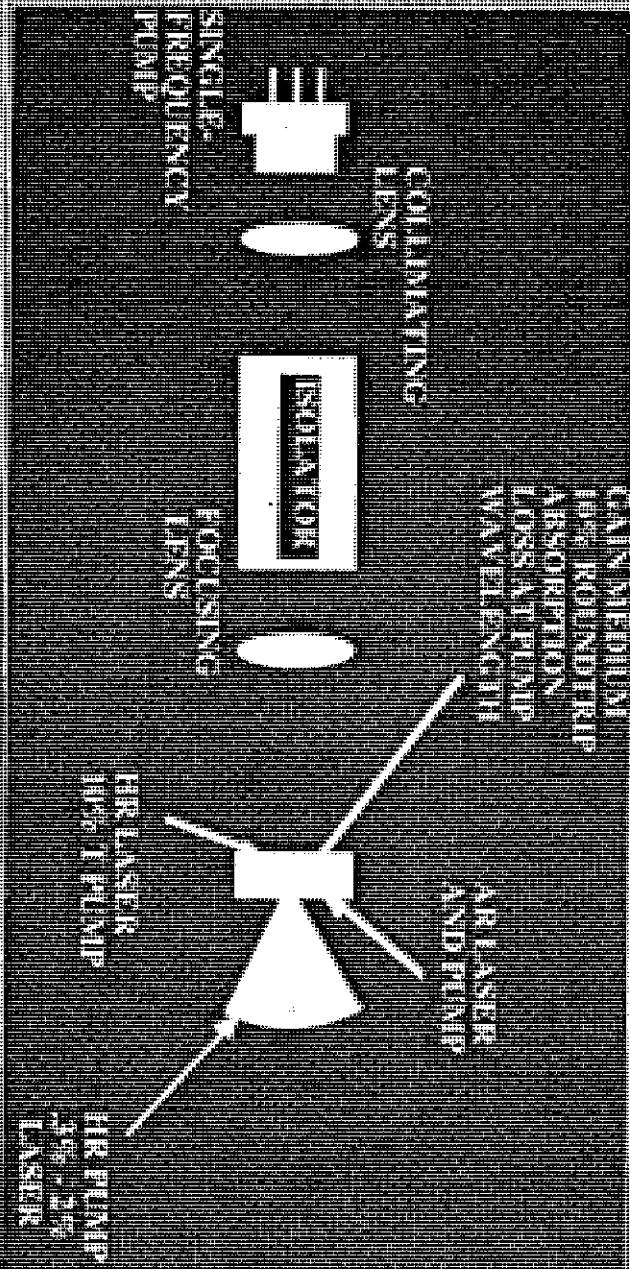
ELECTRONICALLY-TUNABLE DIODE-PUMPED Cr:LiSAF LASER



PUMPING TECHNIQUES

1. INTRACAVITY PUMPING
2. RESONANT PUMPING
3. CLOSE-COUPLED PUMPING
4. GTO-PUMPING

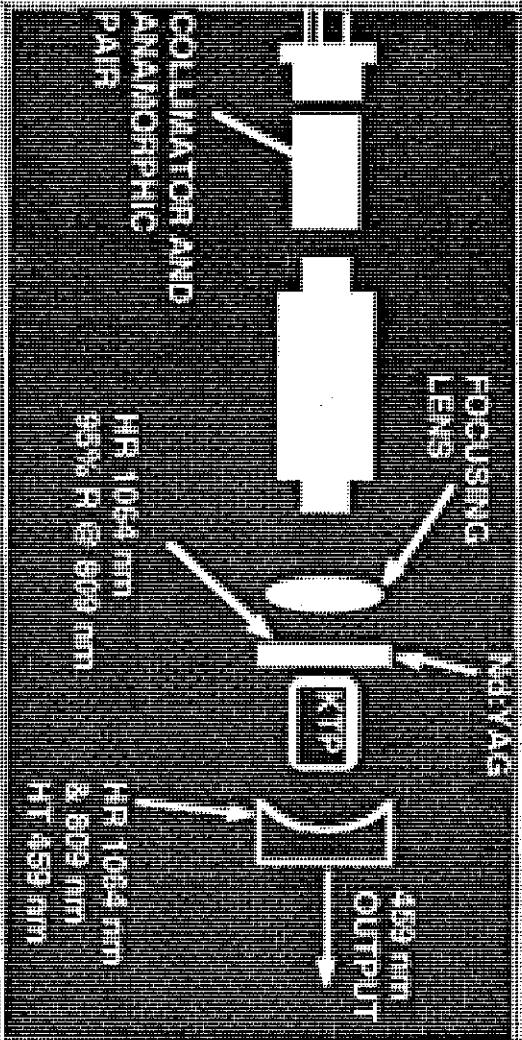
RESONANTLY-PUMPED SOLID-STATE LASER



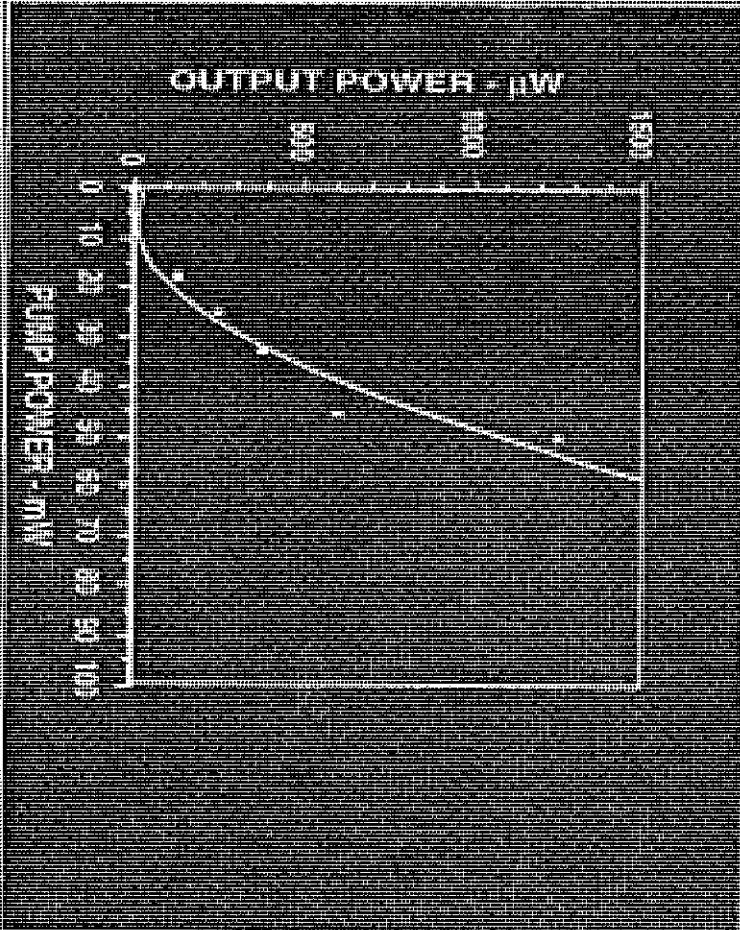
NONLINEAR FREQUENCY CONVERSION

1. RESONANTLY-PUMPED SUM FREQUENCY
GENERATION
2. DOUBLY-RESONANT HARMONIC GENERATION

PUMP-RESONANT SUPERFREQUENCY LASER



OUTPUT CURVE FOR PUMP-
RESONANT SUM FREQUENCY
LASER



CREOL Laser Plasma Laboratory for Science and Technology

Faculty

Dr Martin C. Richardson
Professor, Physics & Electrical Engineering

Dr William T. Silfvast
Professor, Physics & Electrical Engineering

Graduate Research Students

Howard Bender	Physics
Charles Bogusch	Electrical Engineering
Yinfei Chen	Electrical Engineering
Art Hanzo	Electrical Engineering
Feng Jin	Physics
Edward Miesak	Electrical Engineering
Gary A. Sweezy	Electrical Engineering

Visiting Scientists & Research Associates

Dr Paul Beaud	Institute of Applied Physics, University of Bern, Switzerland
Dr Ann Marie Eligon	CREOL
Dr Victor Yanovsky	General Physics Institute, Academy of Sciences, Moscow, USSR

Research Assistants

Karin Karpinchik	Physicist
Douglas Lattman	Computer Scientist
Jerry Thorpe	Physicist

Undergraduate Research Students

Tony DeLia	Physics
Nanette J. Gruber	Electrical Engineering

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Jerry Thorpe	Physicist

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Nanette J. Gruber	Electrical Engineering

Laser Plasma Laboratory Funding

Funding Support

State of Florida

National Science Foundation

Defence Advanced Research Projects Agency

Lawrence Livermore National Laboratory

Florida High Technology & Industry Council

Industrial Support

Laser Ionics Inc, Orlando, FL

Lightning Optical Corp, Tarpon Springs, FL

Newport Corp, Fountain Valley, CA

Quantum Technology Inc, FL

Schwarz Electro-Optics Inc, Orlando, FL

Tektronix Inc, Beaverton WA

PRIMARY COMPONENTS OF LPL

CREOL

LPL

SOFT X-RAY
PROJECTION
LITHOGRAPHY

PULSED X-RAY
MICROSCOPY

ULTRASHORT
LASER PULSE
INTERACTIONS

Advanced solid
state laser
development

X-ray emission
from laser
produced
plasmas

Advanced x-ray
optic &
electro-optic
technology

new laser materials
Ultrashort pulse
techniques
New focusing
techniques

Novel target
geometries
Spectral channelling

New optical designs
Ultrafast techniques
Improved fabrication
techniques

Unique properties of Laser Plasma X-Ray Sources

POINT SOURCE Micron-size point source.

Stable to microns in position

BRIGHTNESS High conversion efficiency to continuum and line emission. Isotropic or directional.

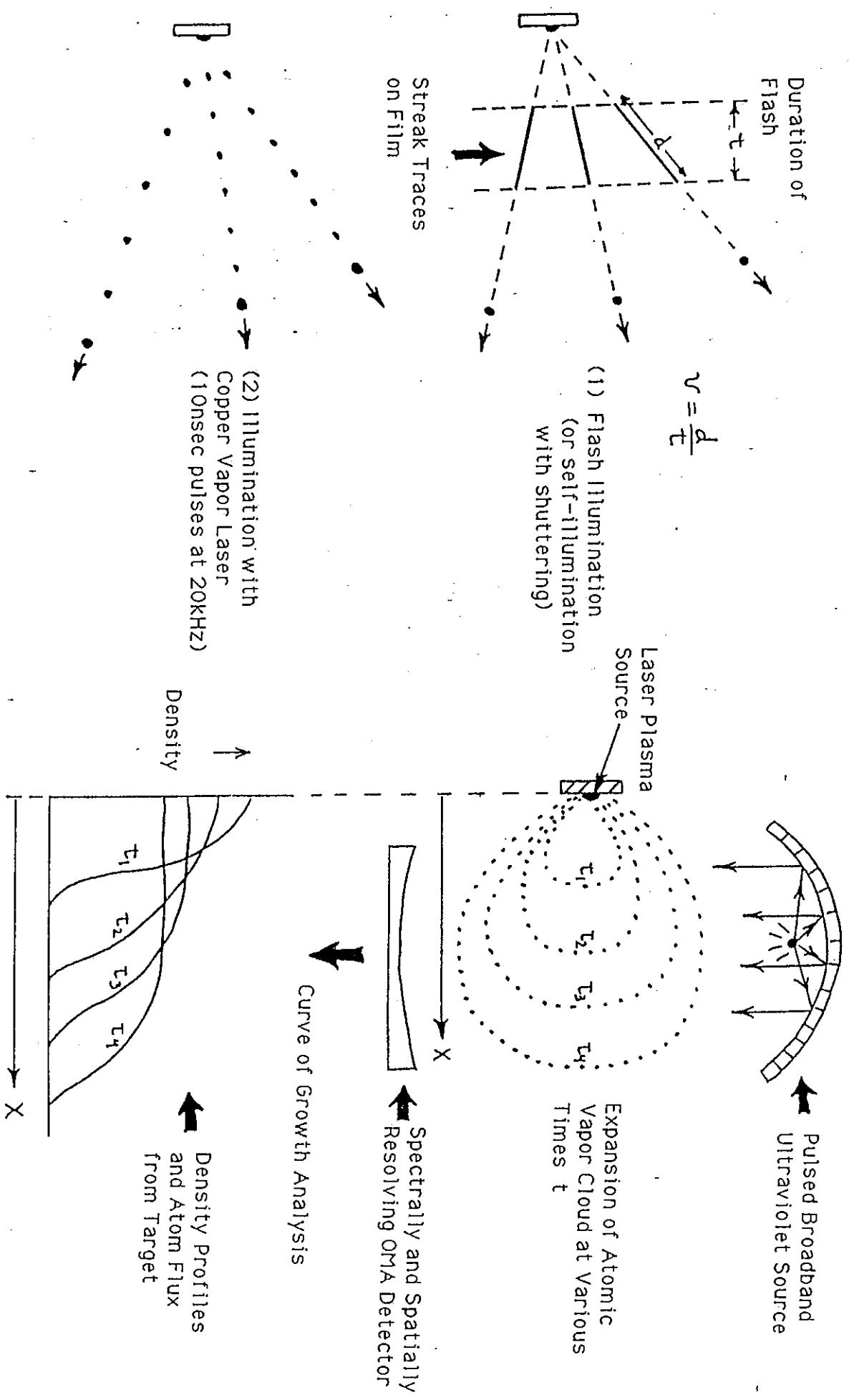
VARIABLE SPECTRUM Multi-component spectrum. Strong line emission.

Target dependent.

PULSED EMISSION Pulsed duration from millisecond to picosecond. flash and time-resolved studies.

COMPACT Laboratory-size footprint. Low cost. Clean vacuum environment. High repetition rate.

Atomic & heavy particle kinetics



Impact Areas of X-ray Microscopy

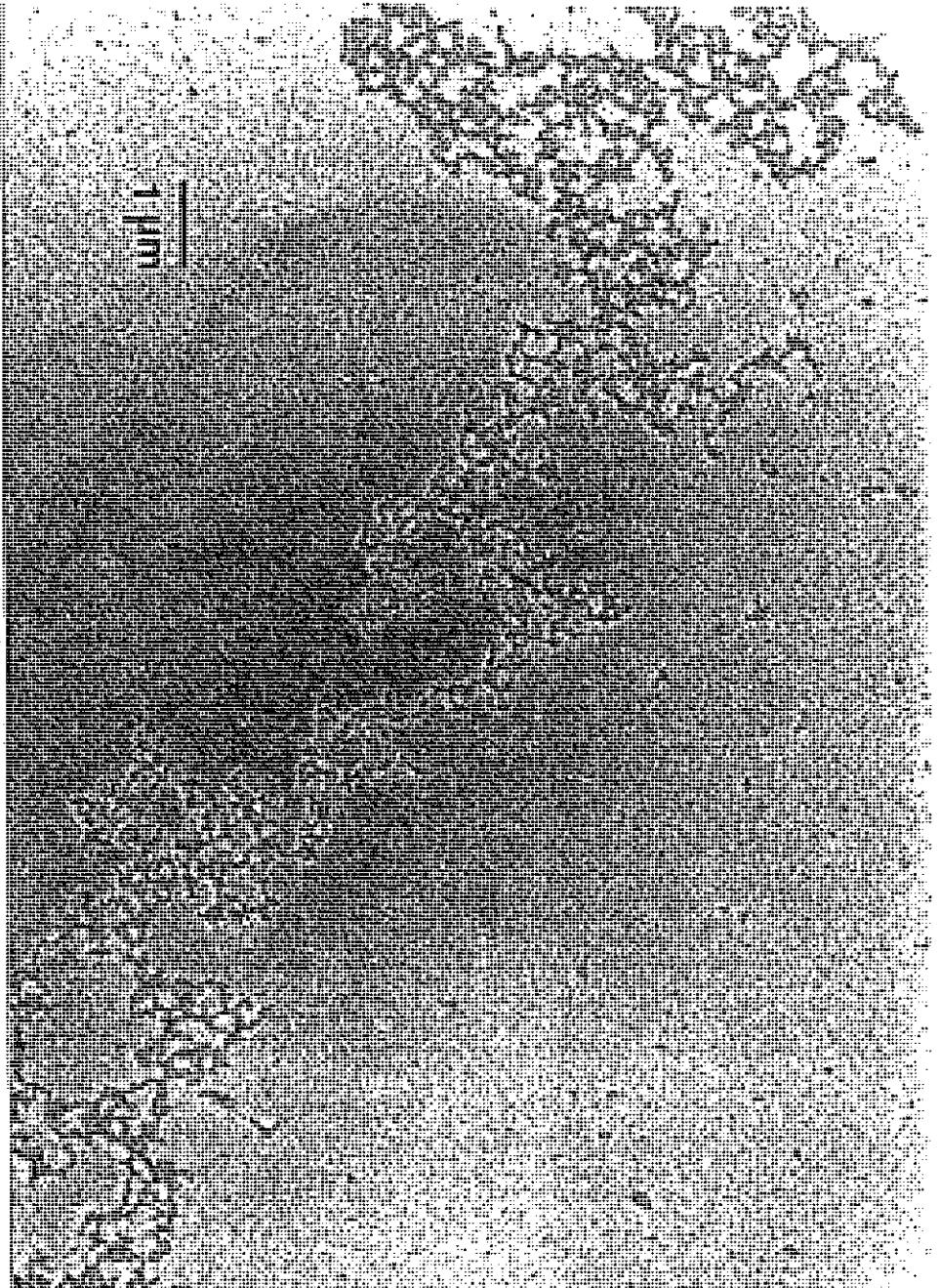
In vitro studies of live specimens. Soft X-rays are the only radiation which can penetrate several microns thick of biological stuff and provide high contrast images.

Dynamic studies of subcellular structure. Pulsed x-rays, say from a laser-plasma source provide picosecond (even less) time resolution.

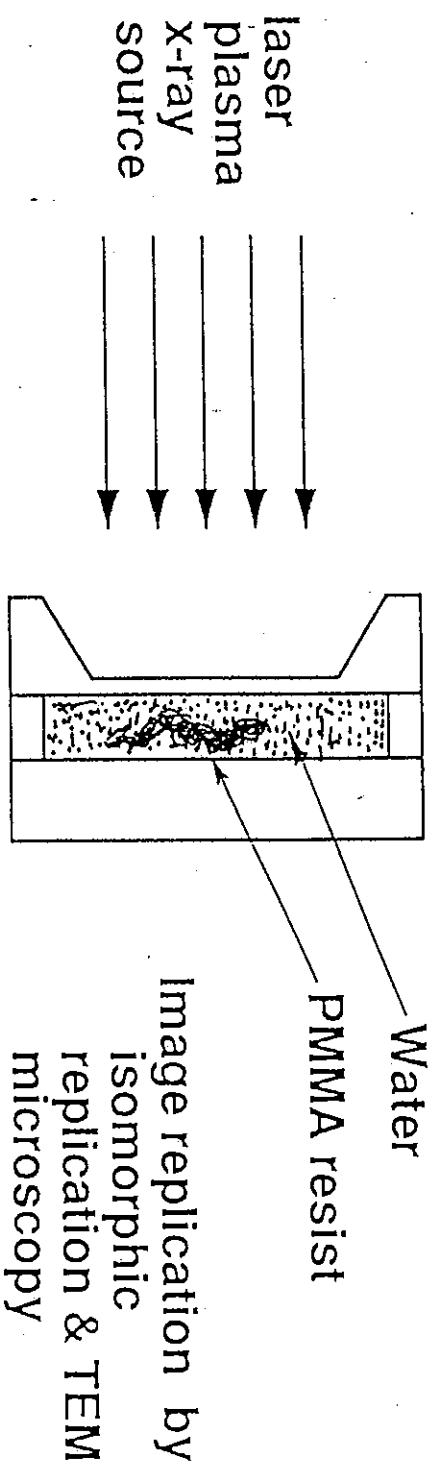
Location of specific elements. Elements possess specific absorption bands in the soft x-ray range. It is therefore possible to isolate the location of specific elements in color-sensitive images.

Thick specimens. The large depth of field permits thick cell structures to be imaged. Structures as thick as 50 microns may be possible.

High Resolution Image of *in-vitro* Human Chromosome



We have demonstrated a robust, reliable technique which permits the rapid application of x-ray microscopy to many biological and life science issues

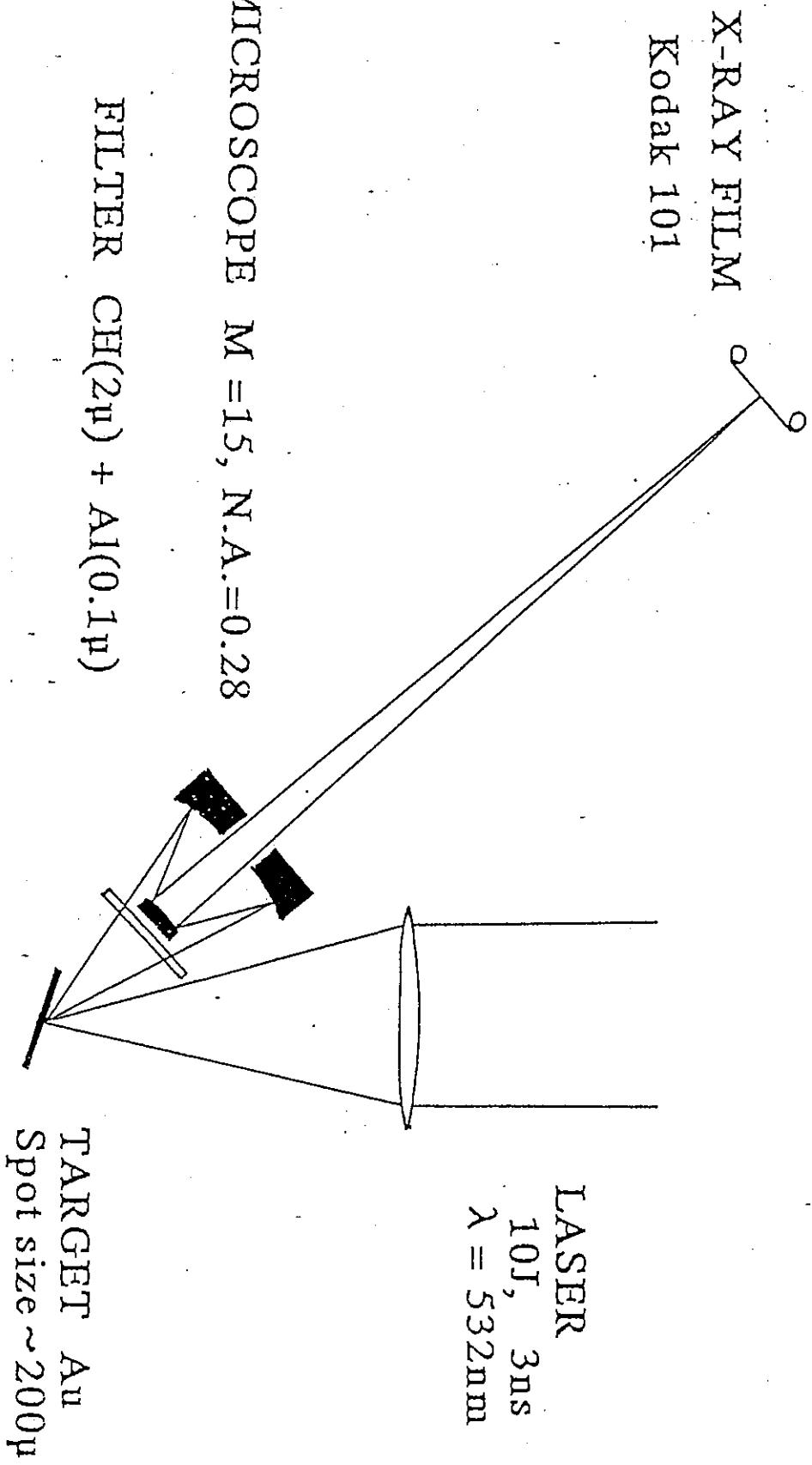


Advantages

Technique is non - specific to specimens studied

Relatively simple laser - plasma experimental set-up

Schwarzschild Microscope at 44A



A multi-media laser system

UCF

CREOL

100fs Front End

Ar ion laser pumped
mode-locked Ti:sapphire

Pulse stretcher

Cr: LiSAF Regenerative

Amplifier with chirped pulse
amplification

Cr: LiSAF / LiCAF Power Amplifier
and Passive FourPass Amplifier

Cr: LiSAF Preamplifier
Wavefront imaging

Pulse Compression
Beam transport
Beam focussing

Primary Scientific Objectives

UCF

CREOL

Laboratory x-ray lasers

Recombination lasers

Fast photoionization

Resonant photo-pumping

Dense plasma production

High density plasma physics Quasi - molecular ions

Super ionization of heavy Z elements

High field effects on ionized media QED effects

Nuclear studies

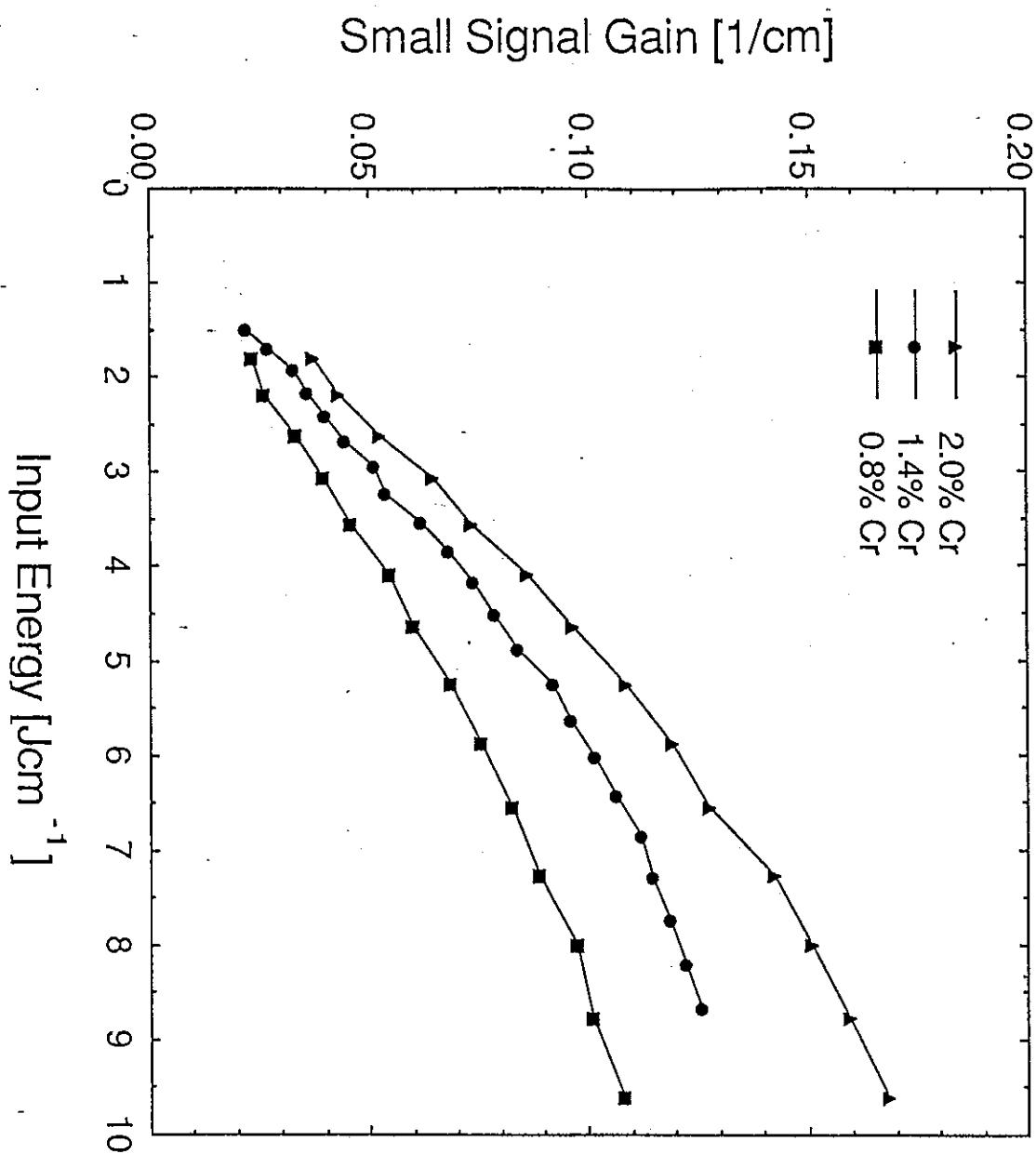
Ultrashort X-ray pulse generation

Dynamic materials studies (crystal & interfaces)

X-ray fluorescence Dynamic absorption measurements

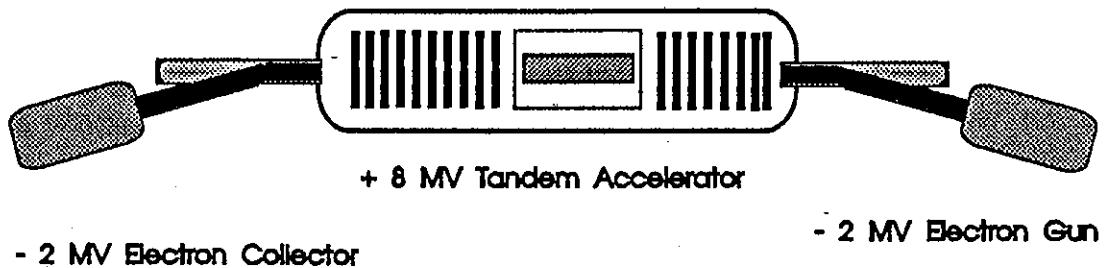
Picosecond x-ray microscopy

Small signal gain measurements of LiSAF



XUVFEL and FIRFEL(X-Ray/Vacuum-UV and Far-Infrared FEL)

Accelerator and Electron Beam Layout



Average Power: 1-3 kW !!

Wavelength Range

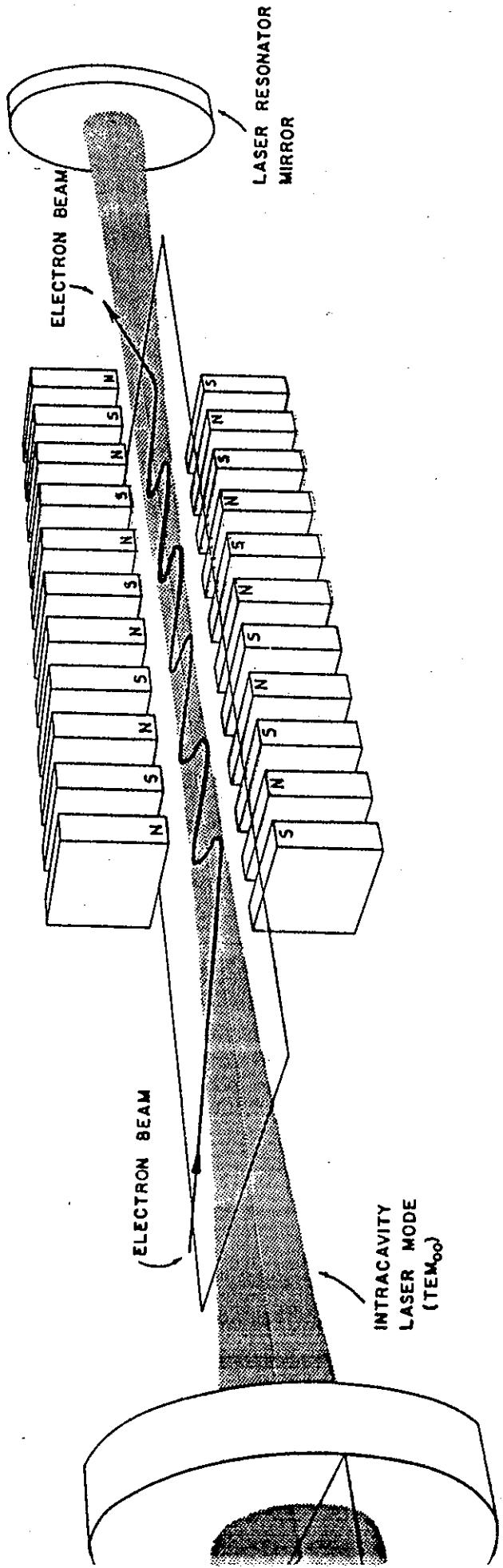
- Phase I: Mid- Infrared Region

$$\lambda = 10 - 80 \text{ microns}$$

- Phase II: Vacuum-Ultraviolet/ Soft X-Ray

$$\lambda = 0.04-0.4 \text{ microns}$$

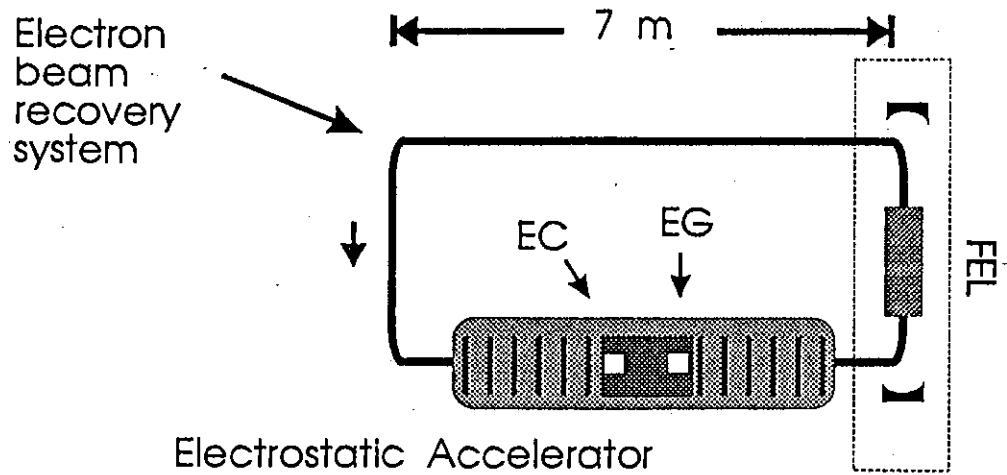
PERMANENT MAGNET ARRAY



LASER RESONATOR MIRROR
AND OUTPUT COUPLER

BASIC COMPONENTS OF
A FREE ELECTRON LASER
UCSB - QUANTUM INSTITUTE

CFELI (Compact Free-Electron Laser)

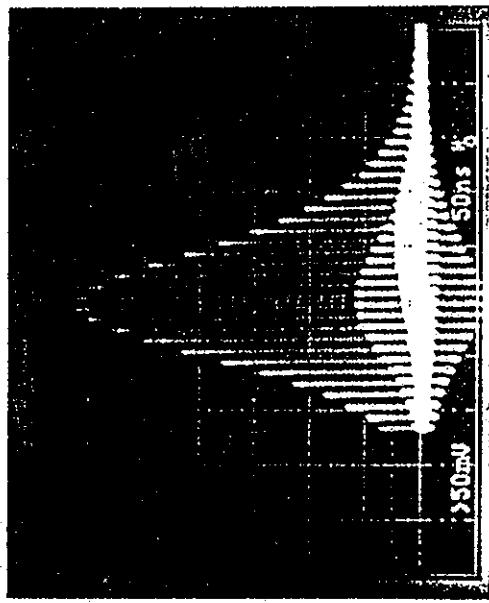
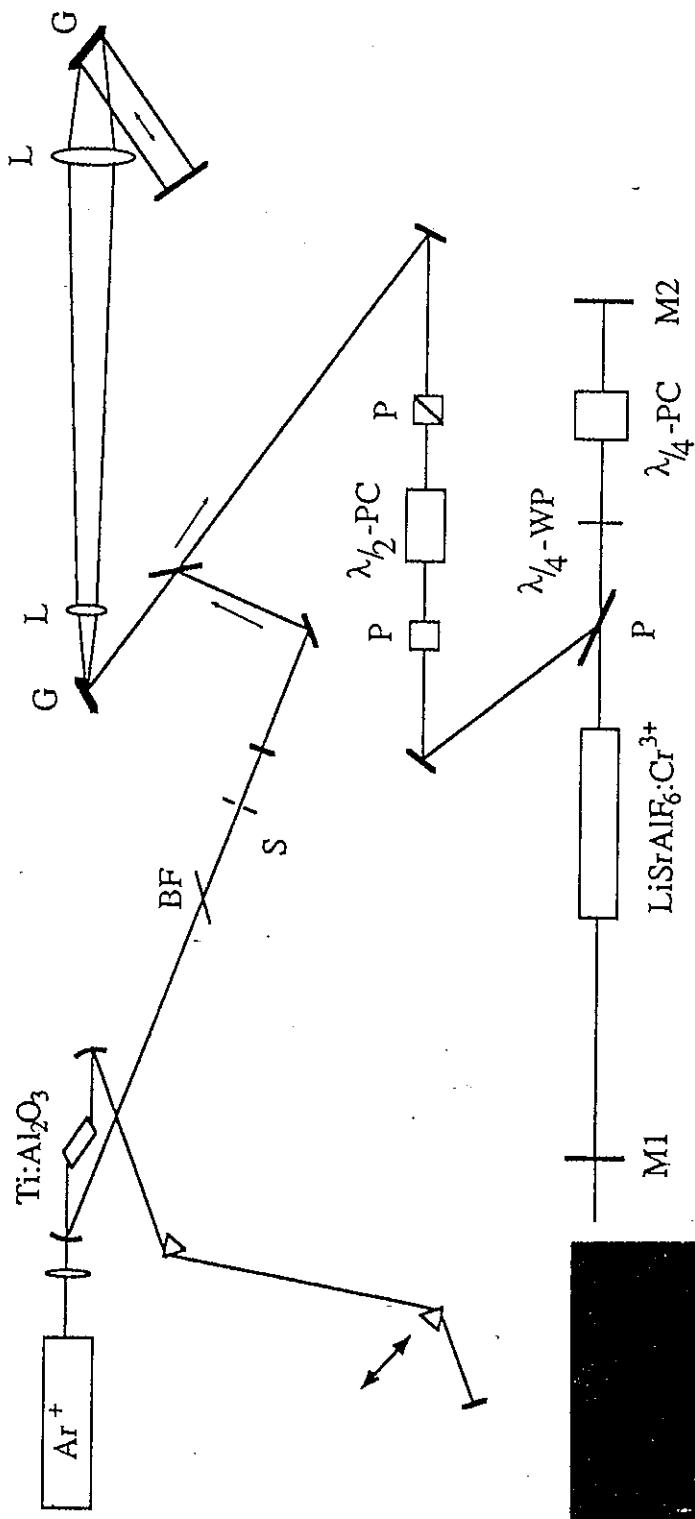


CFELI is presently under construction.

Average Power: 1 kW

Wavelength Range: 120 - 800 micrometers

LiSAF regenerative amplifier for chirped 100fs pulses



Future Work

Improved laser plasma x-ray sources

- Reduced effects of plasma and particulate debris
- Higher x-ray conversion efficiency
- High repetition rate

High resolution x-ray optics

- Further experiments with contact and reflection microscopes
- Active image magnification and registration
- Applications to biology and life sciences

High intensity lasers

- Amplifier studies
- Experiments at ultra-high focused intensities

CREOL FEL PROJECT

Major Objectives:

- Develop continuously tunable sources in regions of the electromagnetic spectrum where conventional sources do not exist.
- Make the laser sources available to science and industry through a state funded user's facility.

Scientific and Technical Staff:

Luis Elias, Professor of Physics, Director of CREOL FEL

Isidoro Kimel, Theoretical Senior Physicist

Huabei Jiang, Postdoctoral Researcher

Muffit Tecimer, Postdoctoral Trainee

Kent Hopkins, Junior Physicist, FEL Laboratory Manager

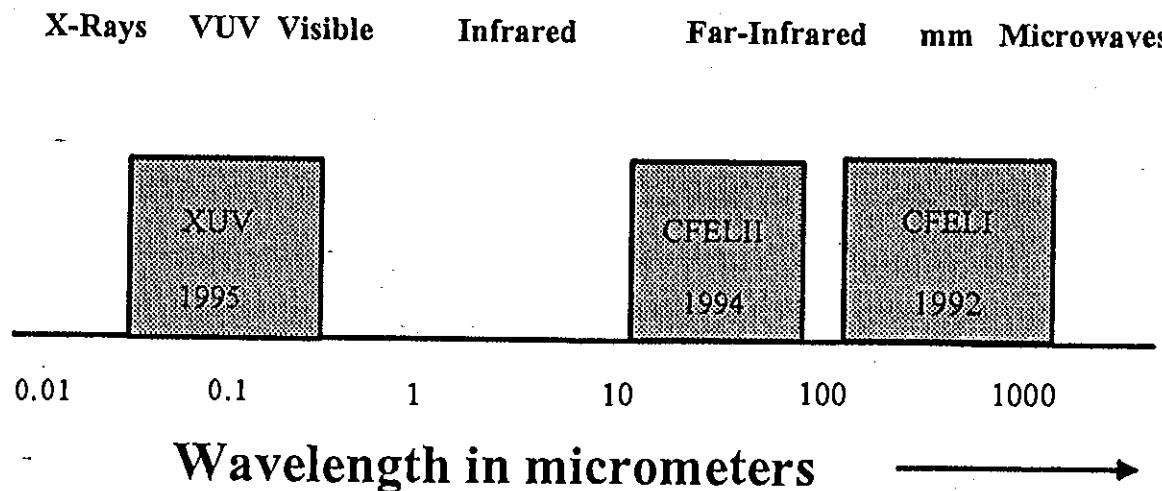
Eduardo Ugaz, Visiting Physicist

Paul Tesch, Graduate Student

3 Undergraduate Students

Administrative Staff:

Gerald Grover, Administrative Assistant



Applications

Chemistry
Microchip etching

Solid State Physics Fusion Energy
Biophysics
Medical

GROUND-BASED LASER TRACKING AND IMAGING
OF SPACE AND AIRBORNE OBJECTS

WAVE PROPAGATION GROUP

Ronald L. Phillips

Professor of Electrical Engineering
and
Professor of Mathematics

Students

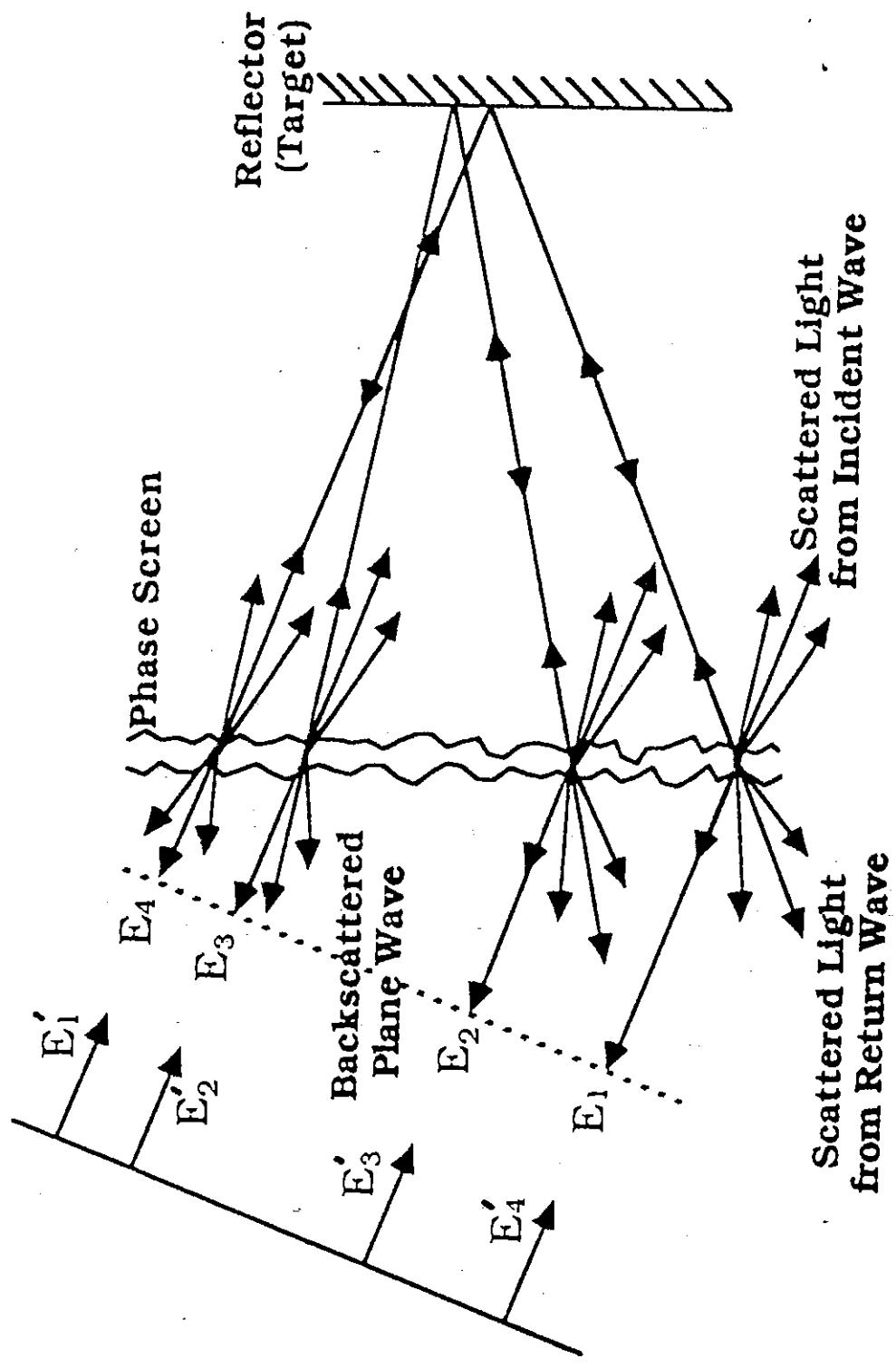
Robert Heileman, M.S. Electrical Engineering

Robert Murphy, Ph.D. Electrical Engineering

Dara Molen, M.S. Mathematics

Center for Research in Electro-Optics and Lasers



Incident Plane Wave

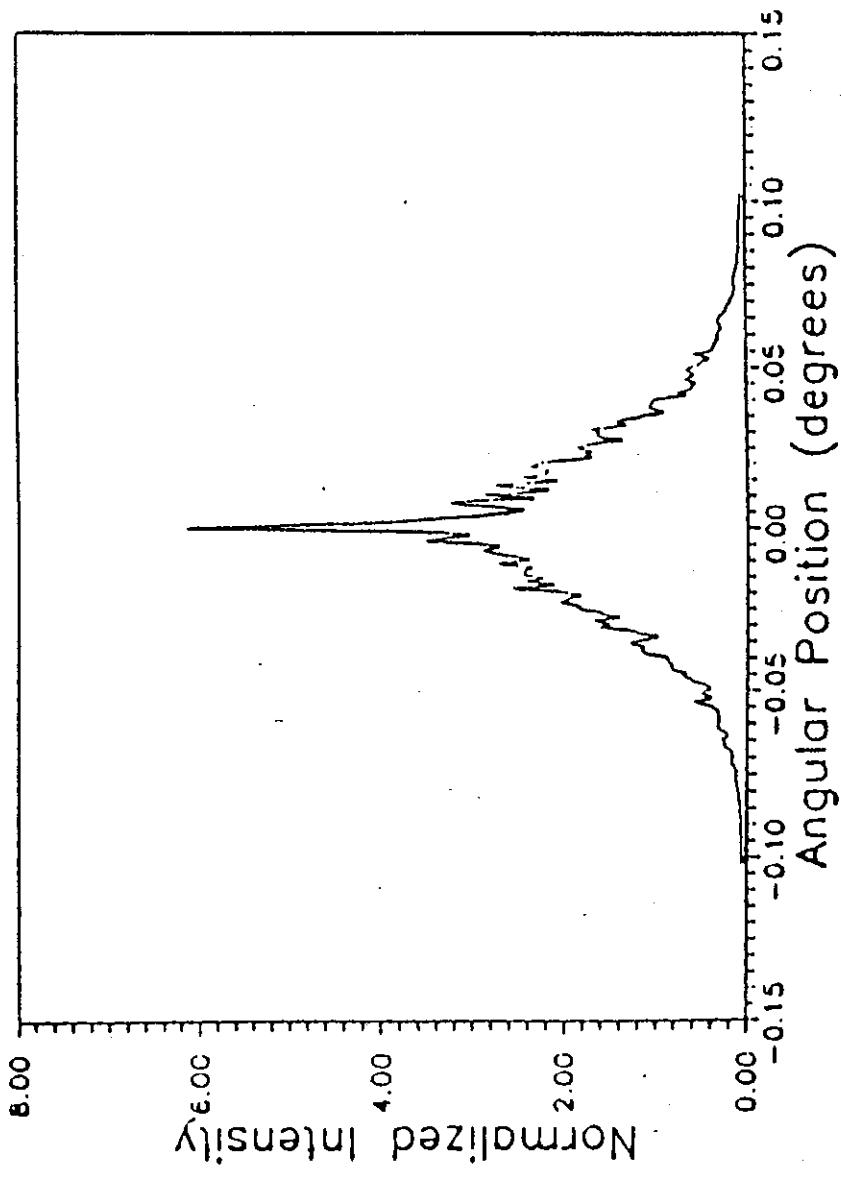


Figure 2. Angular distribution of the far field intensity of the backscatter for a normally incident wave. The computer simulation was performed for a strong turbulent random phase screen with averaging of returns from 100 pulses.



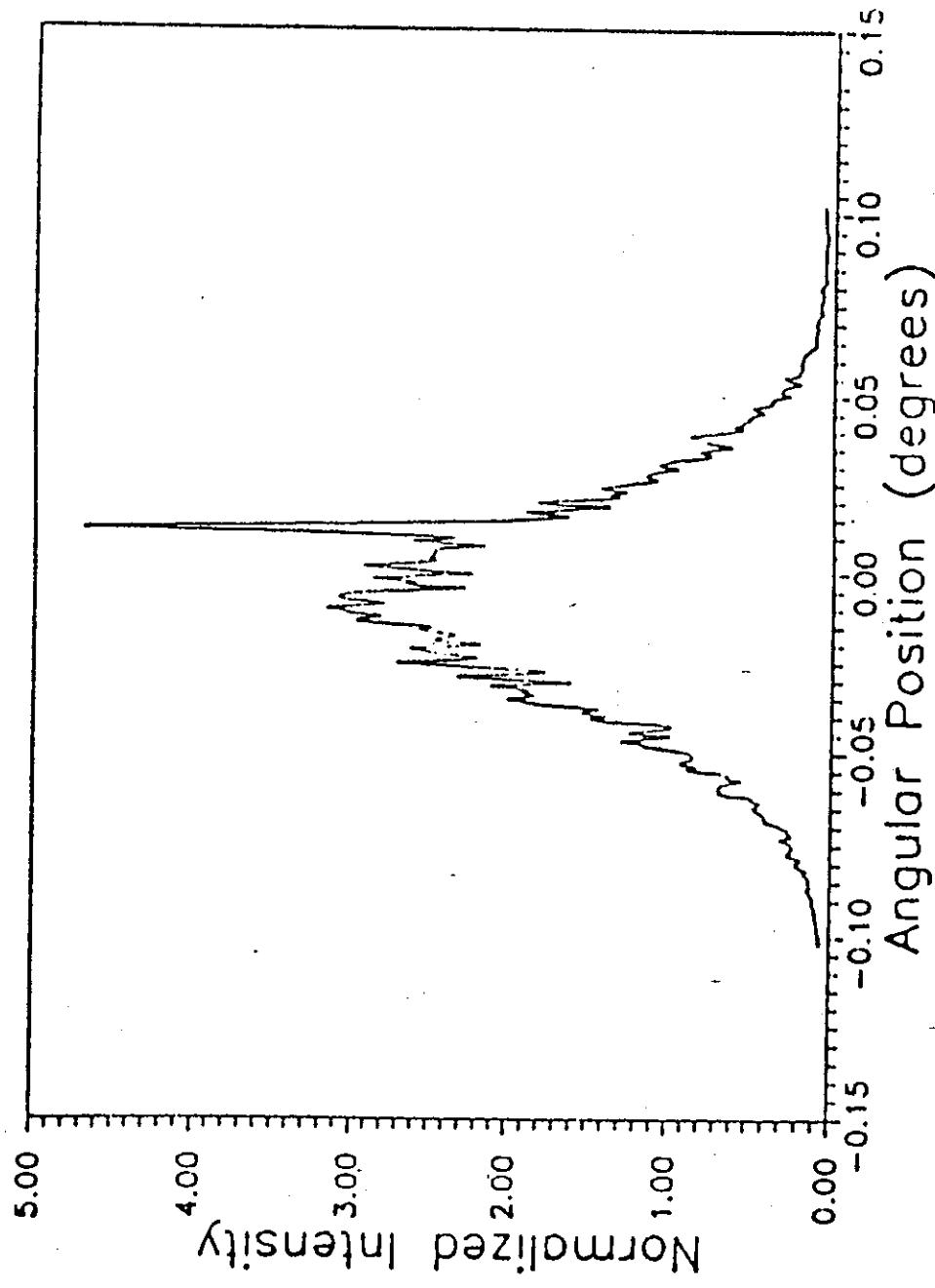


Figure 3. Angular distribution of the far field intensity for a wave incident at an angle of 0.012 degree with the same parameters as in Figure 2 except for averaging of 80 pulses.

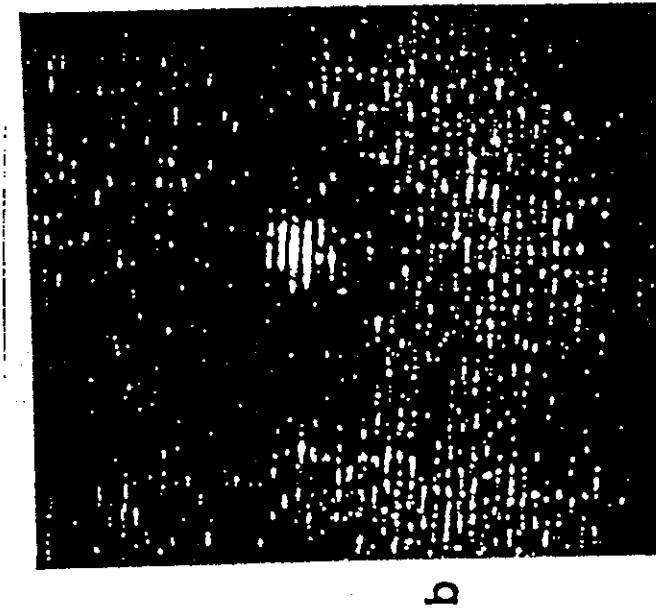
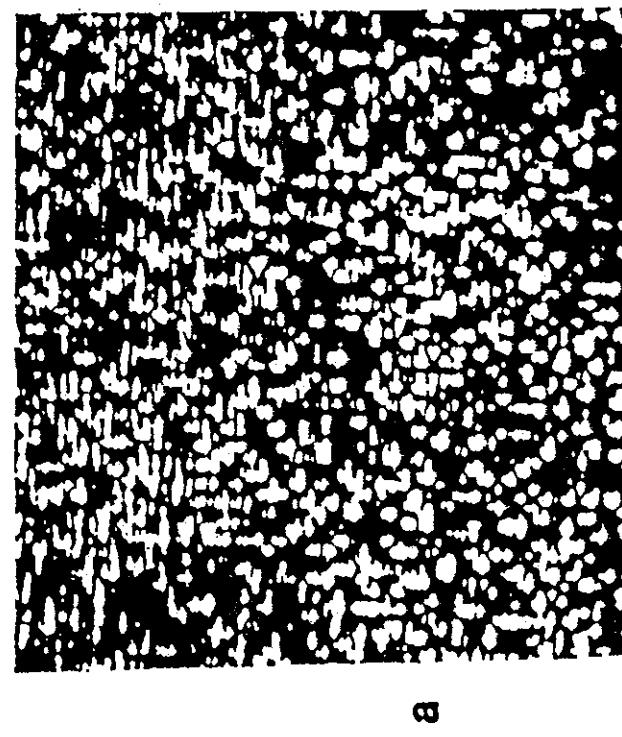


Figure 5. (a) TV image of a laser beam after passing twice through the same screen;
(b) an averaging of the TV images. The bright spot is the conjugate return.

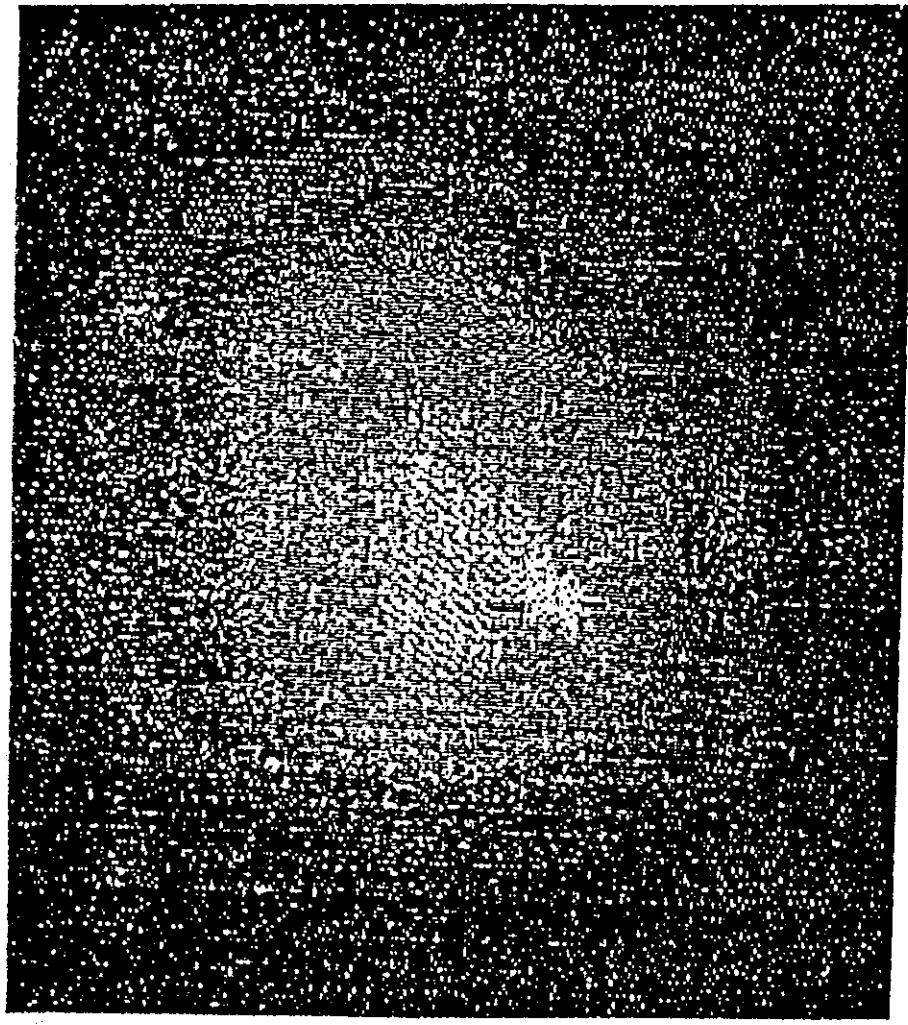


Figure 6. Image of the detected return beam from a retro-reflector located at 1,000 m from the transmitter. The image has been processed by averaging the data from a CCD array.



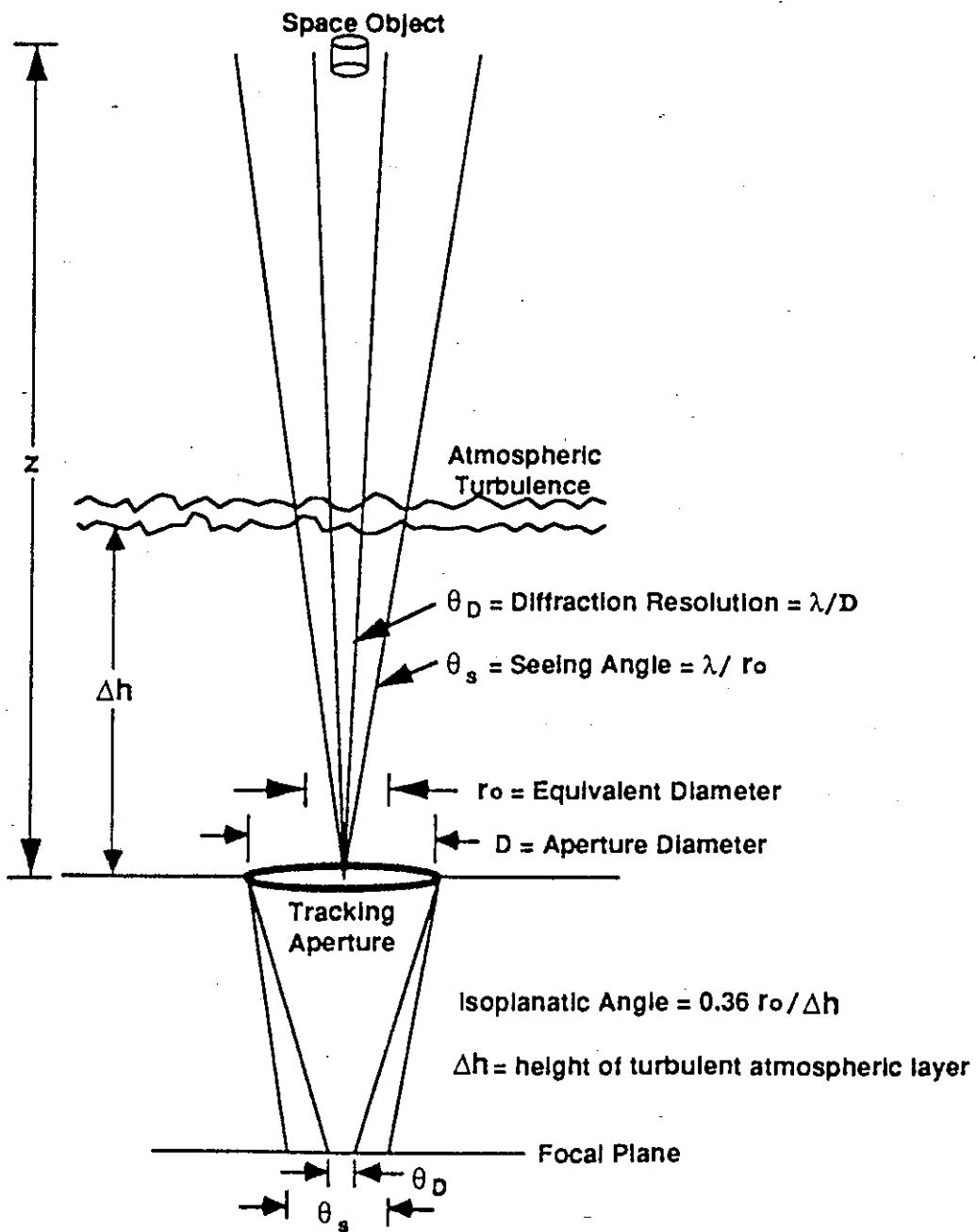
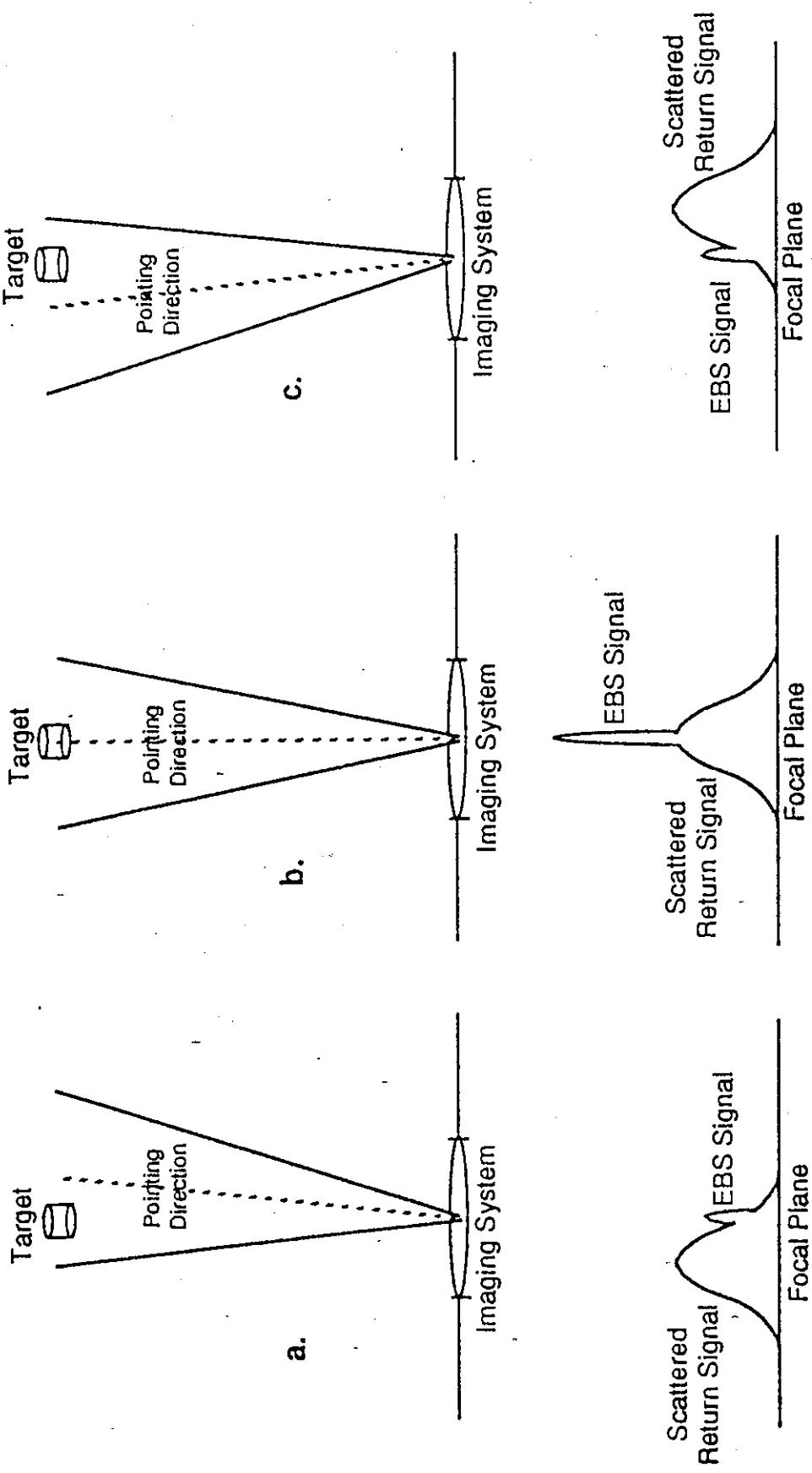


Figure 7. Schematic diagram of optical system and definition of resolution angles.





LASER RADAR RESEARCH

Objective:

- The evaluation, analysis and development of advanced coherent array laser radar receivers with emphasis on atmospheric effects and target signatures.

CREOL Activities:

- Coherent array receiver development
- Laser radar simulation
- Array image processing
- Prototype Nd:YAG ladar testbed



UCF PARTICIPANTS

- Dr. C. Martin Stickle - Professor, EE/CREOL
- Dr. Phillip Gatt - Research Scientist, CREOL
- Dr. Arthur R. Weeks - Assistant Professor, CpE
- Dr. Harley R. Myler - Associate Professor, CpE
- Mr. Robert Murphrey - Graduate Student, EE/CREOL
- Mr. Robert Beeson - Graduate Student, EE/CREOL
- Mr Wilson Perez - Graduate Student, CpE/CREOL
- Mrs. Michelle V. Lewis - Graduate Student, CpE/CREOL
- Mr. Tony Centore - Undergraduate Student, EE/CREOL
- Mrs. Kathy VanScooter - Administrative Assistant, CREOL

COHERENT ARRAY RECEIVER DEVELOPMENT

To evaluate, develop and characterize coherent array laser radar technologies with emphasis in the following areas:

- Heterodyne efficiency optimization
- Fiber optic receivers
- Detector Arrays
- Distributed aperture arrays





LASER RADAR SIMULATION

To develop a laser radar simulation capability to evaluate the performance of laser radar systems.

- In house end-to-end laser radar performance simulation
- Computer simulation of array laser radar systems for diffuse targets
- Atmospheric scintillation effects on laser radar systems
- Computer modeling of track mount jitter
- LOWTRAN7 (Low frequency resolution transmittance and background radiance)
- FASCODE3p (High frequency resolution transmittance)
- DELTAS (Laser Radar Simulator)



ARRAY IMAGE PROCESSING

To develop new techniques of using optical computing devices to implement image processing algorithms normally calculated using digital computers.

- Spatial light modulators for optical image processing
 - Hybrid homomorphic (non-linear) filters to remove image shading
 - Coherent processing for phase reconstruction using deformable mirror devices
- Adaptive filters:
 - Image processing filter using feature extraction techniques to preserve edge detail
- UCFImage[®]:
 - An MS-DOS based image processing software package that includes 2-D FFT, histogram equalization, edge detectors, morphological and adaptive filters, and color capability

PROTOTYPE Nd:YAG LADAR TESTBED

Development, packaging and delivery of a solid state $1.06 \mu\text{m}$ incoherent laser radar testbed to a facility at Kennedy Space Center

- Source:
 - Continuum NY82-20, Nd:YAG, injection seeded, 1.5 J, 8 ns
- Transceiver optics:
 - Bistatic 10 cm transmitter, 50 cm receiver
- Experiments:
 - Hard target and plume backscatter at 532 nm and 1064 nm
 - Autodyne laser tracker
 - Target discrimination



FACILITIES



Laser Radar Lab:

- Lightwave 122-50, 50 mW ring laser with fast PZT frequency tuning
- Lightwave 120-01, 5 mW ring laser with fast PZT frequency tuning
- Newport super cavity optical spectrum analyzer
- Newport acousto-optic modulator
- Hewlett Packard RF spectrum analyzer (2.9Ghz)
- Optical tables (Qty 2)
- MS-DOS 386 PC's (Qty 3)
- Beam diagnostic system (CREOL developed)

Image Processing Lab:

- Ncube supercomputer
- Sun 4 fileserver
- SunSparc 1 color workstations (Qty. 5)
- Sun 3 color workstation
- NCR Towerviews display terminals (Qty. 4)
- DATA TRANSLATION video frame grabber for the Sun 4 fileserver
- Video frame grabber boards for MS-Dos Compatible Computers

APPLICATIONS OF THERMAL IMAGING

CREOL AFFILIATES DAY

JANUARY 13, 1992

DR. GLENN BOREMAN

ASSOCIATE PROFESSOR, EE

INFRARED SYSTEMS LABORATORY

UCF/CREOL

(407) 658-6815

THE INFRARED GROUP

DR. BOREMAN - 8 YRS IN UCF'S ELECTRICAL ENGINEERING DEPT.

CURRENTLY 3 MS AND 3 PHD CANDIDATES

RESEARCH SPECIALTIES

INFRARED/OPTICAL SYSTEMS: ANALYSIS & DESIGN

PROTOTYPE INSTRUMENTATION DEVELOPMENT

DETECTOR AND FOCAL PLANE CHARACTERIZATION

MODULATION TRANSFER FUNCTION

INFRARED SCENE PROJECTION

CUSTOM MEASUREMENTS

SPECIALIZED TRAINING

APPLIED RESEARCH IN COLLABORATION WITH INDUSTRY

CURRENT RESEARCH

IR SCENE PROJECTION - REFLECTIVE LIGHT MODULATOR

Supported by:

Photonic Systems, MELBOURNE, FL (SBIR COLLABORATION)

AND Florida High-Tech Council

ANALYSIS OF FUNDAMENTAL PERFORMANCE ENVELOPE, AND

DEVELOPMENT OF PROOF-OF-PRINCIPLE INSTRUMENT

CHARACTERIZATION OF DETECTOR-ARRAY IMAGE QUALITY

Supported by:

Air Force Armament Lab, EGLIN AFB, FL

DEVELOPMENT OF INSTRUMENTATION FOR RESOLUTION TESTING

USING STATISTICAL PROPERTIES OF LASER SPECKLE

ANGULAR DEPENDENCE OF IR EMISSIVITY & REFLECTANCE

Supported by:

ALCOA Corporation, PITTSBURGH, PA

MEASUREMENT OF IR SIGNATURES FROM HIGH-TEMPERATURE

ALUMINUM SURFACES

THERMAL IMAGING OF CORNEA TISSUE

In collaboration with:

University of Miami Medical School

**MEASUREMENT OF TIME DEPENDENCE & TEMPERATURE PROFILES
DURING LASER SURGERY**

MODELS FOR MINIMUM RESOLVABLE TEMPERATURE

Supported by:

CI Systems, HAWTHORNE, NY

DEVELOPMENT OF NEW FIGURES OF MERIT FOR IR IMAGING SYSTEMS

REPRESENTATIVE PAST PROJECTS

SPRITE DETECTOR ANALYSIS

Supported by:

McDonnell Douglas Missile Systems, TITUSVILLE, FL

THEORETICAL ANALYSIS AND MEASUREMENT OF DETECTORS USED IN
THE SENSOR OF THE DRAGON MISSILE; DEVELOPMENT OF NEW
FIGURES OF MERIT RESULTING IN DESIGN MODIFICATIONS

SINCE 1986, THIS PROJECT HAS GENERATED 6 JOURNAL ARTICLES,
2 MS GRADUATES, AND ACCEPTANCE OF OUR ANALYTICAL MODELS
FOR SPRITE PERFORMANCE IN THE US ARMY STANDARD COMPUTER
CODE (MICOM IMAGING IR SYSTEM PERFORMANCE MODEL)

LASER BEAM STABILITY MEASUREMENT

Supported by:

Laser Ionics, ORLANDO, FL

INSTRUMENTATION DESIGN AND MEASUREMENT OF ARGON LASER
ANGULAR BEAM STABILITY

IR SYSTEMS LAB FACILITIES

Using seed support from CREOL, Florida High-Tech Council, and loans & donations from industry, we have built a complete infrared research facility.

IMAGERS

IR 512 × 512 PtSi CCD CAMERA: 3-5 MICRON

IR SPRITE SCANNER CAMERA: 8-12 MICRON

IR PYROELECTRIC VIDICON CAMERA: 1-12 MICRON

VISIBLE CCD ARRAYS

VARIOUS IR DETECTORS AND VACUUM DEWARS

SOURCES

BLACKBODY SOURCE TO 1300 C

3.39 MICRON HE-NE LASER (50 mW)

10.6 MICRON CO₂ LASER

INSTRUMENTATION

SCANNING SPECTRORADIOMETER: 2-14 MICRON
INTERFEROMETER - SURFACE FIGURE TESTING
IR SCENE PROJECTOR
VIDEO-BAND SPECTRUM ANALYZER
VIDEO-TRIGGERED OSCILLOSCOPE

COMPUTER SYSTEM

SUN WORKSTATIONS: SPARC 330 AND SLC1
VIDEO DIGITIZER
IDL NUMERICAL ANALYSIS SOFTWARE
SEMPER IMAGE PROCESSING SOFTWARE
CODE-V OPTICAL DESIGN SOFTWARE
FLIR-90 INFRARED SYSTEMS DESIGN SOFTWARE

OPTICS

IR ZOOM TELESCOPE (8-12 MICRON)

12" DIAMETER OFF-AXIS PARABOLIC COLLIMATOR

IR LASER COLLIMATOR

POLYGON SCANNERS

VISIBLE AND INFRARED INTEGRATING SPHERES

IR ACOUSTO-OPTIC MODULATOR

HUGHES LCLV

21-ELEMENT DEFORMABLE MIRROR

FUTURE FACILITY

RF ISOLATION CHAMBER (NEW BLDG)

FOR LOW-NOISE

DETECTOR & SYSTEM SENSITIVITY MEASUREMENTS

Graduates of the IR Systems Lab are working at:

MARTIN MARIETTA - ORLANDO, FL (3)

LITTON LASER SYSTEMS - ORLANDO, FL

MCDONNELL DOUGLAS - TITUSVILLE, FL

AIR FORCE ARMAMENT LAB - EGLIN AFB, FL

NASA - HUNTSVILLE, AL

INTERGRAPH - HUNTSVILLE, AL

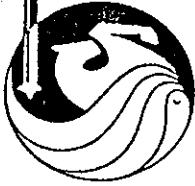
ARNOLD AFB ENGINEERING CENTER -

TULLAHOMA, TN

MEMPHIS STATE UNIVERSITY - MEMPHIS, TN

IT&T ELECTRO-OPTICS CENTER - ROANOKE, VA

NAVAL COMBAT SYSTEMS CENTER - NORFOLK, VA

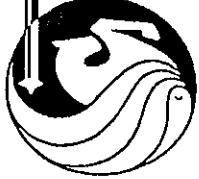


Principal Investigator:

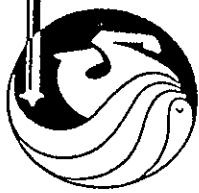
Dr. James E. Harvey, Associate Professor
CREOL/UCF
12424 Research Parkway
Orlando, FL 32826
(407) 658-6818

Graduate Research Assistants:

Kenneth J. Jerkatis, Ph.D. (EE)
Kristin L. Lewotsky, M.S. (EE)
J. Brooks Sweet, M.S. (EE)
Anita Kotha, M.S. (Physics)
William Gresslor, M.S. (EE)



- CREOL / UCF —
- A. **The optical design and image analysis of advanced optical systems** for state-of-the-art applications in the laboratory, in the industrial marketplace, and in space.
 - B. **The simulation and modeling of systems performance for unconventional optical systems** such as diffractive optical elements (binary optics), synthetic aperture optical systems (phased telescope arrays), and X-ray/EUV imaging systems for both astronomical and lithographic applications.
 - C. **The experimental characterization of various optical materials and optical fabrication processes for precision optical surfaces and components.** Of particular interest is the diffraction efficiency and scattering behavior of current state-of-the-art binary optical elements, the anomalous scattering behavior of beryllium optics for space applications, and the image degradation due to small angle scattering in X-ray multilayer coatings for enhanced reflectance at normal incidence.



- EUV Performance of Wolter II Telescopes for Space Astronomy Applications
- Performance Limitations of Imaging Microscopes for Soft X-ray Applications

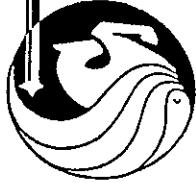
- Nested Conical Foil Imaging Mirrors for High-energy X-ray Telescopes

- NASA/GSFC: BBXRT with 101 Concentric Mirror Pairs
- Soviet Spectrum-X-Gamma Mission: XPECT with 154 Concentric Shells
- Japanese SXO with 89 Concentric Foil Shells
- Italian X-ray Astronomy Satellite (SAX) with 30 Nested Coaxial Shells

- Interface Correlation Effects in Enhanced Reflectance X-ray Multilayers

* Residual design errors are seldom the limiting factor in the performance of very short wavelength high-resolution imaging systems. Even our best optical surfaces are not smooth relative to these wavelengths; hence, optical fabrication errors (over the entire range of relevant spatial frequencies) must be included in the modeling and simulation of such systems. Commercially available optical design codes do not adequately model these effects.

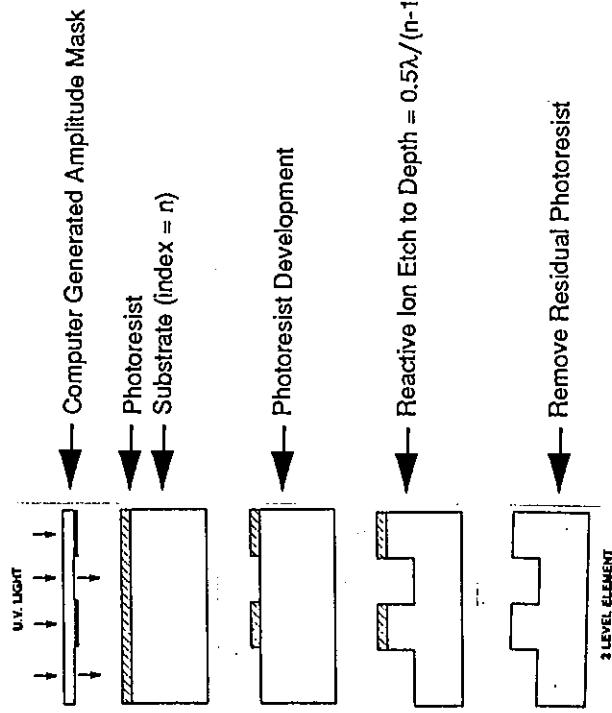
BINARY OPTICS CHARACTERIZATION



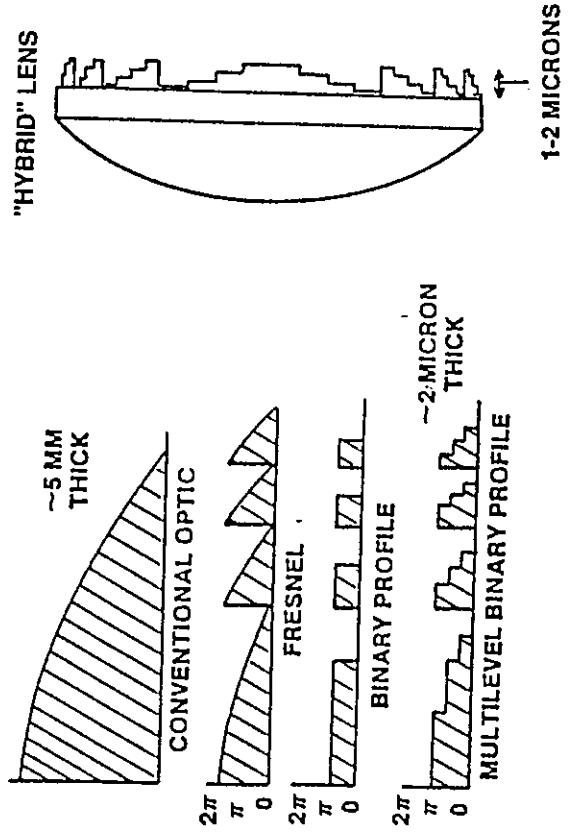
CREOL / UCF =

The concept of binary optics is to fabricate diffractive multi-level Fresnel zone phase profiles with the lithographic technology used in the production of integrated circuits. These "binary" optical elements can be used by themselves or in conjunction with conventional refractive or reflective optical elements.

FABRICATION PROCESS



CONCEPT OF BINARY OPTICS



POTENTIAL ADVANTAGES OF BINARY OPTICS

Improved Performance

- Reduced Weight
- Reduced Cost
- Meets Emerging Needs for Micro-optics
- Enabling Technology for the Integration of Micro-optics and Micro-electronics

PROPOSED EXPERIMENTAL PROGRAM

Theoretical Predictions of Diffraction Efficiency

- Measurements of Diffraction Efficiency
- Measurements of Scattering Behavior
- Comparison of Theory with Experiment
- Parametric Results and Sensitivity Analyses

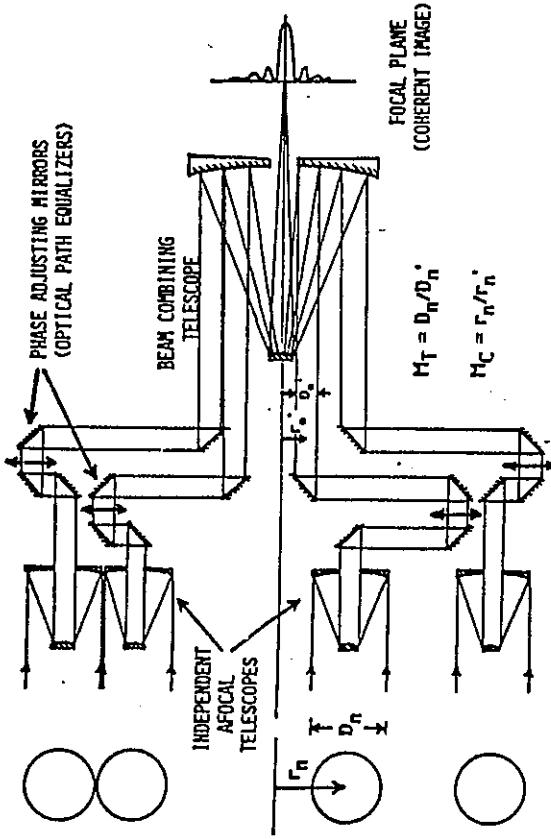
PHASED TELESCOPE ARRAYS



MOTIVATION

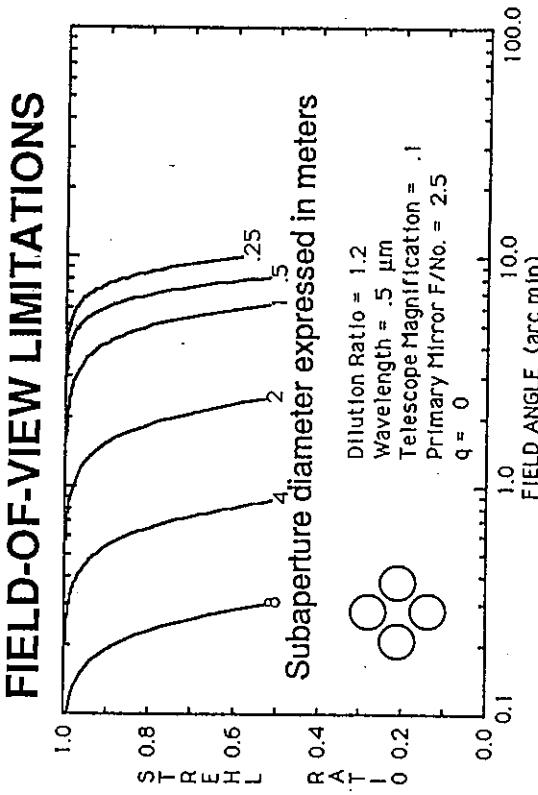
- Fabrication and Testing
- Reduction of Weight and Moment of Inertia
- Potential Cost Savings
- Emerging Technology to be Evaluated

PHASED TELESCOPE ARRAY CONCEPT



POTENTIAL ERROR SOURCES

- Phasing Errors
- Relative Pointing Errors
- Relative Focus Errors
- Optical Fabrication Errors
- Assembly and Alignment Errors
- Lateral Pupil Mapping Errors
- Longitudinal Pupil Mapping Errors
- Relative Magnification Errors
- Off-axis Aberrations



Large apertures (small field angles) Dominated by Field Curvature
Small Apertures (large field angles) Dominated by Distortion.

Column Well Optoelectronics

for Raman Scattering Spectroscopy

Wavelength

Visible light pulsed lasers

Visible light pulsed lasers

Visible light pulsed lasers

Visible light pulsed lasers

Pulsed lasers from 400 nm to 1000 nm
Visible light pulsed lasers

Visible light pulsed lasers
Visible light pulsed lasers

Visible light

Visible light

Visible light

Visible light pulsed lasers
Visible light pulsed lasers

Visible light pulsed lasers
Visible light pulsed lasers

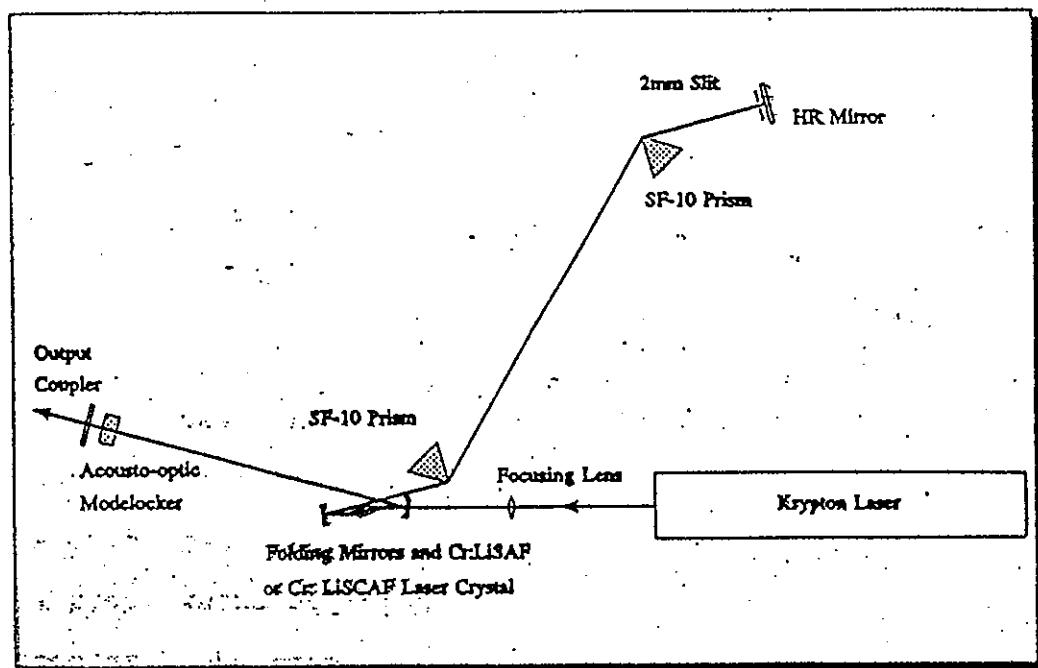
New Tunable Femtosecond Solid State Laser Sources

Patrick Li Kam Wa, Bruce Chai, Alan Miller

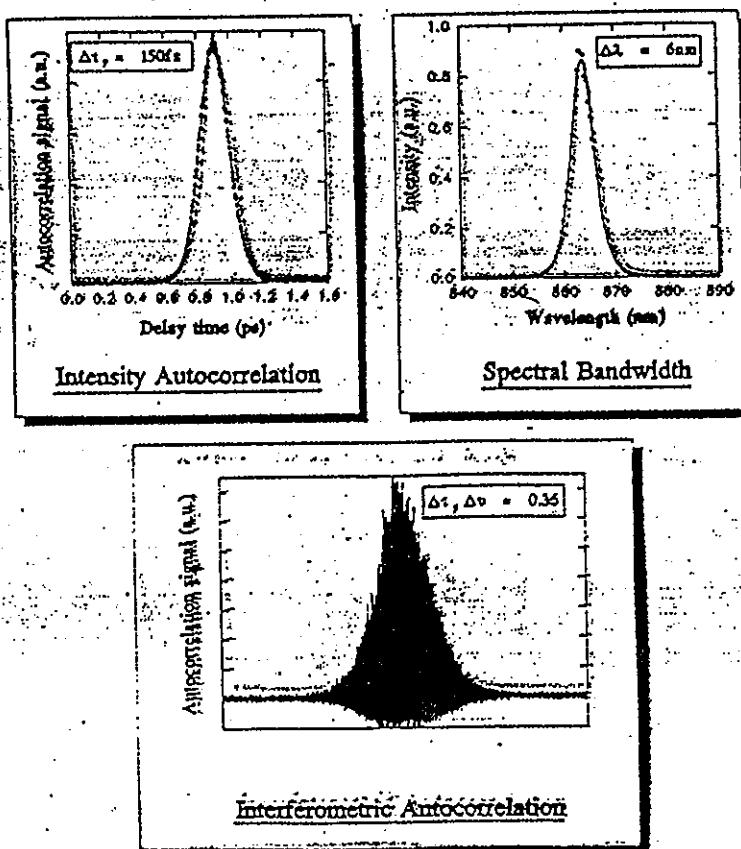
• cw argon pumped Ti:sapphire	80 fs
• Nd:YAG synchronously-pumped Ti:sapphire	170 fs
• cw krypton pumped Cr:LiCAF	150 fs
• cw krypton pumped Cr:LiCAF	150 fs
• cw krypton pumped Cr:LiCAF	100 fs

Collaborations:

Laser Ionics
MEOS
Schwartz EO
Lightning Optical Corp.



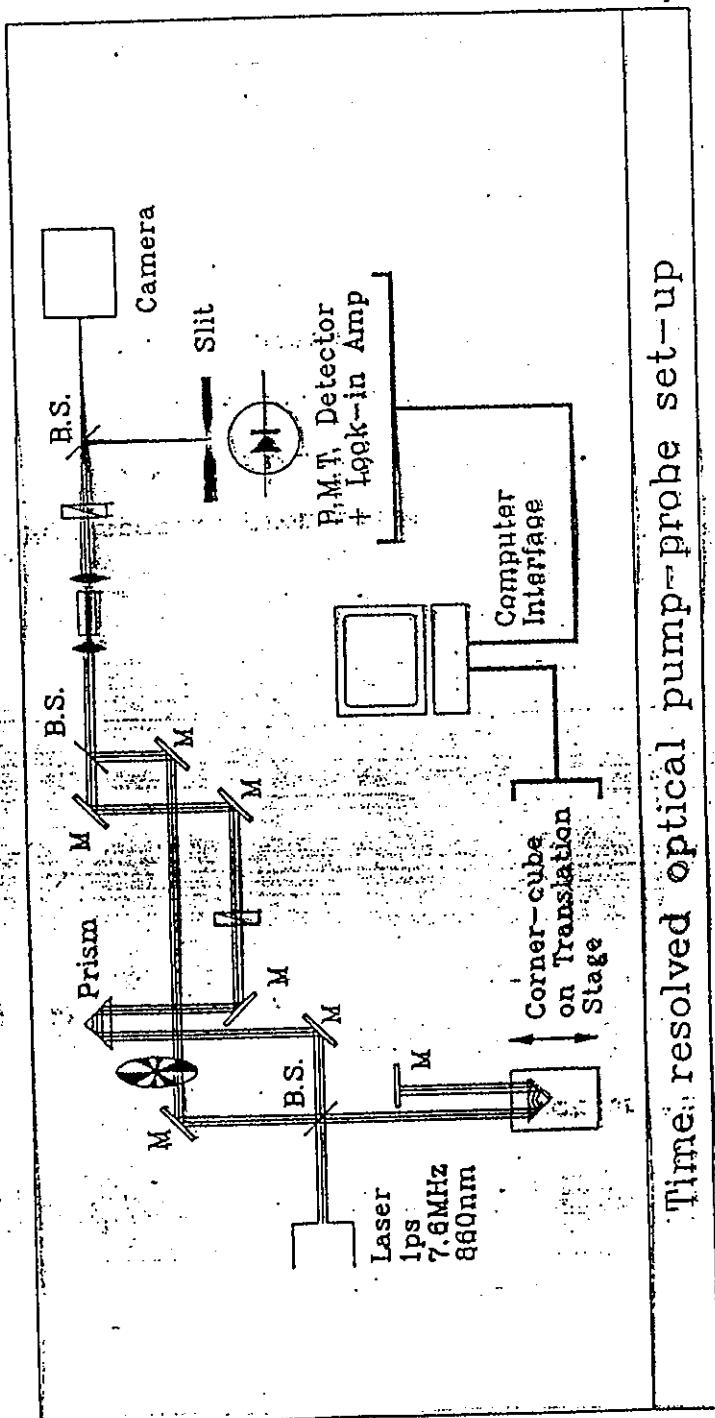
Schematic layout of X-fold, dispersion compensated LiSCAF or LISCAF laser.



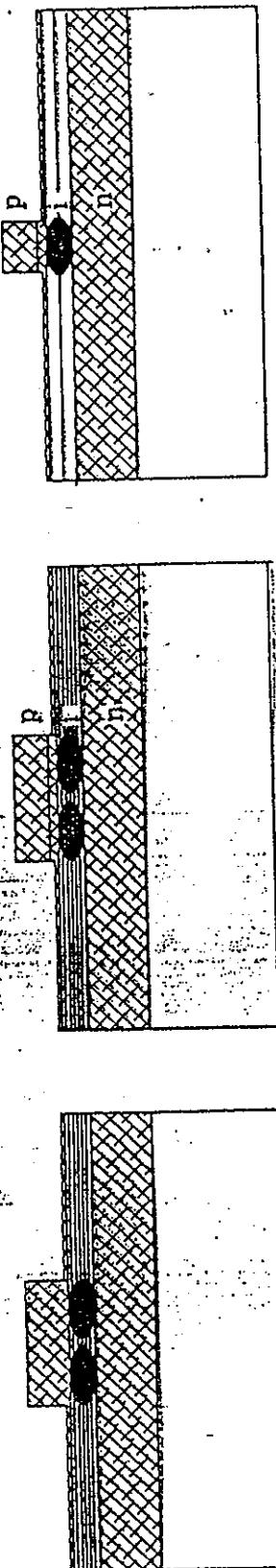
Characteristics of the dispersion compensated LiSCAF laser



50 μ m



Time resolved optical pump-probe set-up

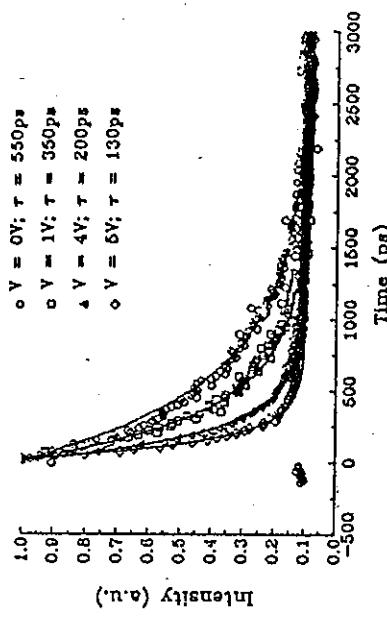




MQW Directional Coupler

- Zero-gap directional coupler to minimize length
- Band-filling and exciton saturation nonlinearities
- Undoped structure gave 1.5ns recovery
- P-i-n doped structure gave ~ 100 psec recovery by employing carrier sweep-out in an applied field
- Potential for < 10psec recovery

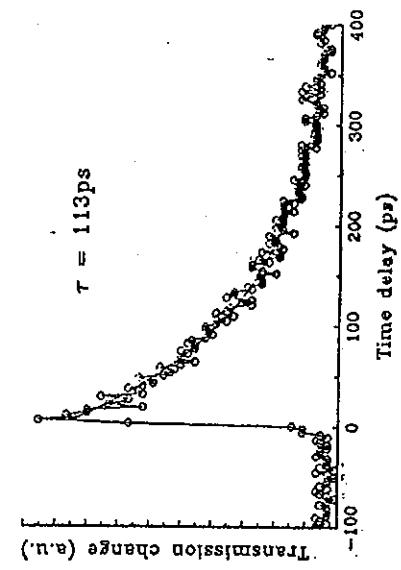
Picosecond pump-probe measurements



MQW waveguide directional coupler response
as a function of reverse bias.

SQW Waveguides

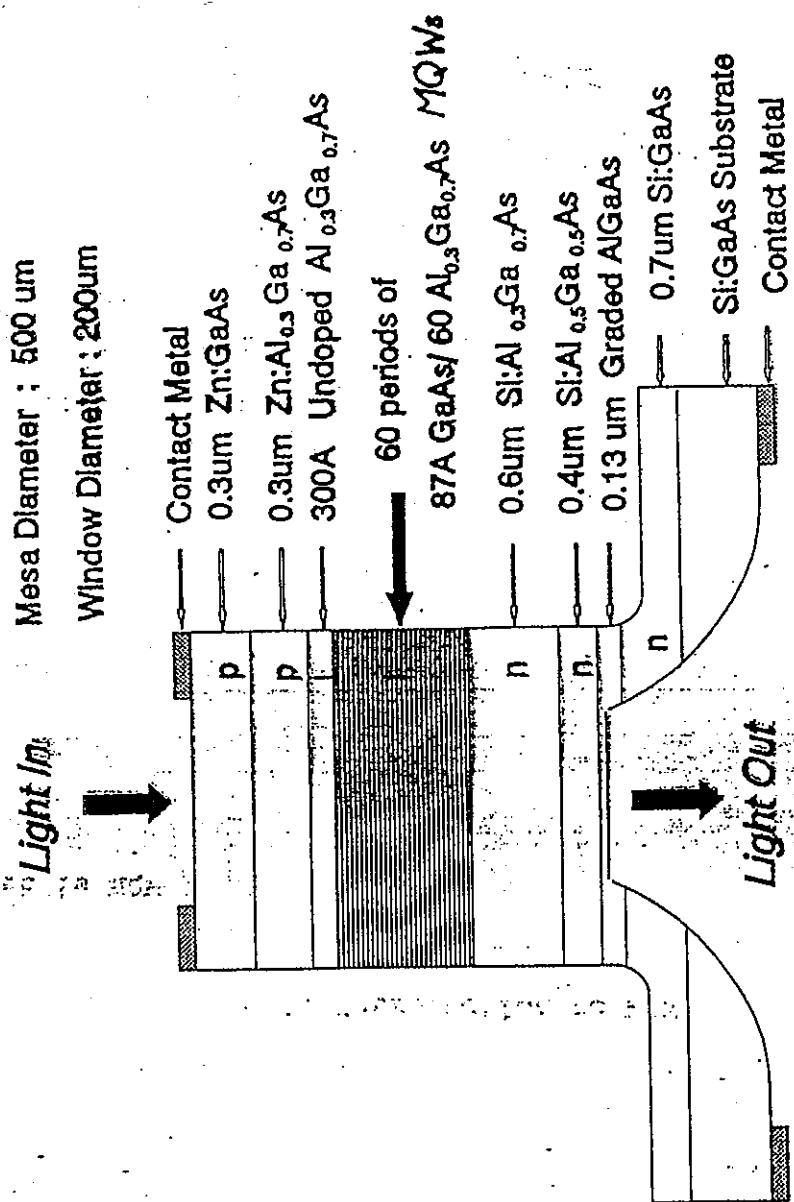
- Both QCSE effects and exciton saturation monitored
- 113psec saturation recovery due to carrier sweep-out with no applied field
(in collaboration with A Moretti, Amoco)
- Asymmetric barriers studied to distinguish between the role of electrons and holes
(in collaboration with D A B Miller, AT&T)



SQW waveguide response showing fast recovery in the absence of an applied field and lasers

Center for Research In Electro-Optics and Lasers

GaAs/AlGaAs SEED Structure





Fundamental Limits of Optical Switching

Approach

- Time resolved measurements of the dynamical quantum confined Stark effect (QCSE) in p-i-n doped structures.
- Modeling of the cross-well carrier dynamics to determine carrier emission rates, tunneling rates and retrapping times.

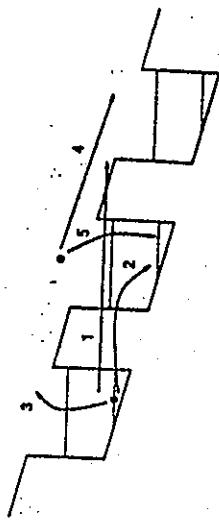
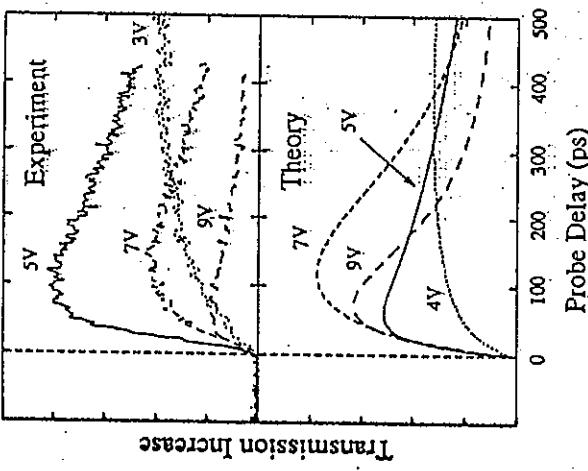
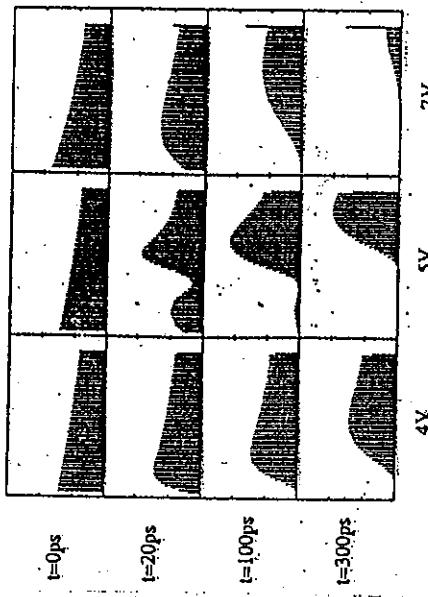


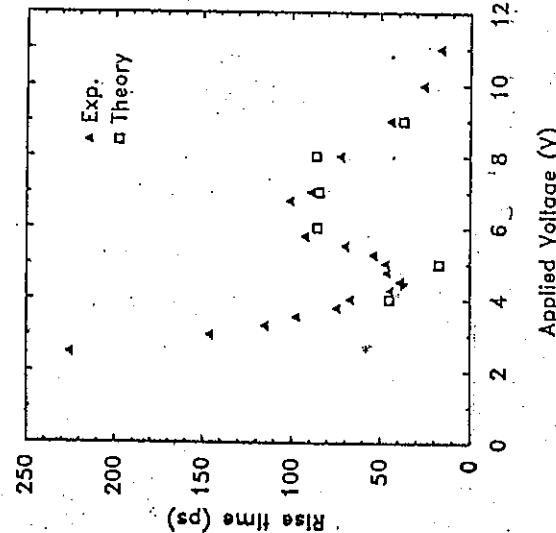
Diagram representing the various time constants involved in cross-well transport of carriers



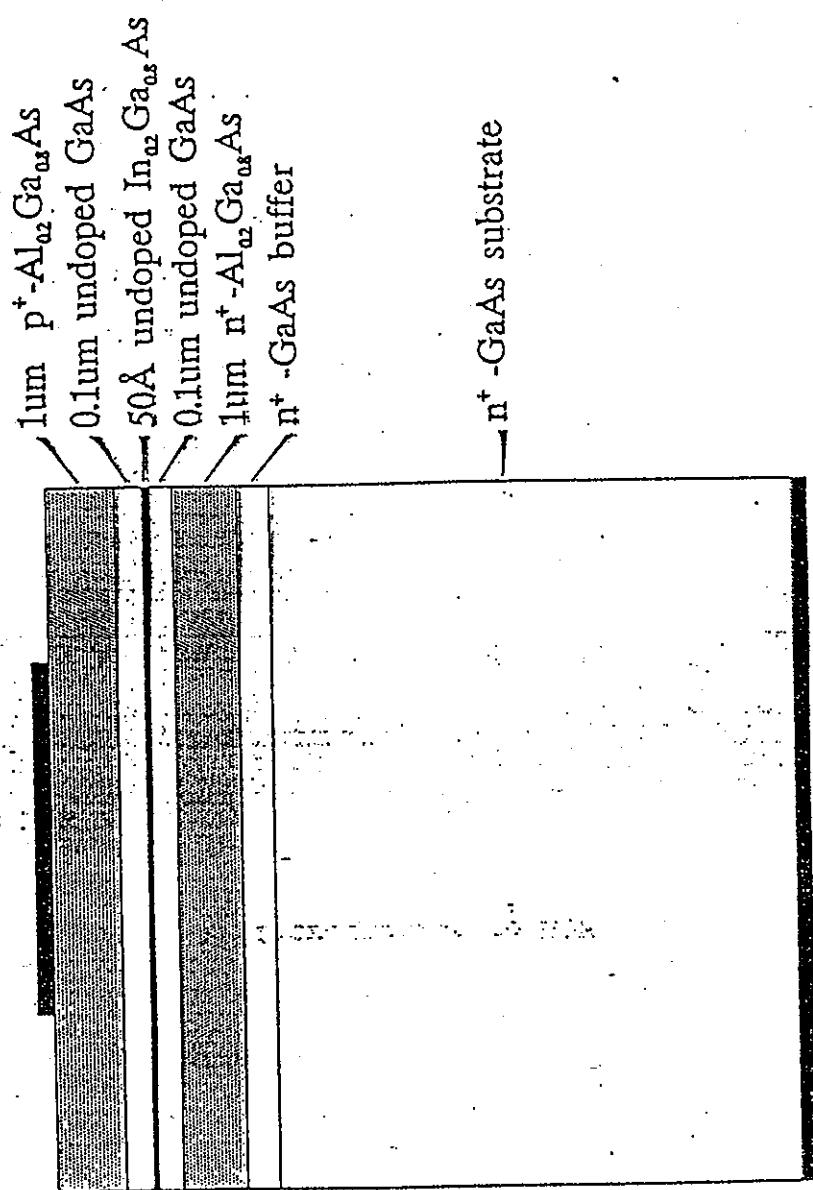
Comparison of experimental transient transmission changes with the theoretical model for different bias voltages.



Comparison of experimental and theoretical rise times showing resonant tunneling at 5V bias.



Representation of the electron densities in the quantum wells at various delay times and bias voltages.

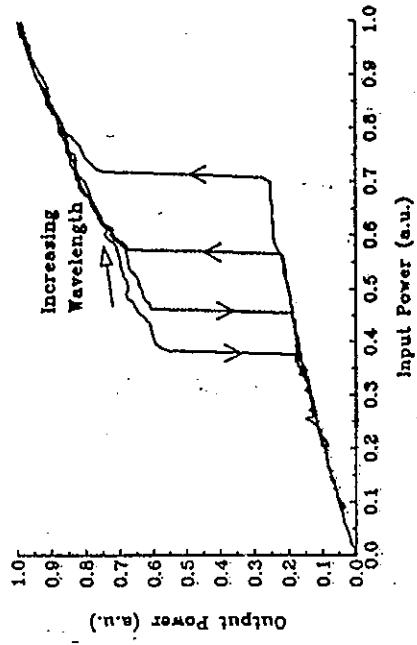




Optical Switching with Gain

Results

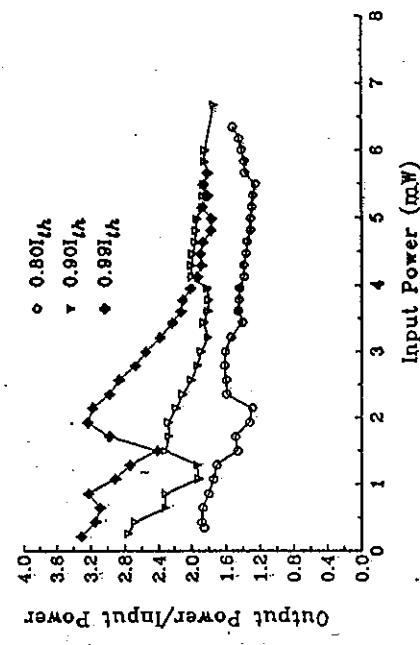
- First demonstration of dispersive optical bistability with gain in a quantum well laser.
- InGaAs/GaAs single quantum well strained layer laser biased below threshold.
- Measurements of gain saturation
(in collaboration with Robert Park, U. Florida)



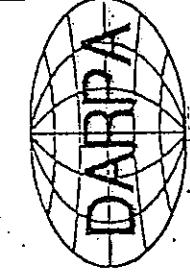
Optical bistability at 960nm at an electrical bias of 0.8V.

Goals

- Time resolved measurements of gain recovery
- Optical bistability in a single mode laser
- Demonstrate a directional coupler switch with gain
(in collaboration with Paul Cook, ETDL)



Gain saturation at 965nm for three different bias conditions



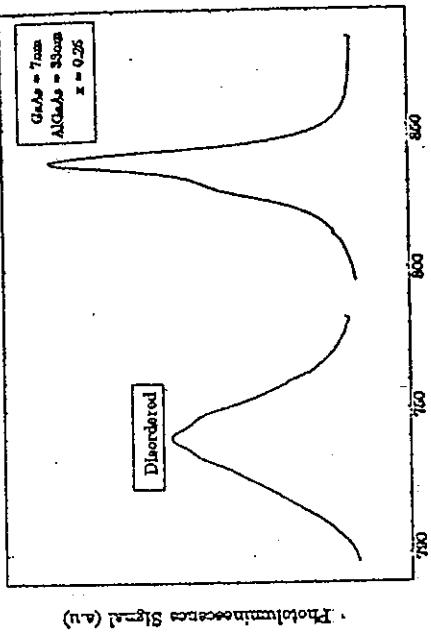
CREOL

Approach

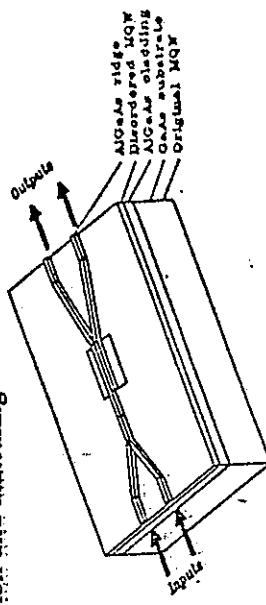
- A large blue shift of the absorption edge is induced by disordering the MQWs by zinc diffusion and annealing (in collaboration with Mitra Dutta, ETDL)
- Non-dopant, gallium vacancy induced disordering is being investigated
(in collaboration with Gareth Parry, UCL)

Goals

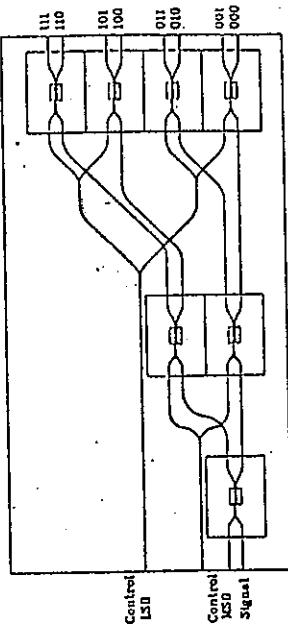
- Characterization and optimization of selective area partial intermixing of MQW waveguides
- Cascading of MQW directional coupler switches
- Demonstration of an all-optical waveguide switching circuit



Photoluminescence of GaAs/AlGaAs MQW before and after zinc diffusion and annealing



Directional coupler switch with selectively disordered interconnects



Concept for an all-optical switching circuit

Center for Research In Electro-Optics and Lasers

NONLINEAR WAVEGUIDES

**Presented by Dr. George Stegeman,
Professor of Physics and Electrical Engineering
and
Cobb-Hooker Eminent Chair**

NONLINEAR WAVEGUIDES

George Stegeman

Long Range Goals:

To investigate the physics and applications of nonlinear optics in waveguides.

Personnel:

5 post-doctoral fellows, 1-3 visitors, 9 graduate students, 1 technician

Program:

1. Nonlinear Materials

- characterization from 450 → 2000 nm**
- physics of the nonlinearities**
- device figures of merit**

2. Waveguide Fabrication

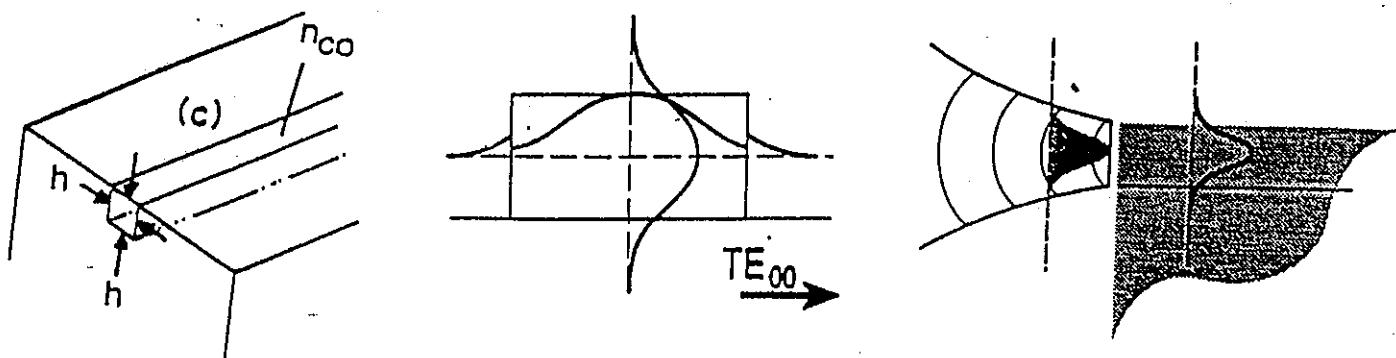
- fabrication of thin film and channel waveguides**
- grating couplers**
- waveguiding characteristics, loss etc.**
- nonlinear characterization**

3. Nonlinear Waveguide Phenomena

- physics of nonlinear waveguides**
- soliton phenomena**
- out-of-plane second harmonic generation**
- all-optical switching in fibers and channels**

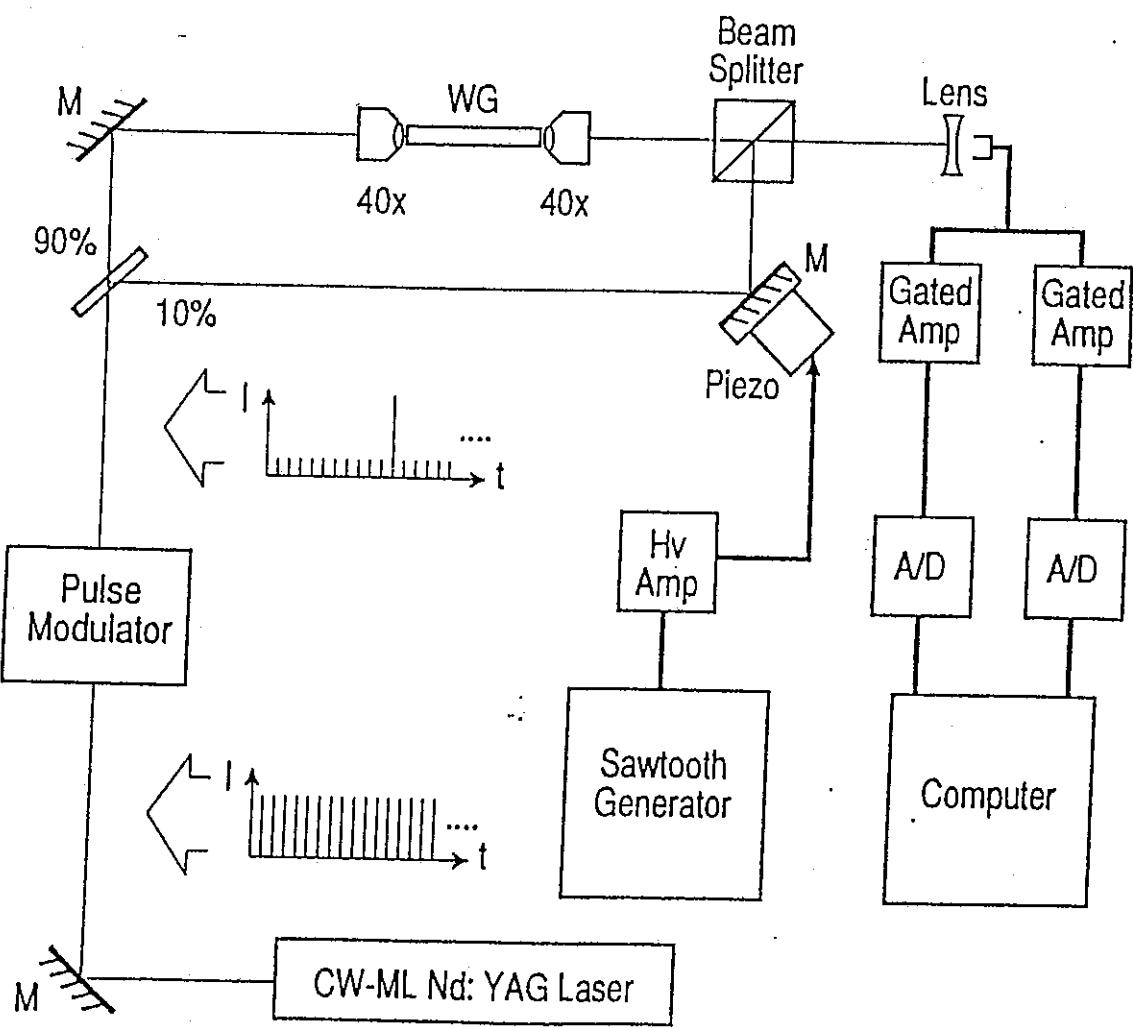
WAVEGUIDE MACH-ZEHNDER INTERFEROMETER

Channel Waveguides

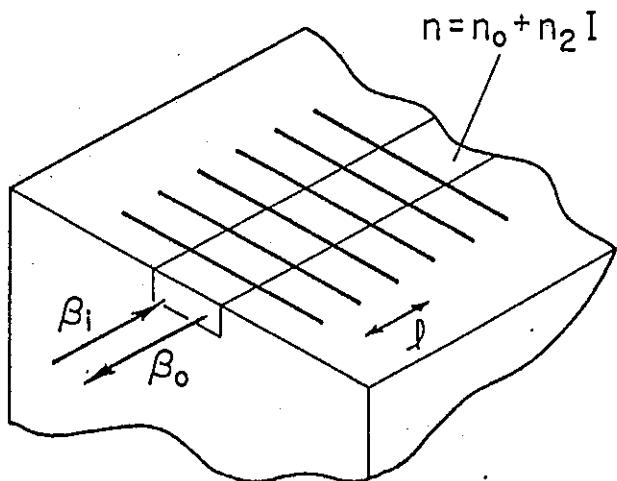


Nonlinear Interferometer

$$\Delta\phi^{NL} = n_2 I \ k_0 \ L_{eff}$$

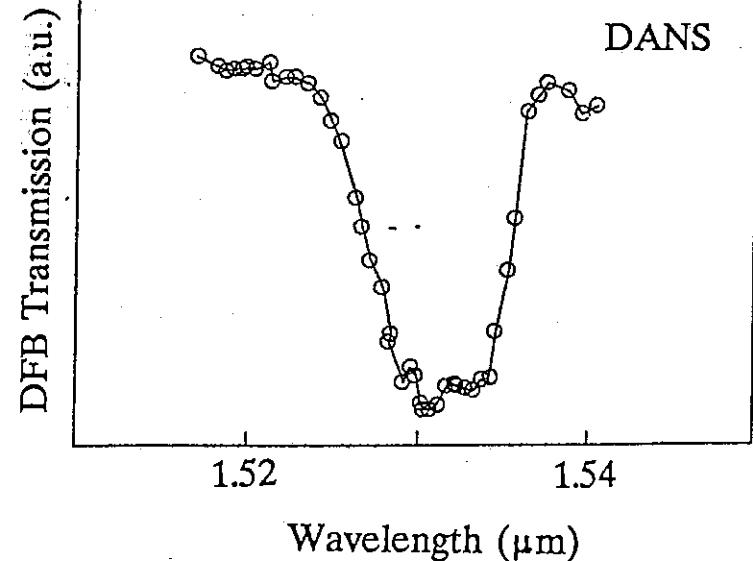
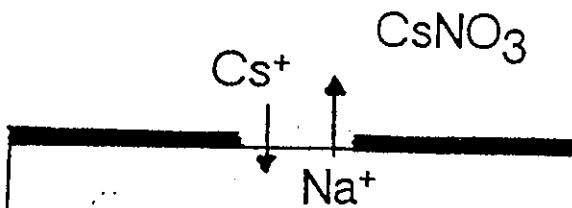


NONLINEAR DISTRIBUTED FEEDBACK GRATINGS

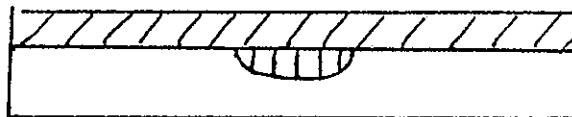


$$\beta_i + \beta_o = 2\pi/l$$

Schott BGG21 glass
has $\approx 10\%$ Na



Polymer film



Field profile

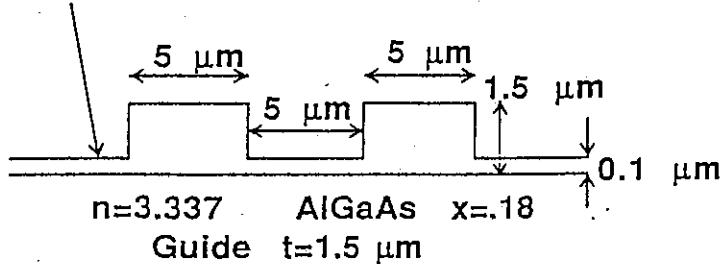


- $3\mu m$ wide, 1 cm long channels, $> 20\%$ throughput
- planar waveguide losses ≈ 0.6 db/cm (channel \approx same)

NONLINEAR DIRECTIONAL COUPLER

$\lambda = 1555 \text{ nm}$ (communications band) 500 fs pulses

$n=3.305$ AlGaAs $x=0.24$ Strip Loading



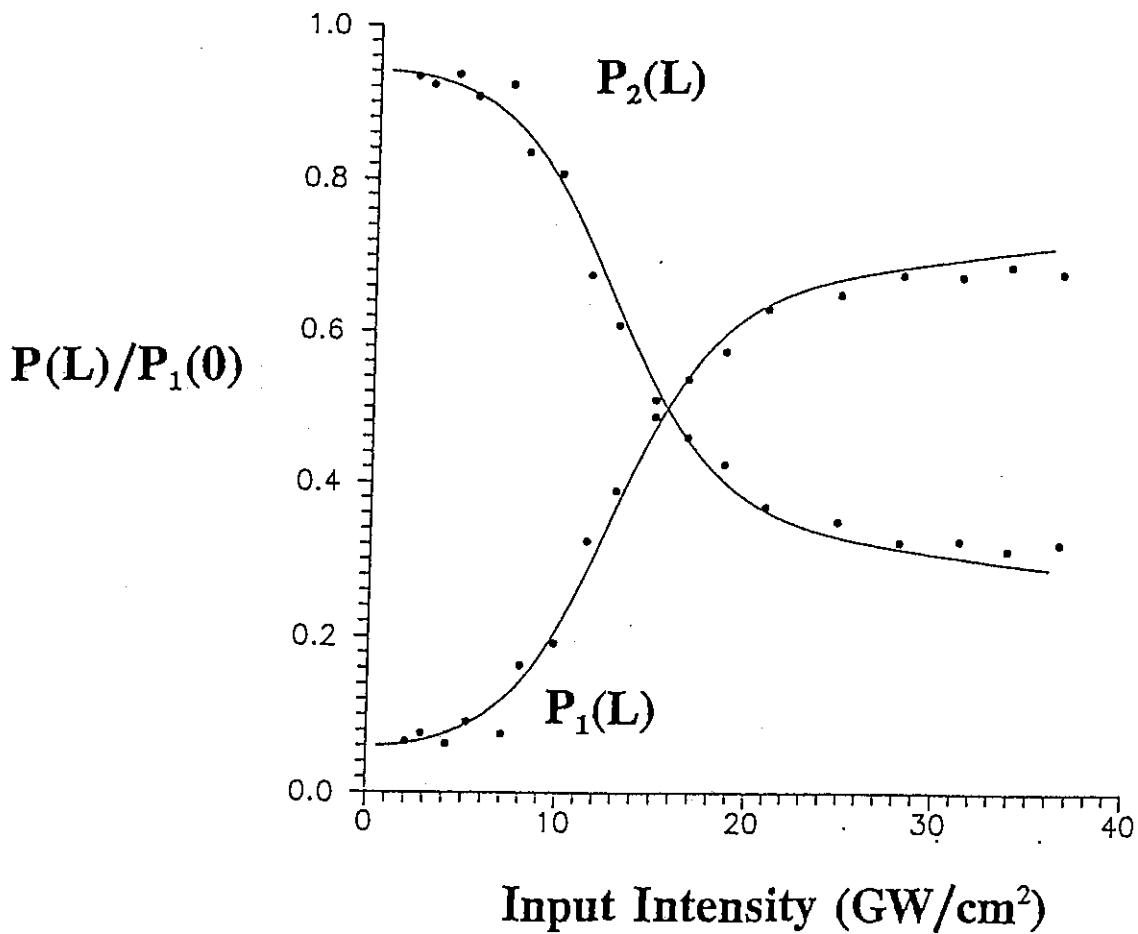
$P_1(0)$

$P_1(z)$

$P_2(z)$

$n=3.305$ AlGaAs $x=0.24$
Cladding $t=4 \mu\text{m}$

$n=3.4$ GaAs Substrate



Novel Applications of Diffractive Optics

Graduate Students

Tim Ayers - MS student

Dan Gray - Ph.D Student

Drew Pommet - Ph.D. Student

Government and Industrial Sponsors and Collaborators:

Florida High Technology Industrial Council

Harris Corporation Electronics System Division - Melbourne, FL

CECOM Center for Night Vision & Electro-Optics - Fort Belvoir, VA

LTV Missiles and Electronics Group - Dallas, TX

Northrup Electronics Systems Division - Hawthorne, CA

Teledyne Brown Engineering - Huntsville, AL

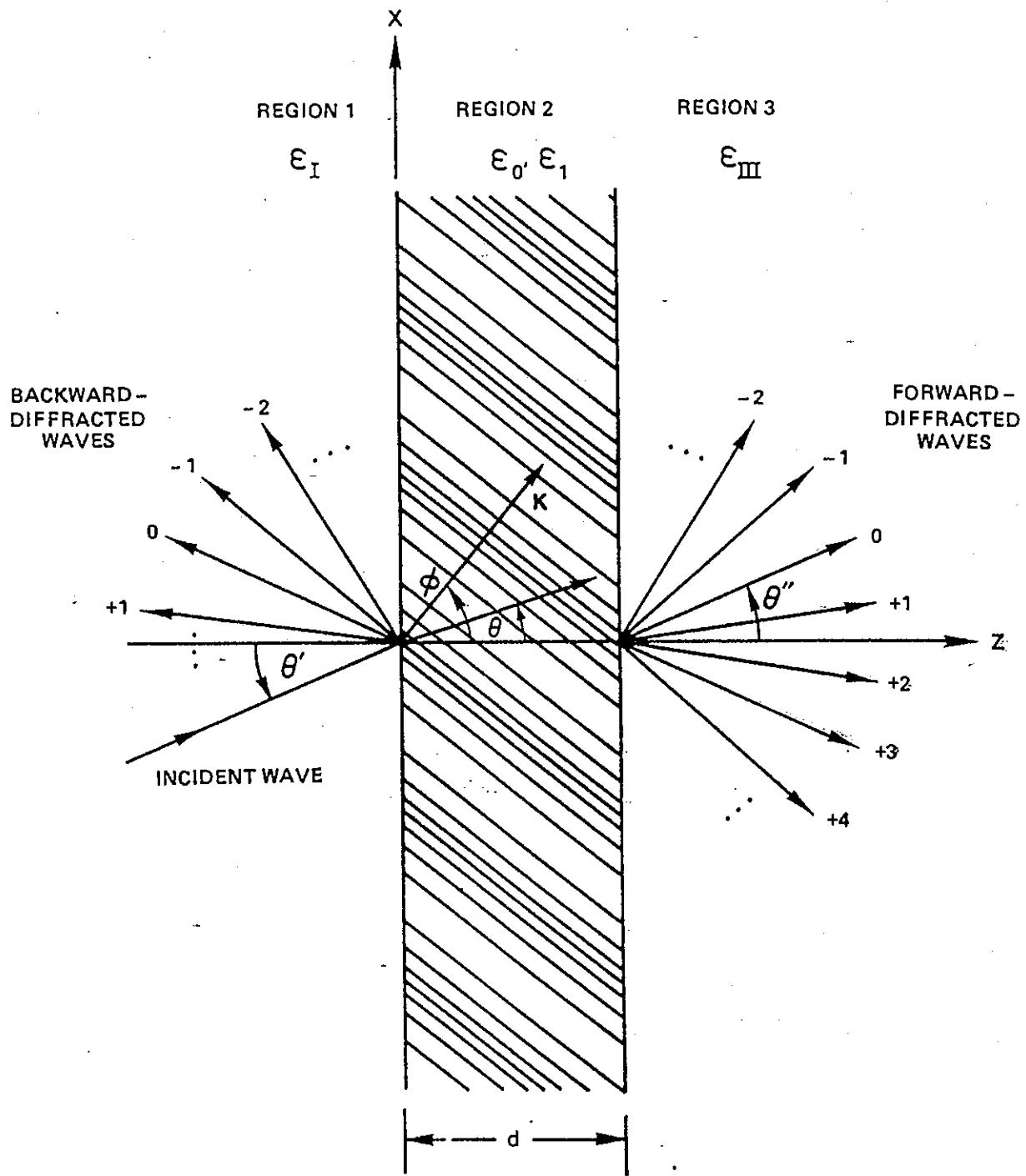
Geletech - Alachua, FL

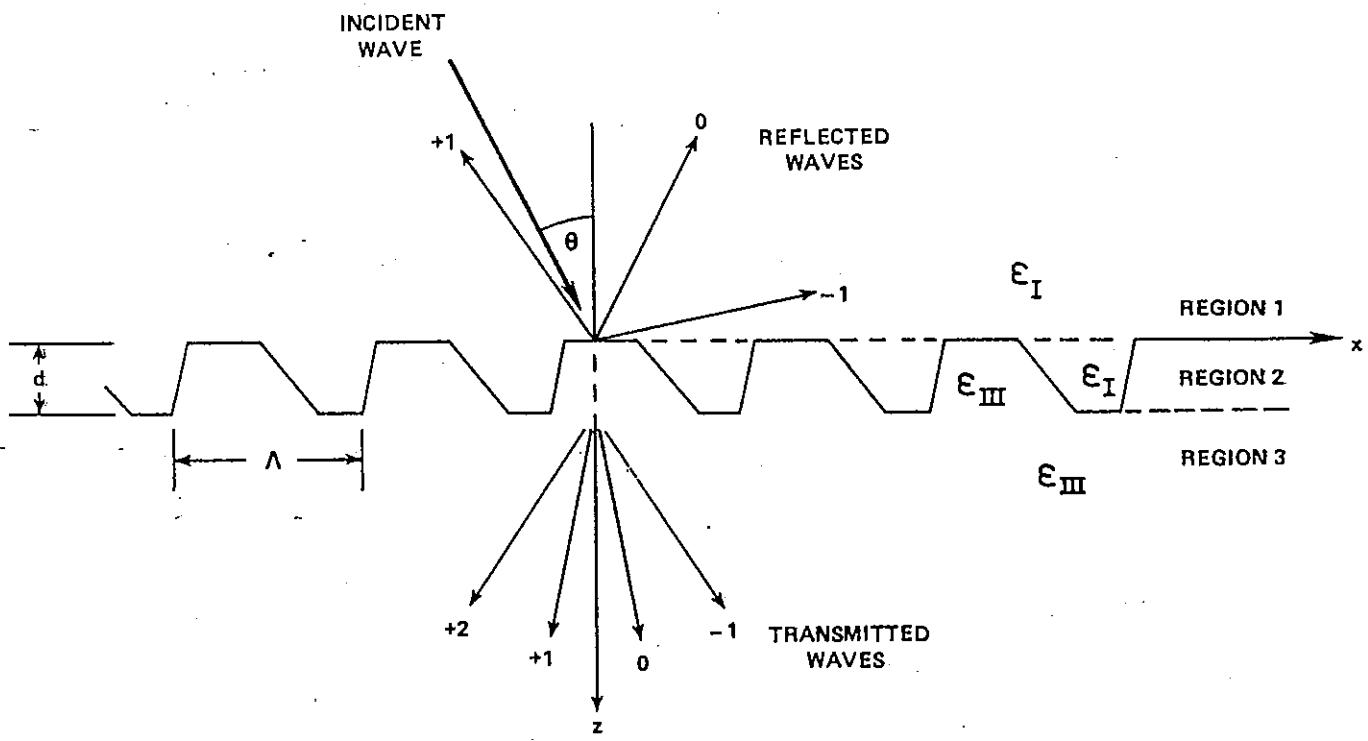
Binary Diffractive Elements Applications

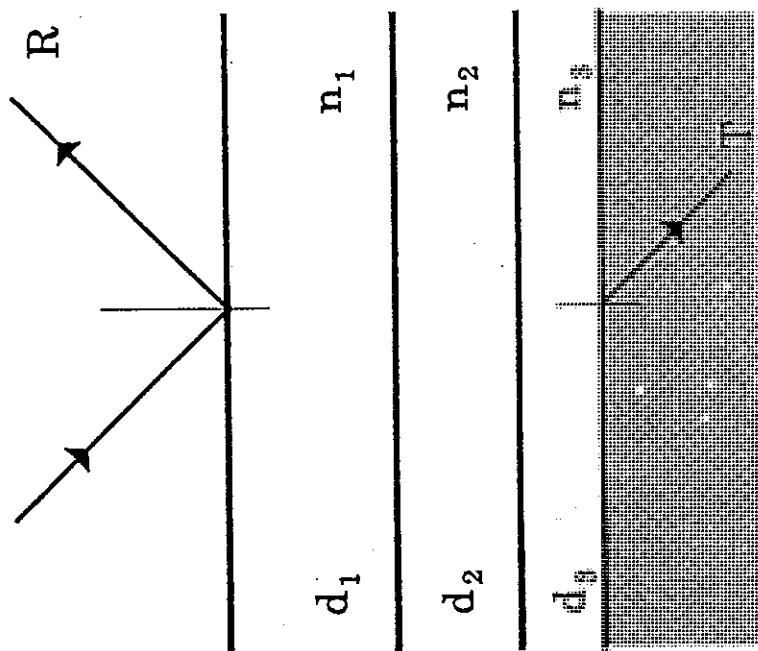
- Multi-Level Binary Broadband Anti-reflection Surfaces
- Surface-Relief Gratings for Spot Array Generation
- Multiplexed Gratings for Optical Interconnects
- Two-Dimensional Binary Grating Filters
- Binary Grating Polarizers

Real Time Holography Applications

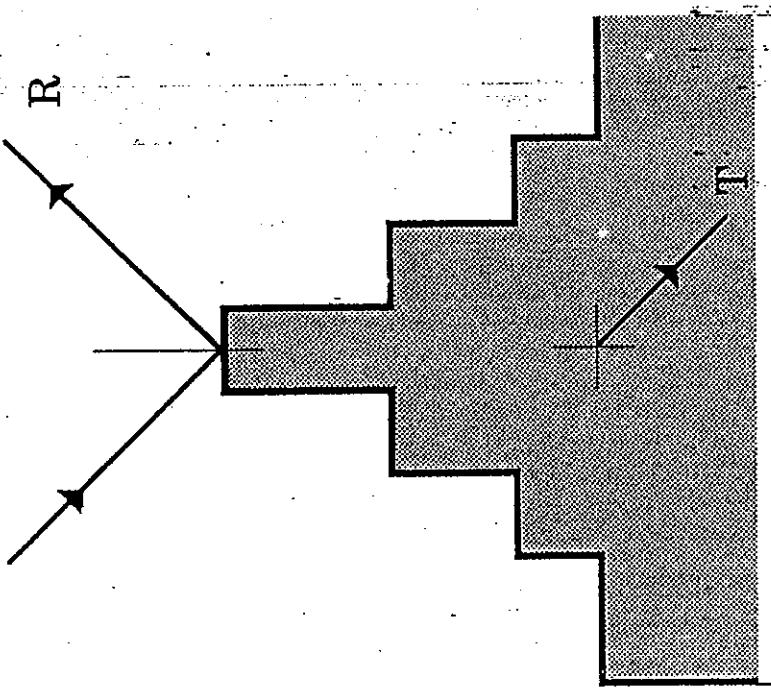
- Acousto-Optics-Photorefractive Signal Processing
- Correlation and Adaptive Nulling
- Novel Technique for the Characterization of Photorefractive Materials



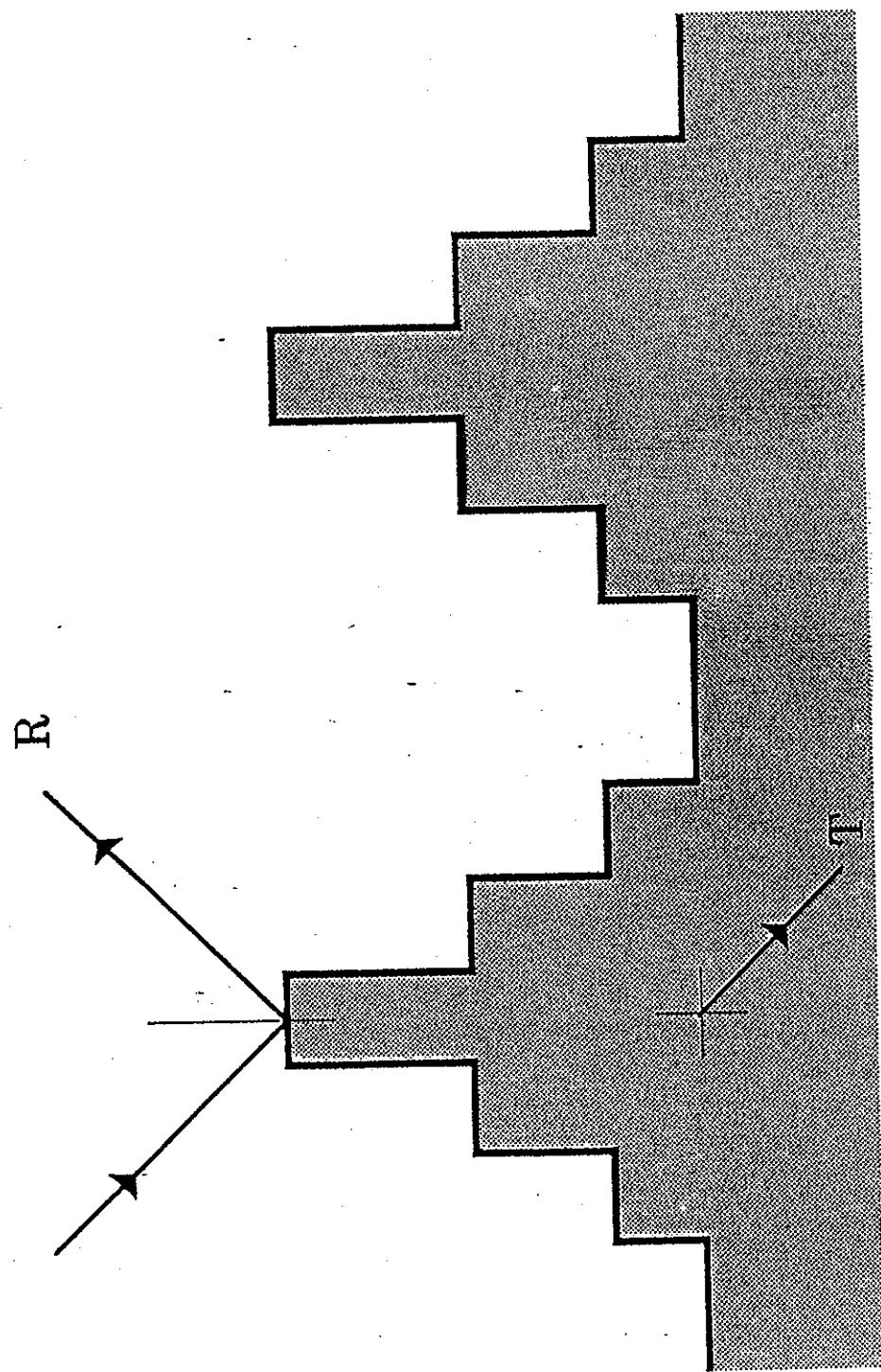


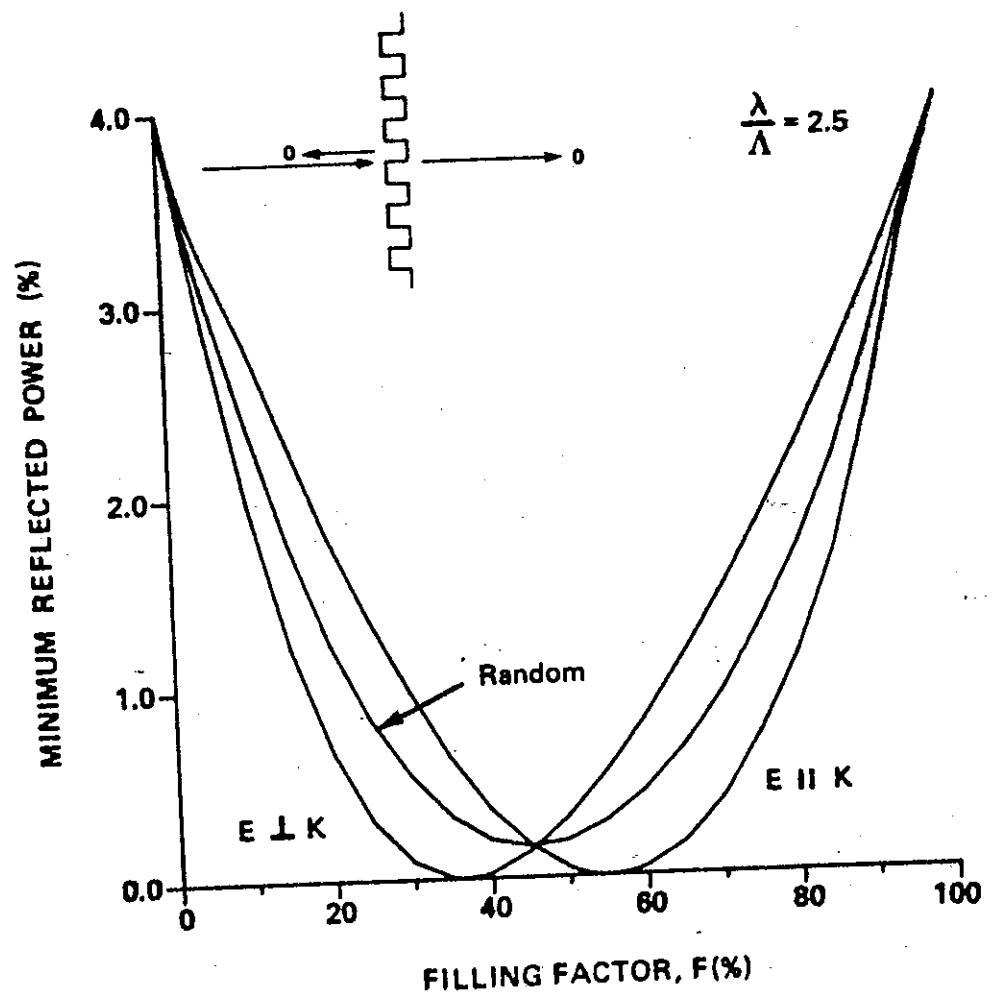


Thin Film

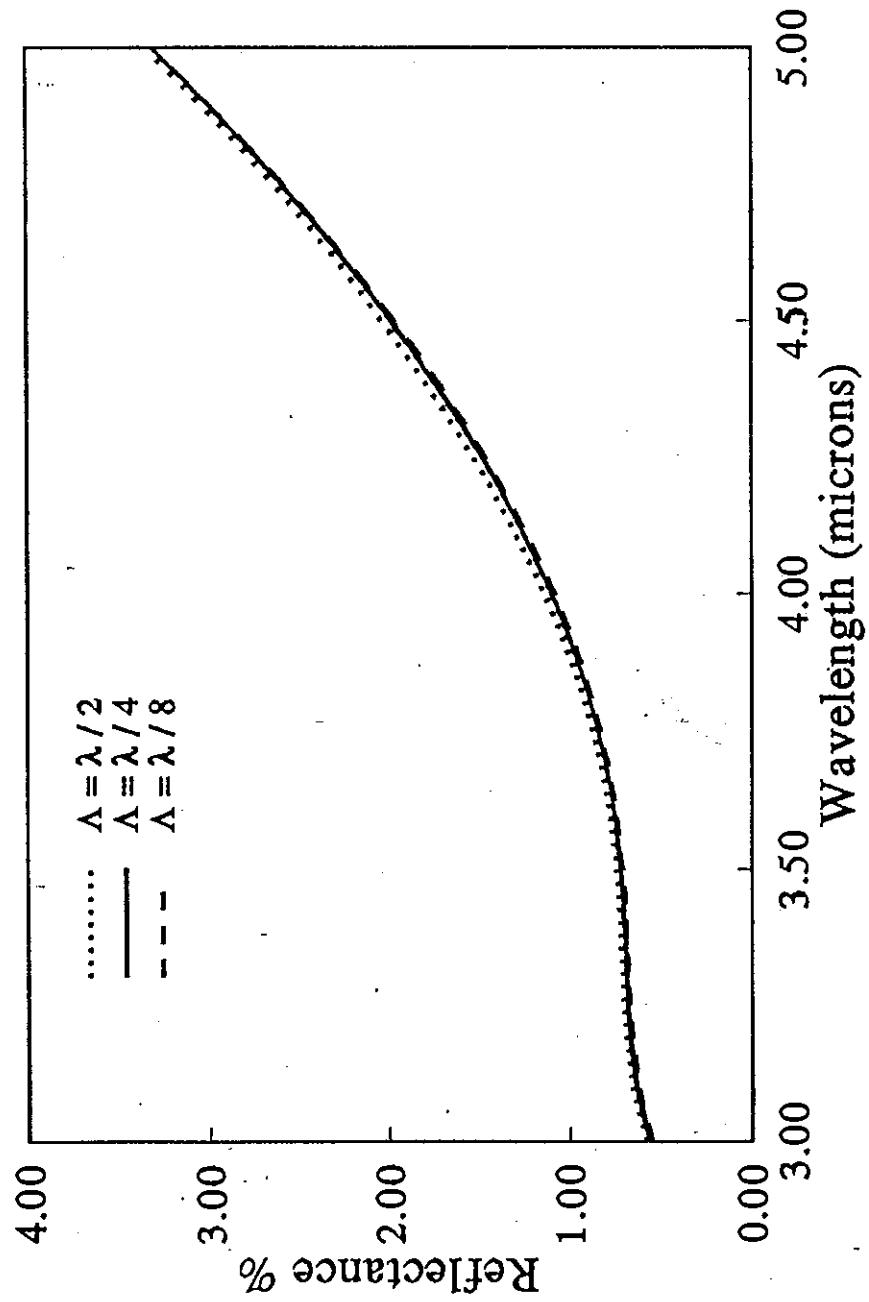


Binary Grating

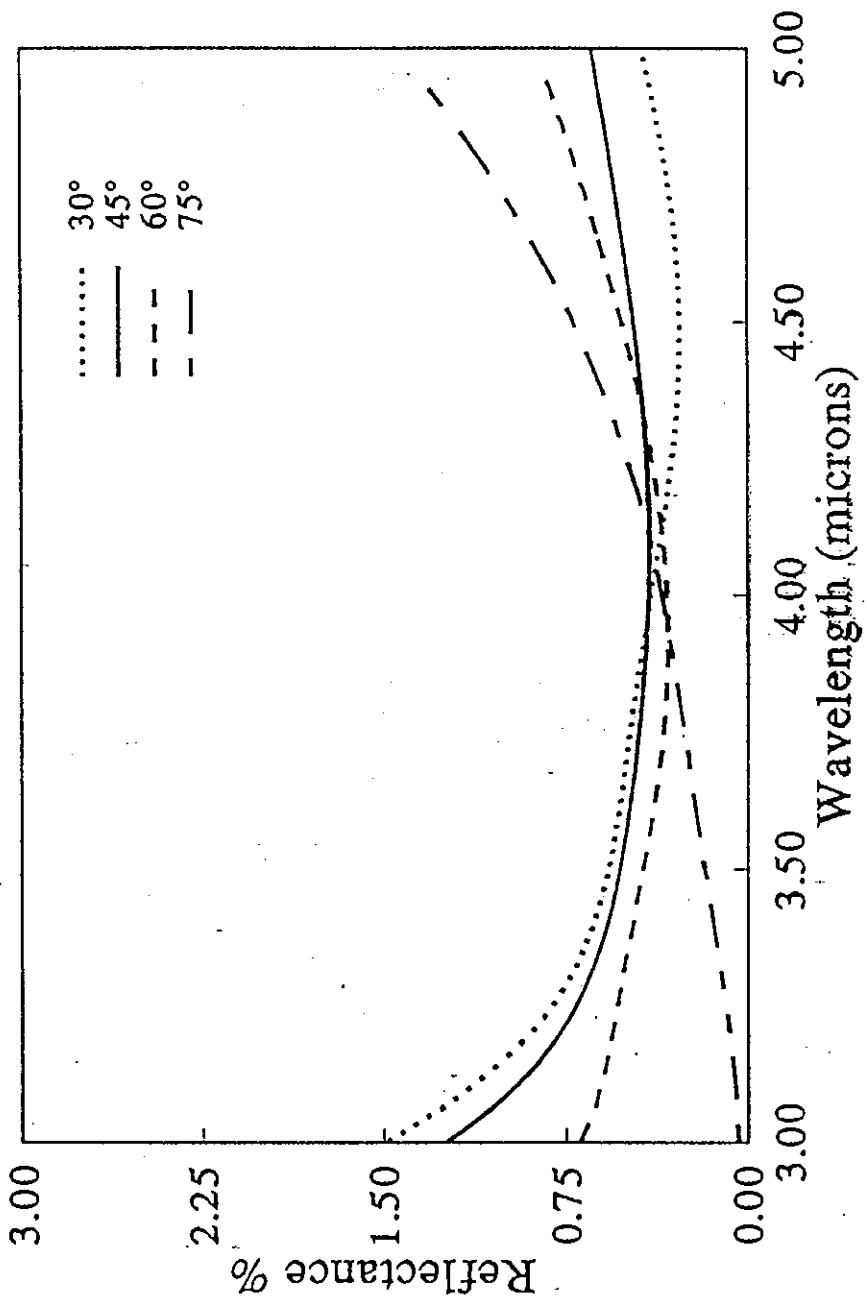




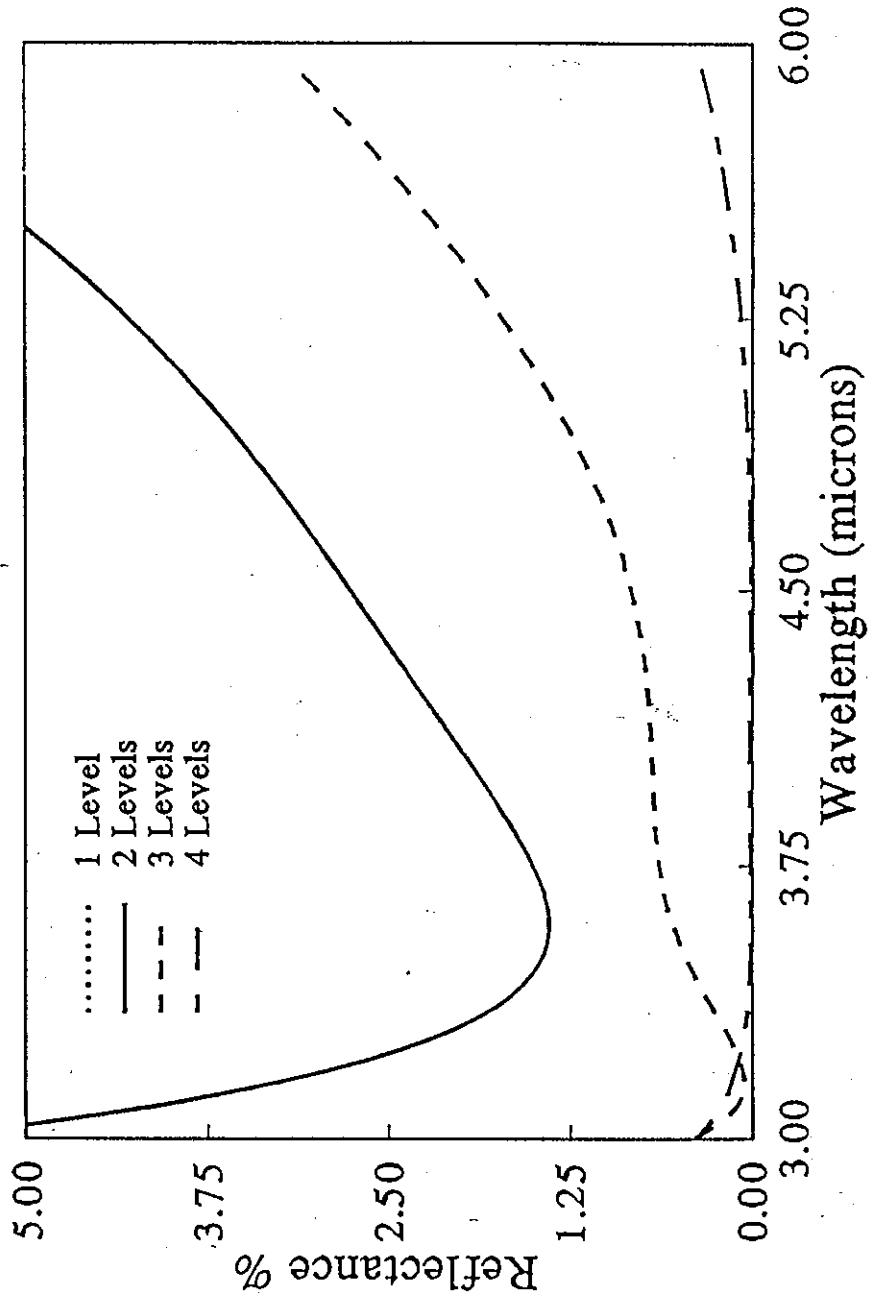
Three-Level Binary Grating AR Coating
Unpolarized Light

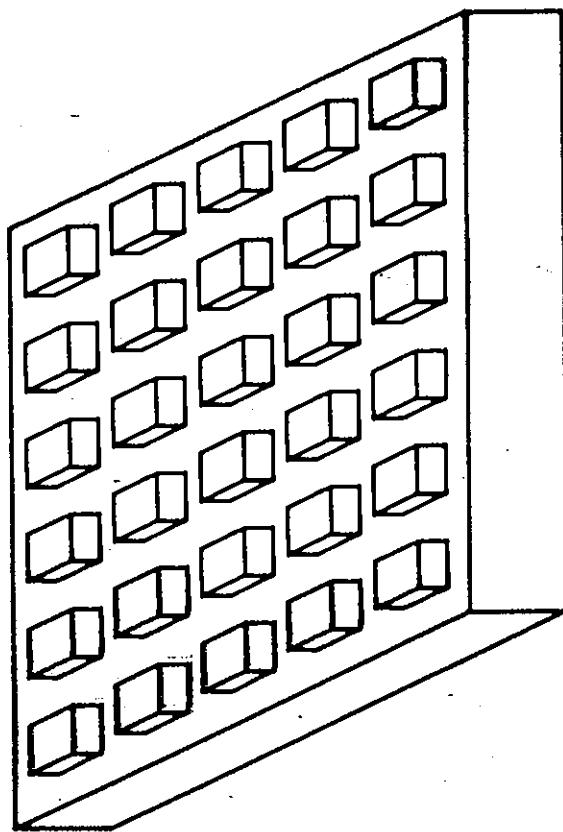
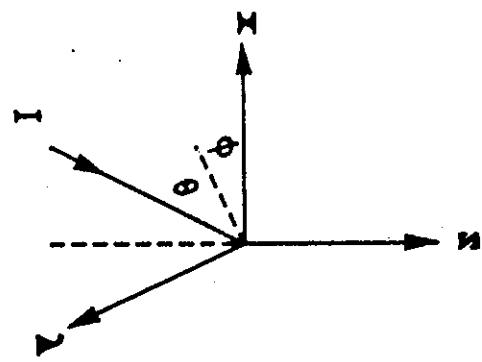


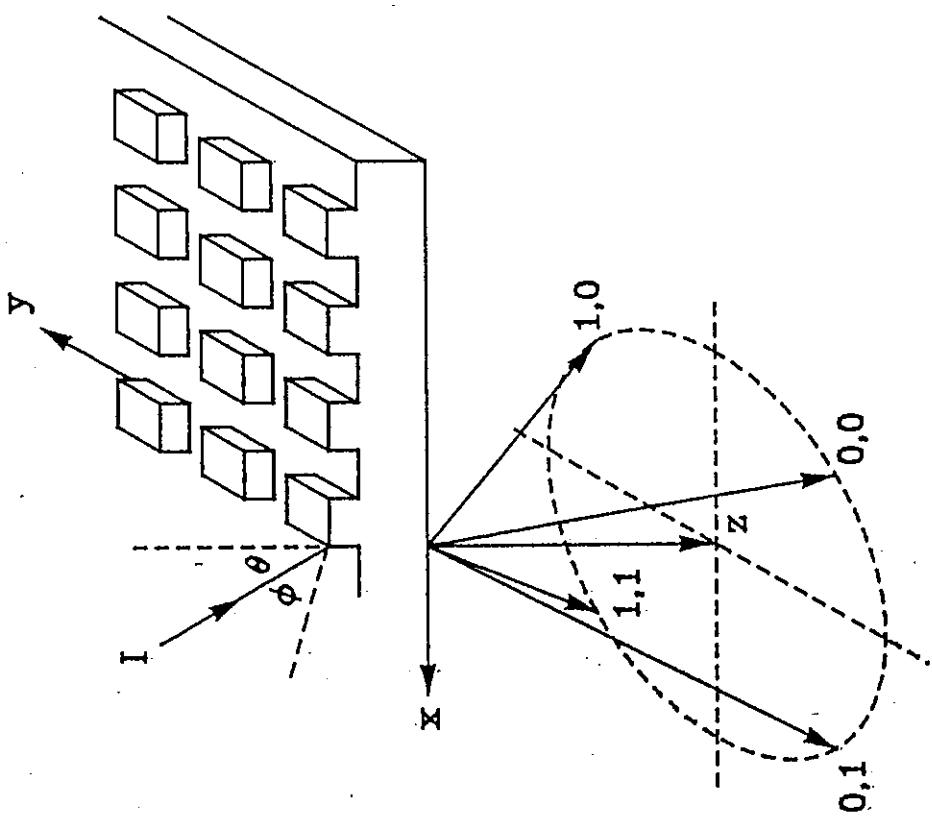
Four-Level Binary Gating AR Coating
Unpolarized Light



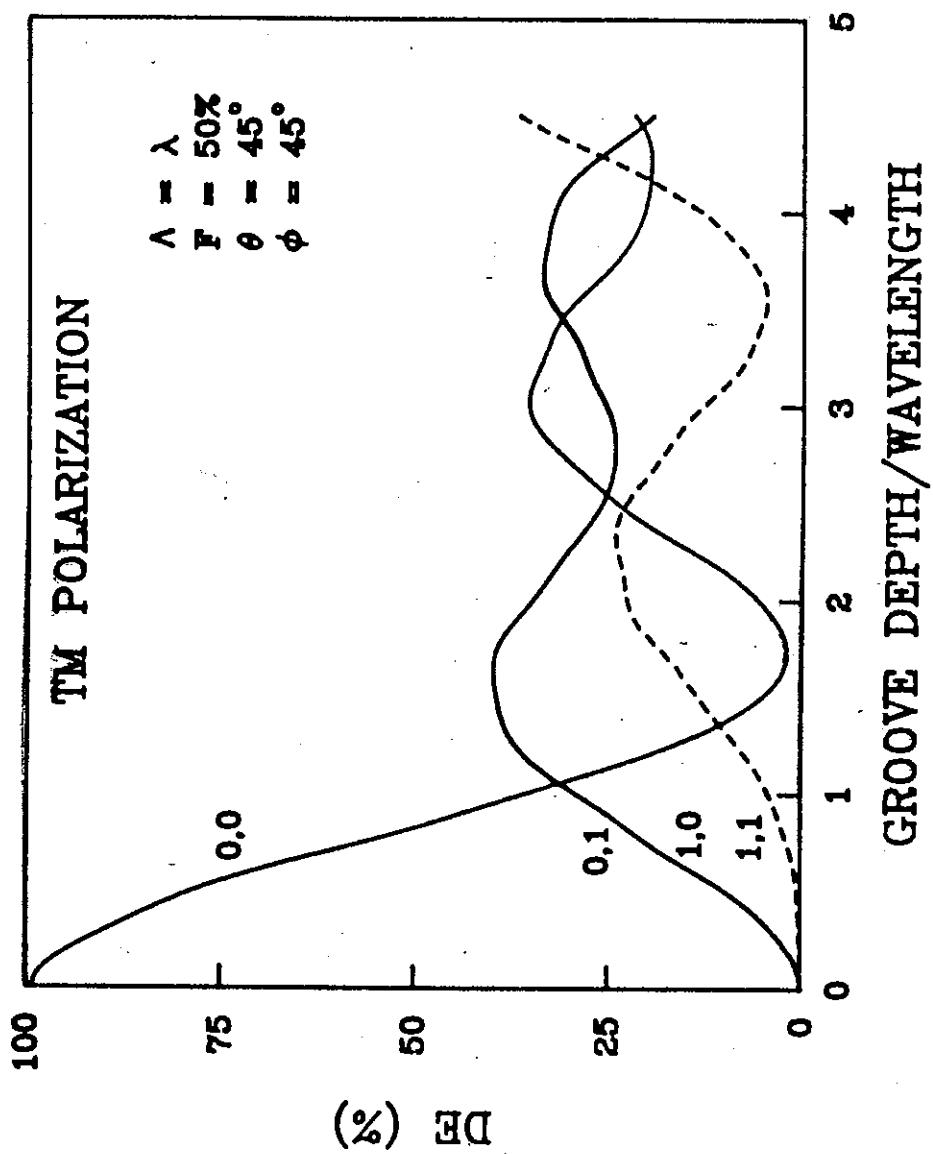
Binary Grating AR Coating
Unpolarized Light ($\theta=75^\circ$)

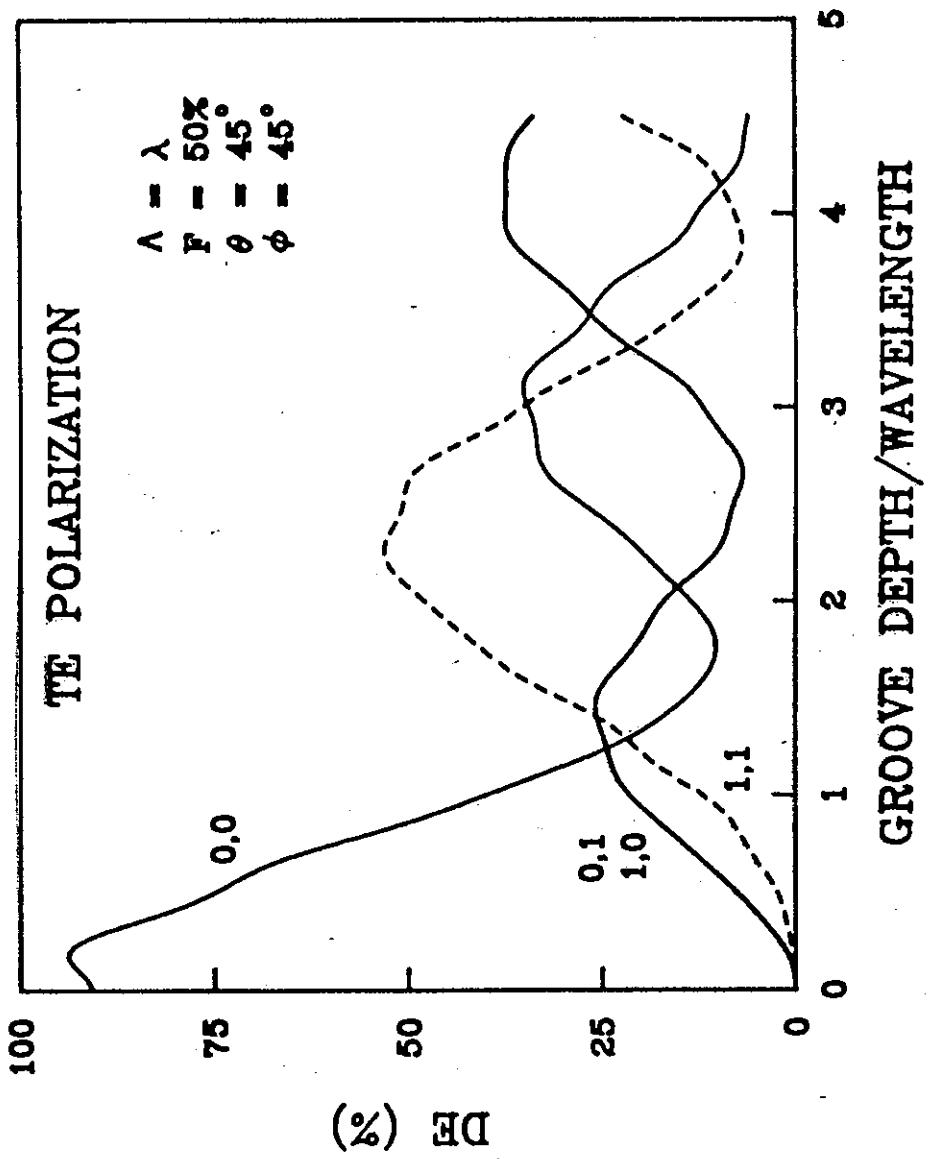




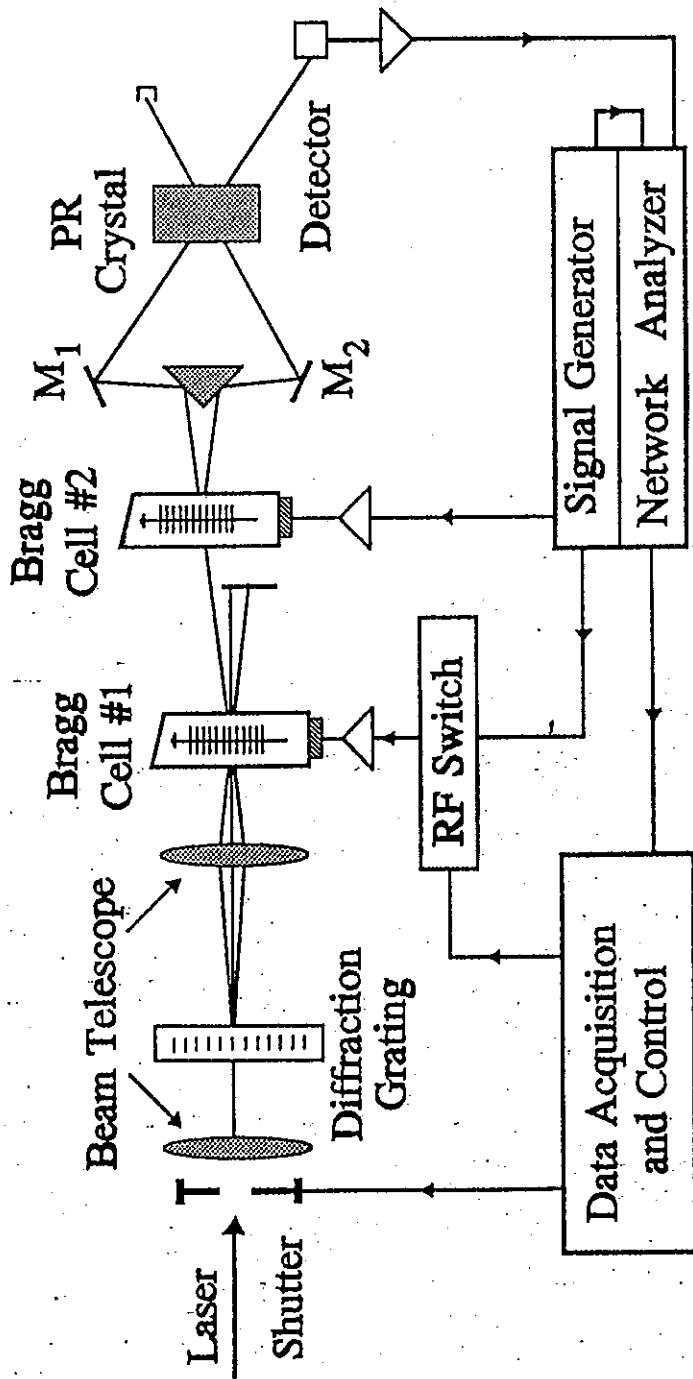


$$\begin{aligned}\Lambda &= \lambda^{\circ} \\ \theta &= 45^{\circ} \\ \phi &= 45^{\circ}\end{aligned}$$

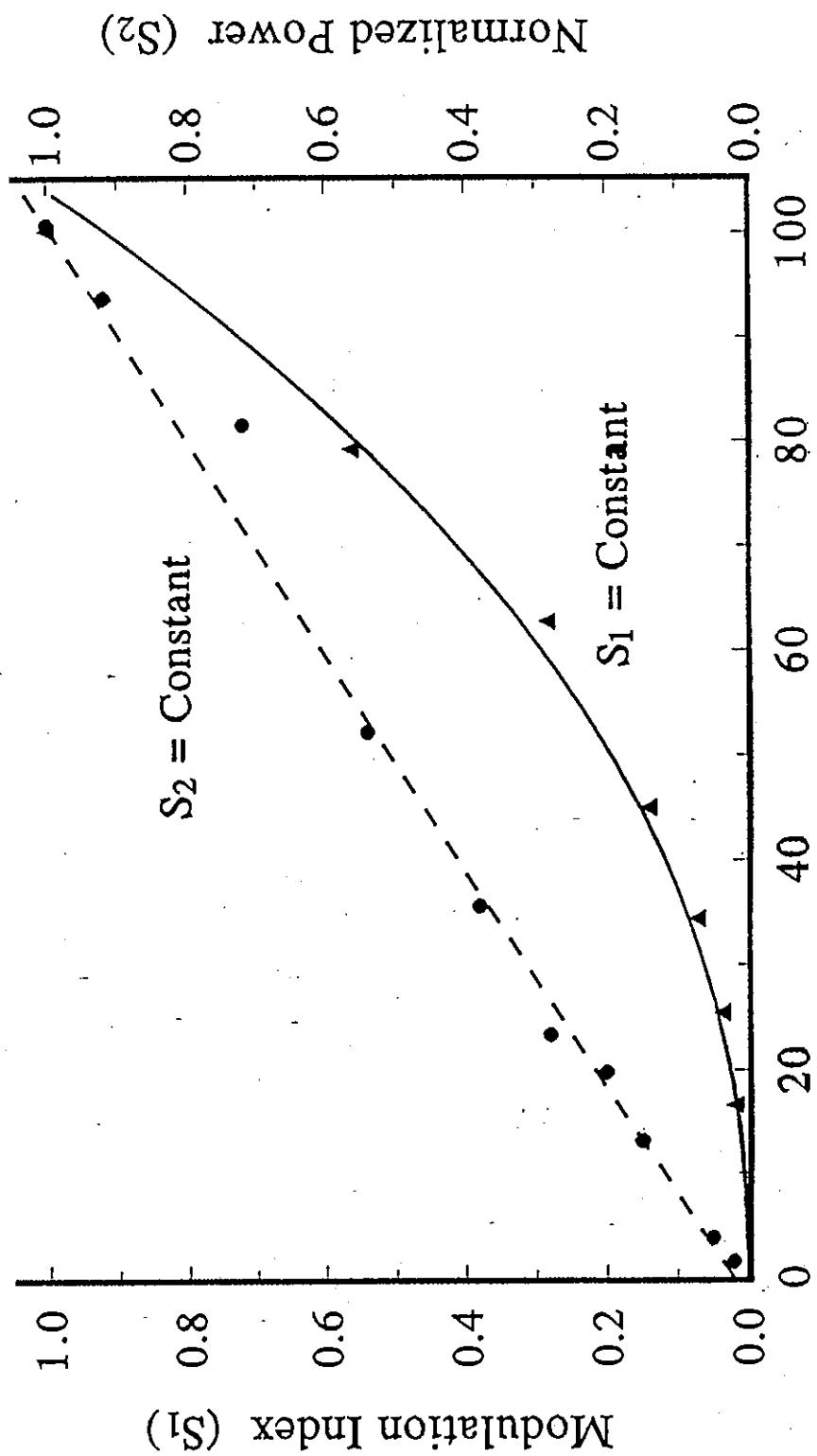




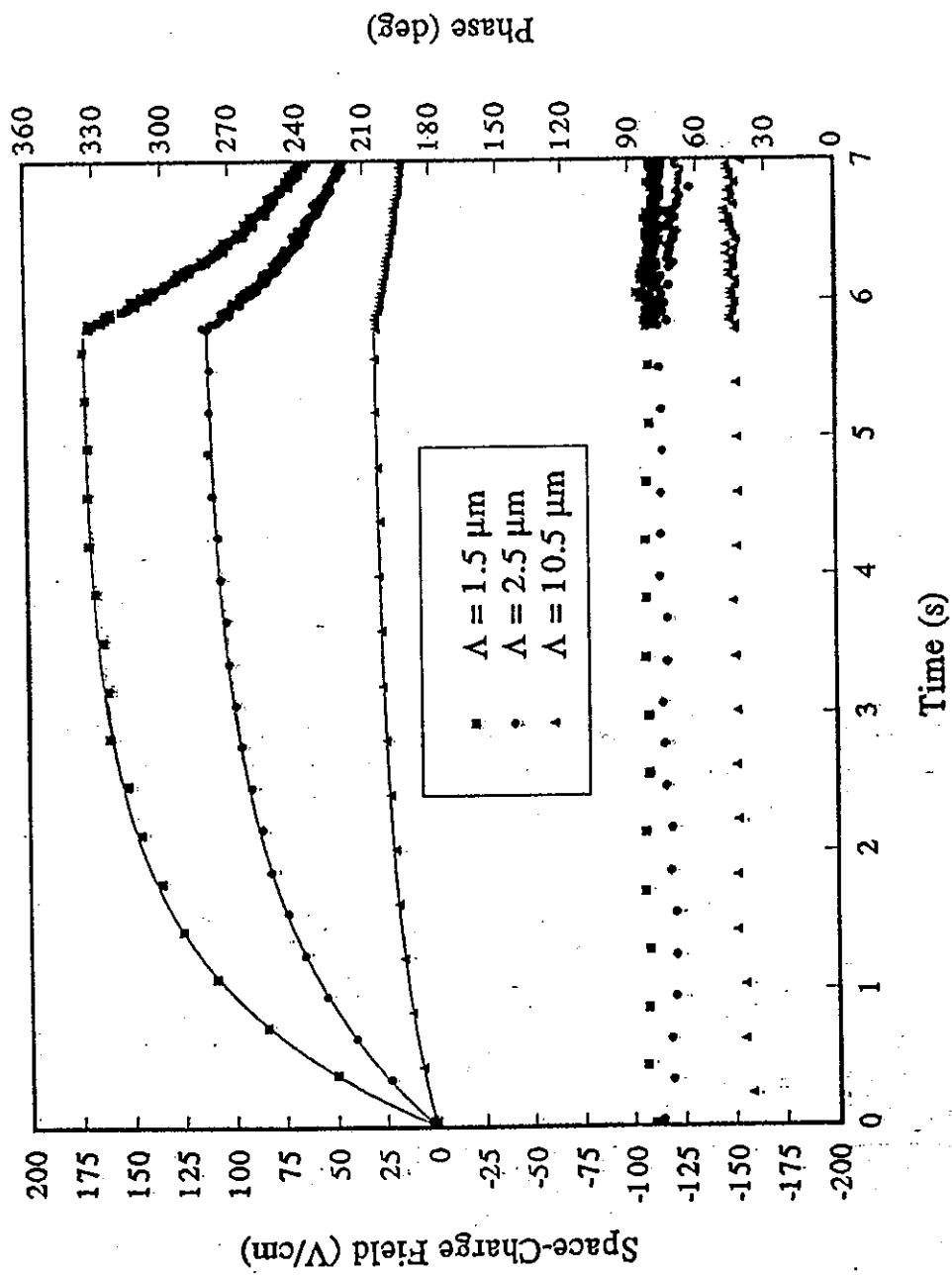
Experimental Configuration

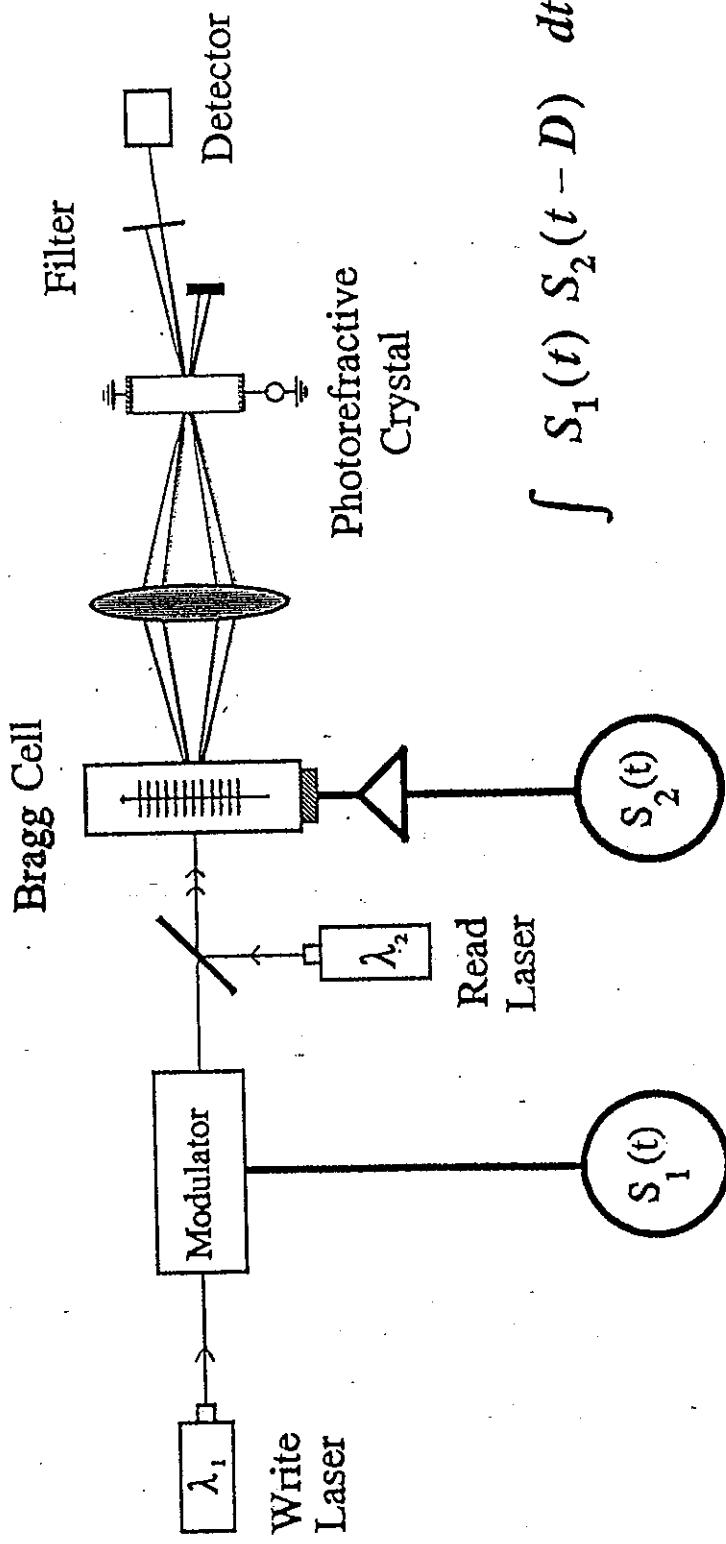


Normalized Correlator Output Signal

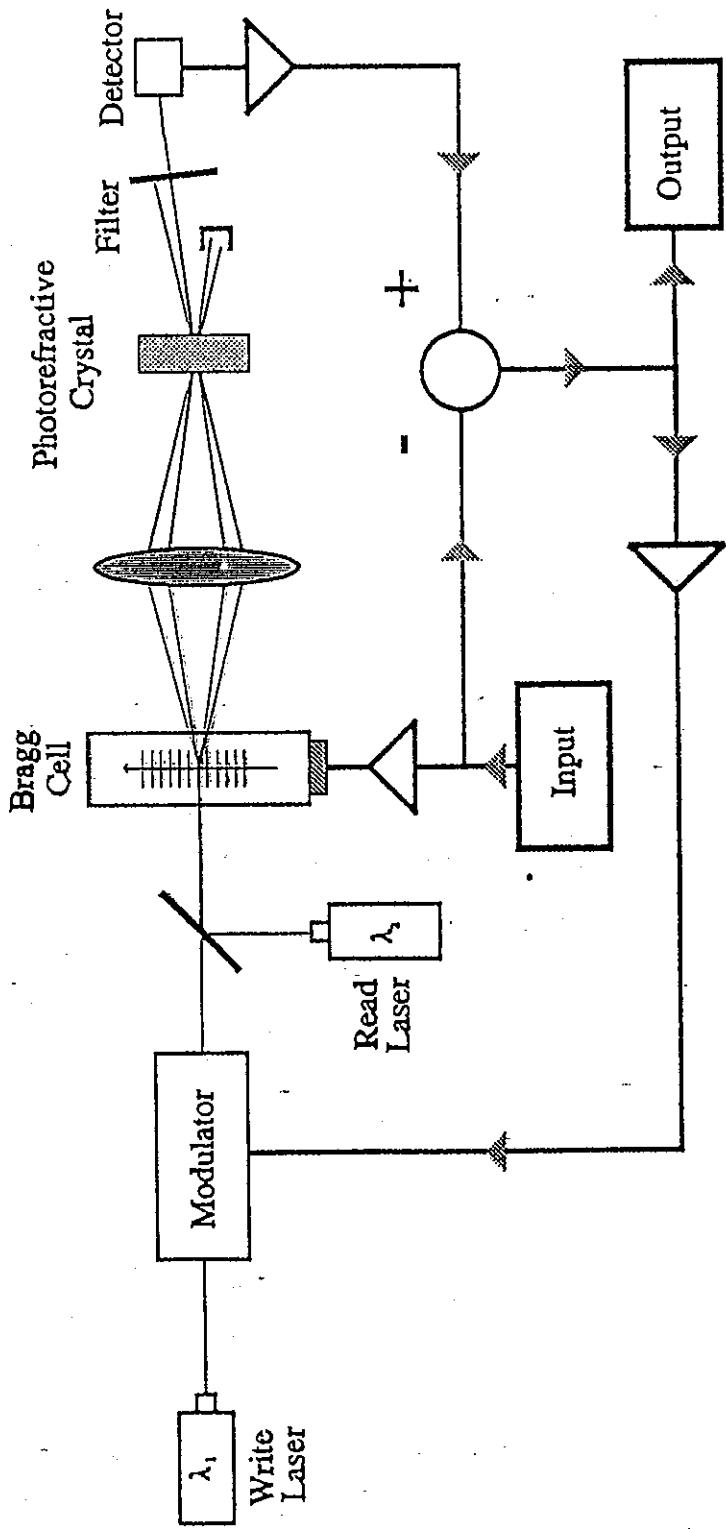


Response of BaTiO₃ as a Function of Spatial Frequency





Photorefractive Correlator Concept



Photorefractive Adaptive Filter Concept

A NEW CLASS OF OPTICAL THIN FILMS



Principal Investigator:
Prof. Karl H. Guenther
Electrical Engineering and Physics
Collaborators:

Dr. K. Balasubramanian

Drs. M. Himmel (now at AT&T) and **S. Zarabian**
Prof. K. Beck (Chemistry) and **Prof. A. Grogan** (ME)

MAJOR TOPICS

React. Low Voltage Ion Plating

Plasma Process Diagnostics

**Thin Film Characterization
and Analysis**

**Feasibility Studies for Florida
and National Industry,
Federal Agencies and Labs**

ACCOMPLISHMENTS

Glassy, Dense, Smooth Films

Better Oxidation Mechanism

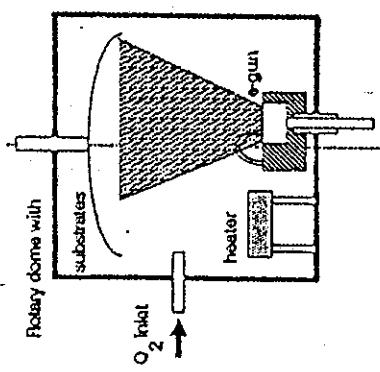
**Optical Micrometrology
and Surface Microanalysis Labs**

**Laser Coatings, Eye Protection,
Polarizers, AR-Coatings
Waveguide Beam Deflector**

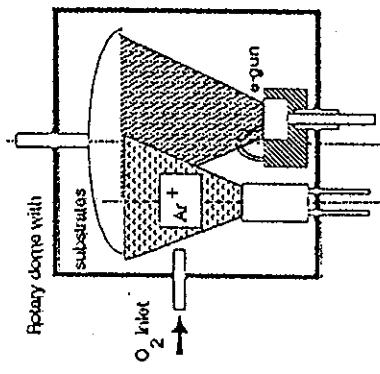
CERAMIC OPTICAL COATINGS?

K. H. Guenther

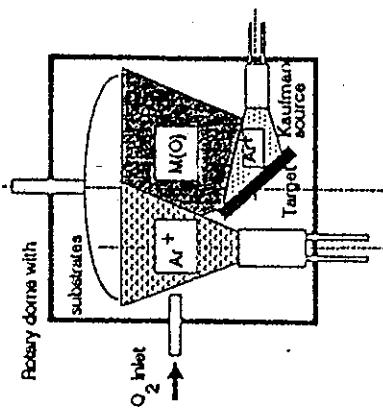
Comparison of Thin Film Deposition Processes



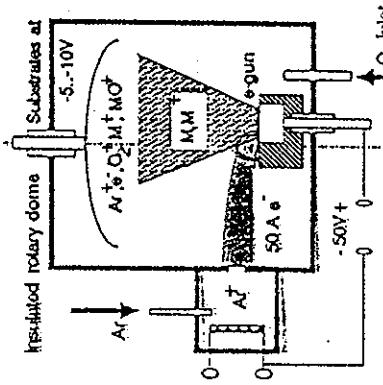
Reactive Evaporation



Ion Assisted Deposition

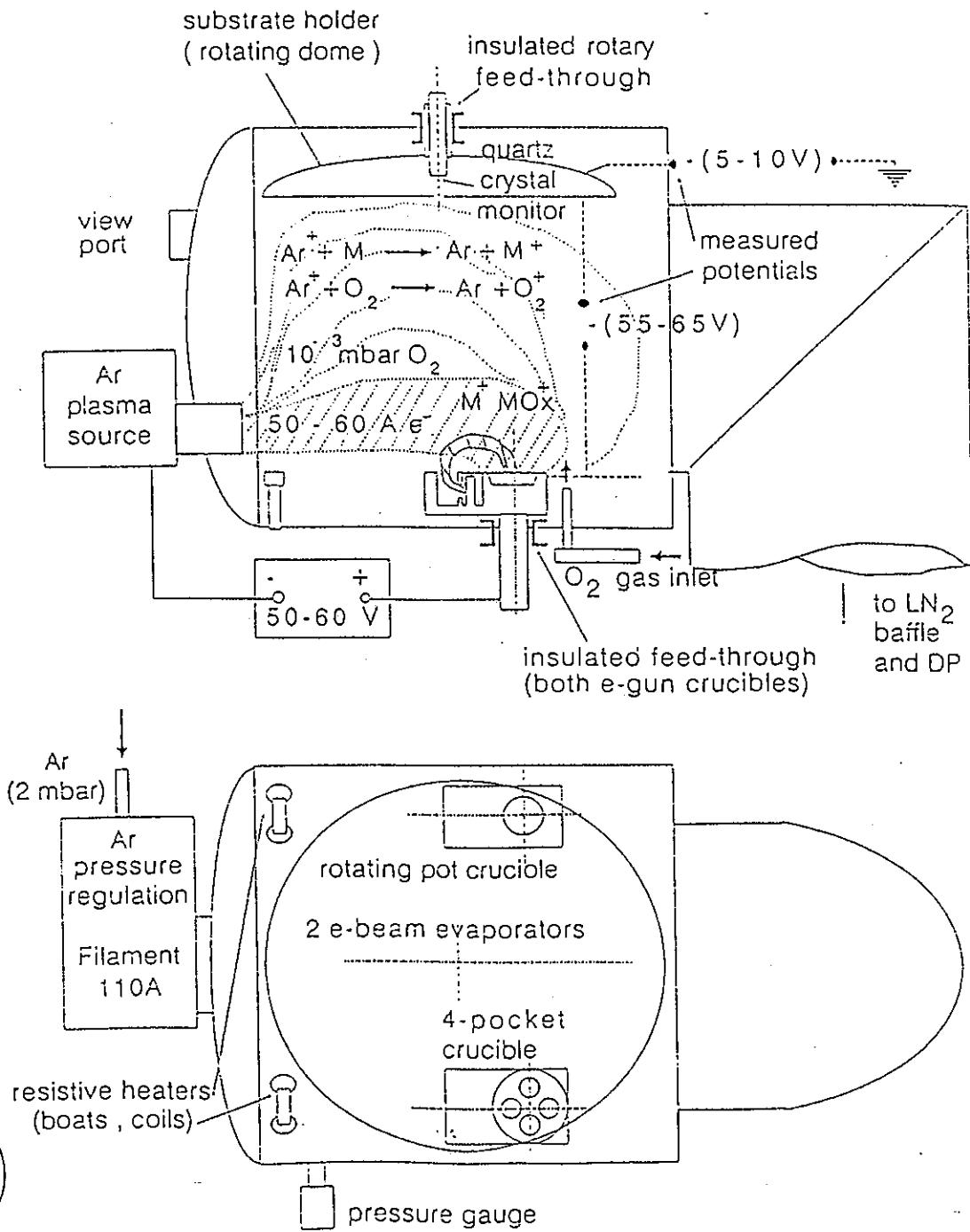


Ion Beam Sputtering



Low Voltage Ion Plating

**High Vacuum Deposition System
(Balzers BAP 800)**
for Reactive Electron Beam (EB) and Thermal Evaporation
and Reactive Low Voltage Ion Plating (RLVIP)



PROGRAM OPTICS

TO: 1000

DATE 09-NOV-88
PAGE 1

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ZrO_2/SiO_2 , ion plated multilayer coating: electron micrograph of a direct cross-section obtained by microtome slicing normal to the interface (nitrided 100 nm in 10^{-6} mbar)



Laser-Quality Coatings Deposited by
Reactive Low Voltage Ion Plating (RLVIP)

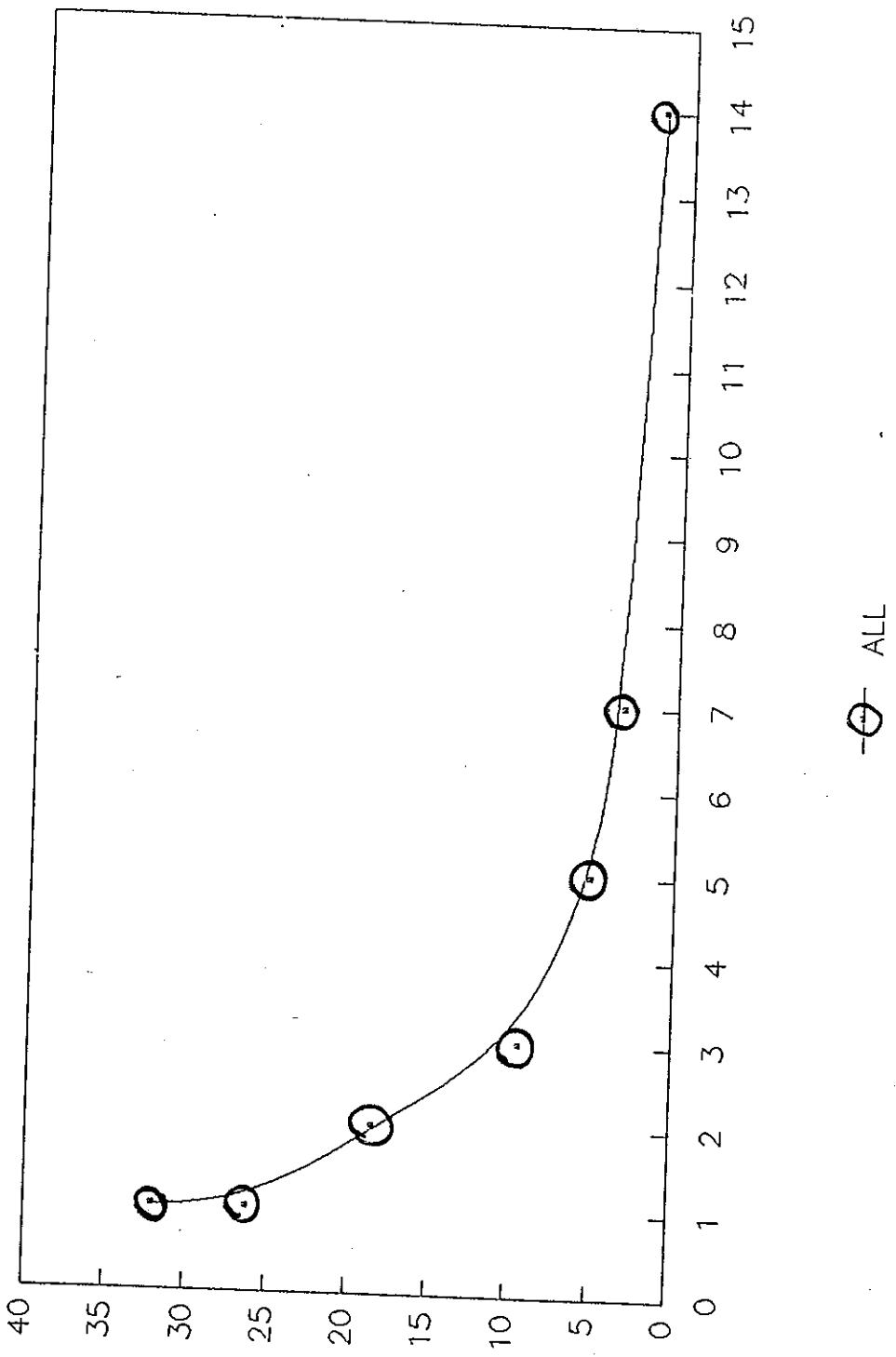
K. H. Guenther, K. Balasubramanian, and X.-Q. Hu
Center for Research in Electro-Optics and Lasers
(CREOL)

University of Central Florida
Orlando, FL 32826

R. Chow and C. J. Stoltz
Optical Initiative Project and KMI
Lawrence Livermore National Laboratory
University of California
Livermore, CA 94551

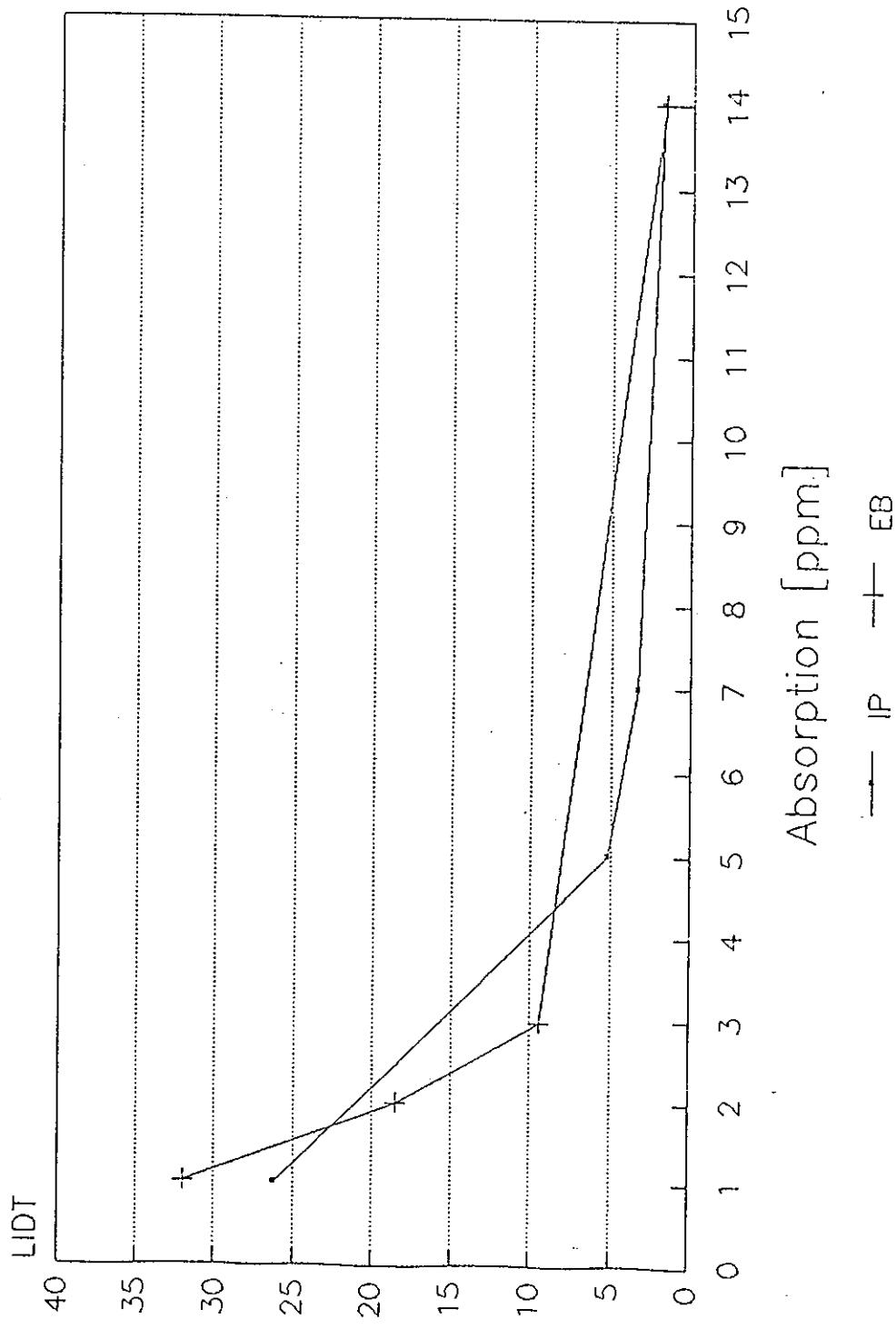
CLEO/QELS
May 12-17, 1991
Baltimore, Maryland







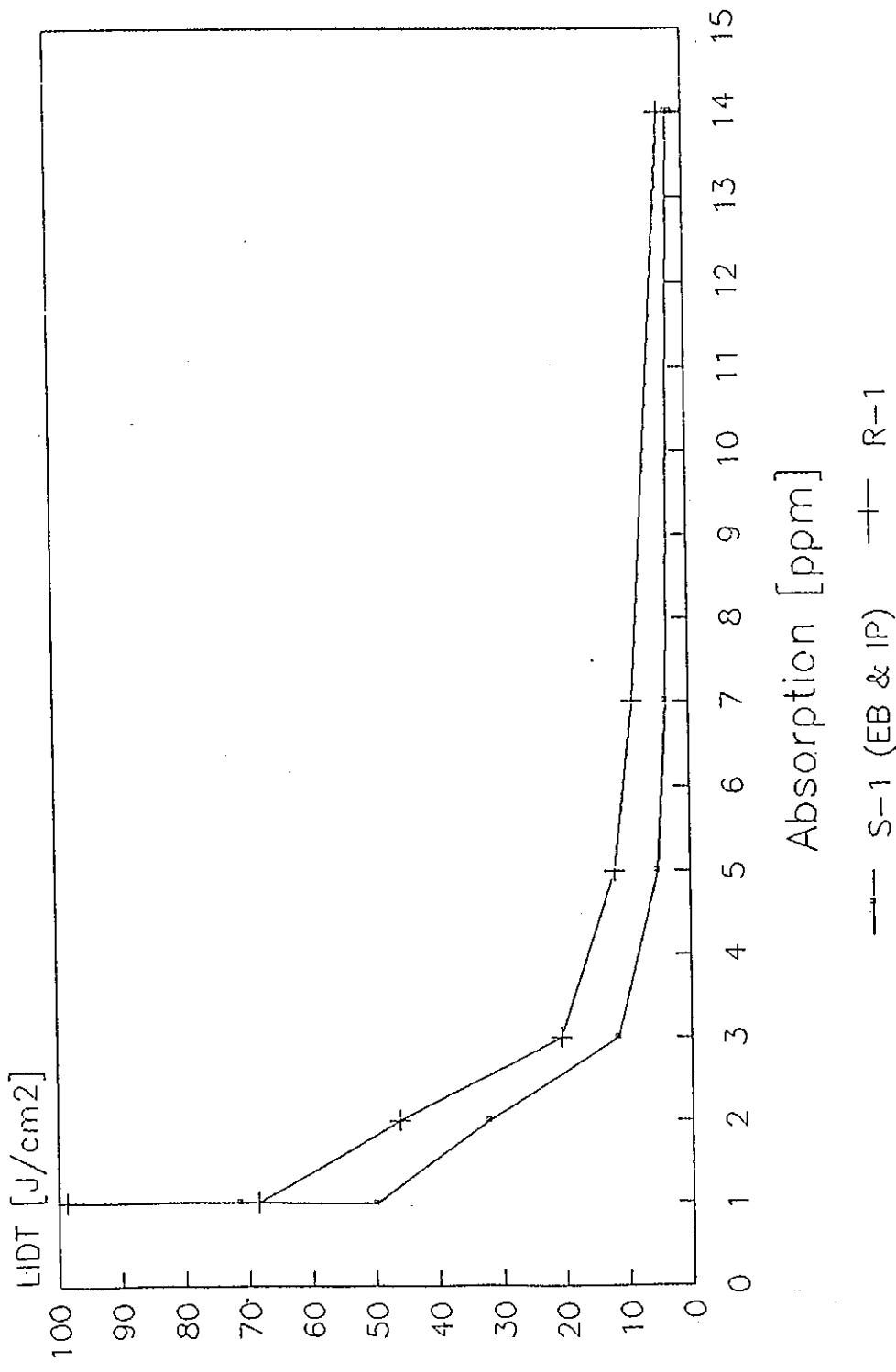
LIDT @ 532 nm of 1 QWOT Single Layers, EB-Deposited and Ion-Plated (IP) on FS





CREOL

LIDT @ 1064nm of Single Layers, QWOT@532 EB-Deposited and Ion-Plated (IP) on FS





Discussion

- RLVIP coatings have desirable properties:
 - Refractive index invariant to environment
(stable spectral characteristic)
 - Expected high durability / longevity
(hardness, imperviousness, abrasion resistance)
- Microstructure and surface roughness investigation indicate dense, glassy (vitreous) or nano-crystalline phases with little (or no) increase of surface roughness
- RLVIP is suitable for mass production and scale-up to large substrate sizes alike (potentially 2 m diameter)
- Absorption of our RLVIP single layer samples is higher than that of comparative e-beam evaporated thin films
- Absorption seems to be a dominant factor for laser damage,
independent of the deposition process

Conclusions

- RLVIP thin films still have good promise for becoming ideal optical and laser coatings
- Further investigations into the influence of absorption on laser induced damage and, conversely, of process parameters on absorption are necessary
- Collaboration between industry, national labs, and universities works and assures broad base for leading edge technology.

